



# MSP430FR231x ミクスト・シグナル・マイクロコントローラ

## 1 デバイスの概要

### 1.1 特長

- 組み込みマイクロコントローラ
  - 最高 16MHz の 16 ビット RISC アーキテクチャ
  - 3.6V~1.8V の広い電源電圧範囲 (最低電源電圧は SVS レベルにより制限されます。「[SVS 仕様](#)」を参照)
- 最適化された低消費電力モード (3V 時)
  - アクティブ・モード: 126μA/MHz
  - スタンバイ: リアルタイム・クロック (RTC) カウンタ (LPM3.5 で 32768Hz の水晶発振器を使用): 0.71μA
  - シャットダウン (LPM4.5): SVS なしで 32nA
- 高性能アナログ
  - トランスインピーダンス・アンプ (TIA) <sup>(1)</sup>
    - 電流/電圧変換
    - ハーフ・レール入力
    - 低リーク電流の負入力、最低 5pA、TSSOP16 パッケージでのみ有効
    - レール・ツー・レール出力
    - 複数の入力選択
    - 構成可能な大消費電力モードと低消費電力モード
  - 8 チャンネル、10 ビットの A/D コンバータ (ADC)
    - 内蔵の 1.5V 基準電圧
    - サンプル・アンド・ホールド 200kpsps
  - 拡張コンパレータ (eCOMP)
    - 基準電圧として 6 ビットのデジタル/アナログ・コンバータ (DAC) を内蔵
    - プログラマブル・ヒステリシス
    - 高消費電力モードと低消費電力モードを構成可能
  - スマート・アナログ・コンボ (SAC-L1)
    - 汎用オペアンプをサポート
    - レール・ツー・レールの入出力
    - 複数の入力選択
    - 構成可能な大消費電力モードと低消費電力モード
- 低消費電力の強誘電体 RAM (FRAM)
  - 最大 3.75KB の不揮発性メモリ
  - エラー訂正コード (ECC) 搭載
- 書き込み保護を設定可能
- プログラム、定数、ストレージの統合メモリ
- 書き込みサイクルの耐久性: 10<sup>15</sup> 回
- 放射線耐性、非磁性
- インテリジェントなデジタル・ペリフェラル
  - IR 変調ロジック
  - 3 つのキャプチャ / 比較レジスタを搭載した 16 ビット・タイマ (Timer\_B3) × 2
  - 16 ビットのカウンタ専用 RTC × 1
  - 16 ビットの巡回冗長性検査 (CRC)
- 拡張シリアル通信
  - 拡張 USCI A (eUSCI\_A) により UART、IrDA、SPI をサポート
  - 拡張 USCI B (eUSCI\_B) により SPI および I<sup>2</sup>C をサポート、リマップ機能をサポート(「[信号概要](#)」を参照)
- クロック・システム (CS)
  - オンチップの 32kHz RC 発振器 (REFO)
  - オンチップの 16MHz デジタル制御発振器 (DCO)、周波数ロック・ループ (FLL) 付き
    - オンチップの基準電圧は室温で ±1% 精度
  - オンチップの超低周波数 10kHz 発振器 (VLO)
  - オンチップの高周波数変調発振器 (MODOSC)
  - 外付けの 32kHz 水晶発振器 (LFXT)
  - 最大 16 MHz の外付けの高周波数水晶発振器 (HFXT)
  - 1~128 の MCLK プリスケールをプログラム可能
  - 1、2、4、8 のプログラマブル・プリスケールを使って MCLK から SMCLK を生成
- 汎用入出力およびピン機能
  - 20 ピンのパッケージに 16 の I/O を搭載
  - 12 本の割り込みピン (P1 に 8 ピン、P2 に 4 ピン) により、MCU を LPM からウェイクアップ可能
  - すべての I/O で静電容量式タッチ機能をサポート
- 開発ツールとソフトウェア
  - LaunchPad™ 開発キット ([MSP-EXP430FR2311](#))
  - ターゲット開発ボード ([MSP-TS430PW20](#))
- ファミリー・メンバー (「[デバイスの比較](#)」も参照)
  - MSP430FR2311: 3.75KB のプログラム FRAM と 1KB の RAM
  - MSP430FR2310: 2KB のプログラム FRAM と 1KB の RAM

(1) トランスインピーダンス・アンプについては、当初は TRI という略語を説明文、ピン名、およびレジスタ名で使用するものとしました。説明文では全面的にこの略語を TIA に変更しましたが、ピン名およびレジスタ名では引き続き TRI を使用しています。



- パッケージ・オプション
  - 20 ピン TSSOP (PW20)
  - 16 ピン TSSOP (PW16)
  - 16 ピン VQFN (RGY16)

## 1.2 アプリケーション

- 煙感知器
- 電力監視
- 外付けバッテリー
- パーソナル・エレクトロニクス
- ポータブル健康管理およびフィットネス

## 1.3 概要

MSP430FR231x FRAMマイクロコントローラ(MCU)は、MSP430™MCUバリュー・ライン・センシング・ファミリの製品であり、リーク電流の小さいトランスインピーダンス・アンプ(TIA)と汎用オペアンプを内蔵しています。このMCUには強力な16ビットRISC CPU、16ビット・レジスタ、および定数ジェネレータが搭載されているため、最高水準のコード効率を実現できます。また、デジタル制御発振器(DCO)により、低消費電力モードからアクティブ・モードへ通常10μs未満でウェイクアップできます。このMCUの各種機能は、煙感知器からポータブル健康管理/フィットネス・アクセサリまで、幅広い用途に最適です。

超低消費電力のMSP430FR231x MCUファミリは複数のデバイスからなり、組み込み型の不揮発性FRAMや、さまざまなセンシングおよび測定機器に対応する多様なペリフェラル・セットを特長としています。アーキテクチャ、FRAM、ペリフェラルに多様な低消費電力モードを組み合わせ、携帯型/ワイヤレス・センシング機器で長いバッテリー駆動時間を実現するように最適化しています。FRAMは、SRAMの速度、柔軟性、耐久性とフラッシュの安定性および信頼性を両立しながら総消費電力を抑制できる不揮発性メモリ・テクノロジーです。

MSP430FR231x MCUは、ハードウェアおよびソフトウェアの大規模なエコシステムによってサポートされており、リファレンス・デザインやサンプル・コードを利用して設計をすぐに開始できます。開発キットにはMSP-EXP430FR2311 LaunchPad™開発キットと、MSP-TS430PW20 20ピン・ターゲット開発ボードが含まれます。また、TIは無償のMSP430Ware™ソフトウェアも提供しており、Code Composer Studio™ IDEデスクトップのコンポーネントとして利用できます。TI Resource Explorerではクラウド・バージョンも利用可能です。MSP430 MCUには、幅広い範囲のオンライン資料、トレーニング、およびE2E™コミュニティ・フォーラムによるオンライン・サポートも用意されています。

モジュールの詳細な説明については、『MSP430FR4xx and MSP430FR2xx Family User's Guide』(英語)を参照してください。

### 製品情報<sup>(1)</sup>

| 型番                | パッケージ      | 本体サイズ <sup>(2)</sup> |
|-------------------|------------|----------------------|
| MSP430FR2311IPW20 | TSSOP (20) | 6.5mm×4.4mm          |
| MSP430FR2310IPW20 |            |                      |
| MSP430FR2311IPW16 | TSSOP (16) | 5mm×4.4mm            |
| MSP430FR2310IPW16 |            |                      |
| MSP430FR2311IRGY  | VQFN (16)  | 4mm×3.5mm            |
| MSP430FR2310IRGY  |            |                      |

- (1) 最新の製品、パッケージ、および注文情報については、9の「付録:パッケージ・オプション」、または[www.ti.com](http://www.ti.com)のTI Webサイトを参照してください。
- (2) ここに記載されているサイズは概略です。許容公差を含めたパッケージの寸法については、9の「メカニカル・データ」を参照してください。

### 注意

電氣的な過剰ストレスや、データやコード・メモリの不安定化を防止するため、デバイス・レベルのESD仕様に従って、システム・レベルのESD保護を適用する必要があります。詳細については、『MSP430™のシステム・レベルのESD考慮事項』を参照してください。

## 1.4 機能ブロック図

図 1-1に機能ブロック図を表します。

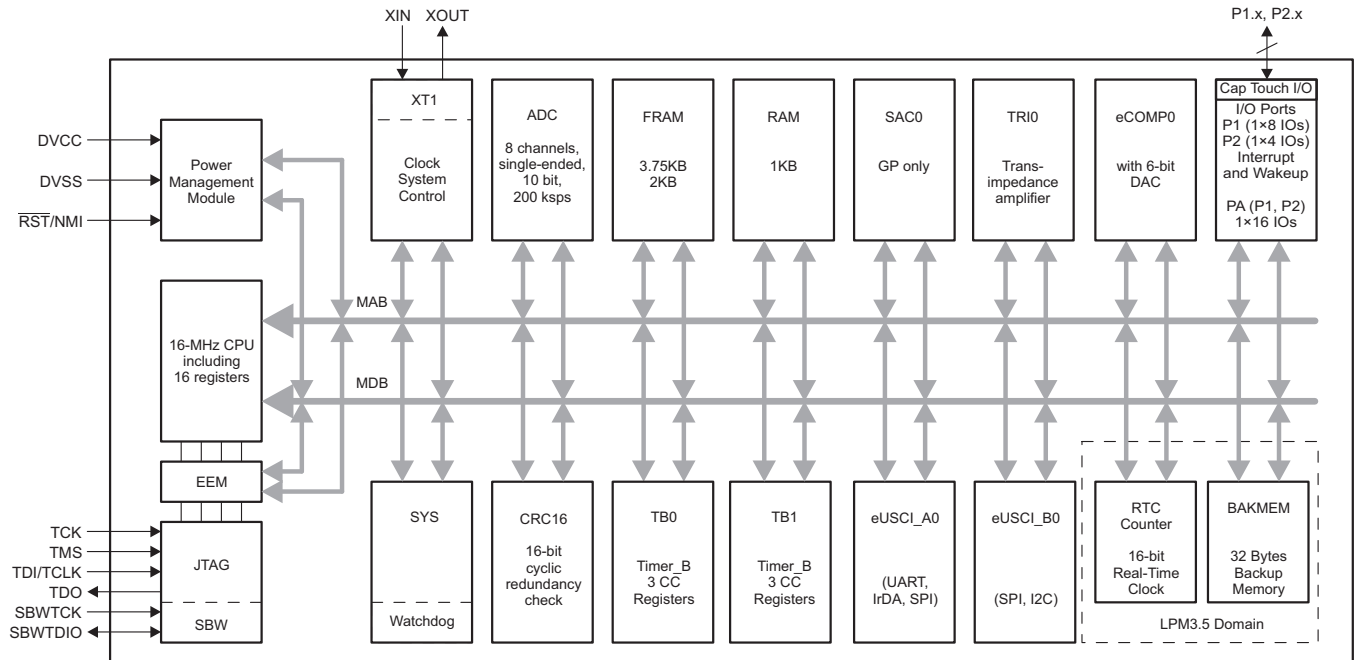


図 1-1. MSP430FR231x の機能ブロック図

- このMCUには、DVCCおよびDVSSの1つのメイン電源ペアがあり、デジタルとアナログの両方のモジュールへ電力を供給します。バイパスおよびデカップリング・コンデンサとしては、それぞれ4.7 $\mu$ F～10 $\mu$ Fおよび0.1 $\mu$ Fで、精度 $\pm 5\%$ が推奨されます。
- P1の8本すべてのピンと、P2の4本のピンにはピン割り込み機能があり、LPM4、LPM3.5、LPM4.5を含むすべてのLPMからMCUをウェイクアップできます。
- 各Timer\_B3には3つのキャプチャ/比較レジスタがあります。外部的に接続されているのはCCR1およびCCR2のみです。CCR0レジスタは、内部的な期間のタイミングと割り込みの生成にのみ使用できます。
- LPM3.5では、RTCカウンタとバックアップ・メモリが動作し、他のペリフェラルはオフです。
- すべての汎用I/Oは、静電容量式タッチI/Oとして構成可能です。

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## 2 改訂履歴

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

### リビジョン D からリビジョン E への変更点

| 2018年8月29日発行分から2019年12月9日発行分への変更                                                                                                                                                                        | Page               |
|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------|
| • Updated <a href="#">Section 3.1, Related Products</a> .....                                                                                                                                           | <a href="#">7</a>  |
| • Changed the note that begins "Supply voltage changes faster than 0.2 V/ $\mu$ s can trigger a BOR reset..." in <a href="#">Section 5.3, Recommended Operating Conditions</a> .....                    | <a href="#">15</a> |
| • Added the note that begins "TI recommends that power to the DVCC pin must not exceed the limits..." in <a href="#">Section 5.3, Recommended Operating Conditions</a> .....                            | <a href="#">15</a> |
| • Changed the note that begins "A capacitor tolerance of $\pm 20\%$ or better is required..." in <a href="#">Section 5.3, Recommended Operating Conditions</a> .....                                    | <a href="#">15</a> |
| • Combined former sections 5.8 and 5.10 to <a href="#">Section 5.9, Production Distribution of LPM Supply Currents</a> .....                                                                            | <a href="#">19</a> |
| • Corrected "SVS Enabled" test condition on <a href="#">Figure 5-2, LPM3.5 Supply Current vs Temperature</a> .....                                                                                      | <a href="#">19</a> |
| • Added the note "See <a href="#">MSP430 32-kHz Crystal Oscillators</a> for details on crystal section, layout, and testing" to <a href="#">Table 5-3, XT1 Crystal Oscillator (Low Frequency)</a> ..... | <a href="#">23</a> |
| • Changed the note that begins "Requires external capacitors at both terminals..." in <a href="#">Table 5-3, XT1 Crystal Oscillator (Low Frequency)</a> .....                                           | <a href="#">23</a> |
| • Added the $t_{TB, cap}$ parameter in <a href="#">Table 5-13, Timer_B</a> .....                                                                                                                        | <a href="#">30</a> |
| • Changed the parameter symbol from $R_i$ to $R_{i, MUX}$ in <a href="#">Table 5-20, ADC, Power Supply and Input Range Conditions</a> ..                                                                | <a href="#">36</a> |
| • Corrected the test conditions for the $R_{i, MUX}$ parameter in <a href="#">Table 5-20, ADC, Power Supply and Input Range Conditions</a> .....                                                        | <a href="#">36</a> |
| • Added $R_{i, Misc}$ TYP value of 34 k $\Omega$ in <a href="#">Table 5-20, ADC, Power Supply and Input Range Conditions</a> .....                                                                      | <a href="#">36</a> |
| • Added formula for $R_i$ in <a href="#">Table 5-21, ADC, 10-Bit Timing Parameters</a> .....                                                                                                            | <a href="#">36</a> |
| • Added the note that begins " $t_{Sample} = \ln(2^{n+1}) \times \tau$ ..." in <a href="#">Table 5-21, ADC, 10-Bit Timing Parameters</a> .....                                                          | <a href="#">36</a> |
| • Corrected bitfield from RTCCLK to RTCKSEL in <a href="#">Table 6-8, Clock Distribution</a> .....                                                                                                      | <a href="#">51</a> |
| • Corrected bitfield from IRDSEL to IRDSSEL in <a href="#">Section 6.11.8, Timers (Timer0_B3, Timer1_B3)</a> , in the description that starts "The interconnection of Timer0_B3 and ..." .....          | <a href="#">54</a> |
| • Added P1SEL information in <a href="#">Table 6-31, Port P1, P2 Registers (Base Address: 0200h)</a> .....                                                                                              | <a href="#">65</a> |
| • Added P2SEL information in <a href="#">Table 6-31, Port P1, P2 Registers (Base Address: 0200h)</a> .....                                                                                              | <a href="#">65</a> |
| • Added note to "ADC calibration" in <a href="#">Table 6-46, Device Descriptors</a> .....                                                                                                               | <a href="#">72</a> |

### リビジョン C からリビジョン D への変更点

| 2017年9月12日発行分から2018年08月28日発行分への変更                                                                                            | Page               |
|------------------------------------------------------------------------------------------------------------------------------|--------------------|
| • Updated <a href="#">Section 3.1, Related Products</a> .....                                                                | <a href="#">7</a>  |
| • Combined former sections 5.8 and 5.10 to <a href="#">Section 5.9, Production Distribution of LPM Supply Currents</a> ..... | <a href="#">19</a> |
| • Added note to $V_{SVSH-}$ and $V_{SVSH+}$ parameters in <a href="#">Table 5-1, PMM, SVS and BOR</a> .....                  | <a href="#">21</a> |
| • Added the $t_{TB, cap}$ parameter in <a href="#">Table 5-13, Timer_B</a> .....                                             | <a href="#">30</a> |
| • Corrected ADCINCHx column heading in <a href="#">Table 6-16, ADC Channel Connections</a> .....                             | <a href="#">58</a> |
| • <a href="#">8.2「デバイスの項目表記」のテキストおよび図を更新</a> .....                                                                           | <a href="#">79</a> |

### リビジョン B からリビジョン C への変更点

| 2016年6月1日発行分から2017年09月11日発行分への変更                                                                                                                                                                                   | Page               |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------|
| • 特長の項目「シャットダウン (LPM4.5)」の電流を訂正 .....                                                                                                                                                                              | <a href="#">1</a>  |
| • テストデータに基づき低リーク電流入力を 50pA から 5pA に改善 .....                                                                                                                                                                        | <a href="#">1</a>  |
| • Added <a href="#">Section 3.1, Related Products</a> .....                                                                                                                                                        | <a href="#">7</a>  |
| • Combined former sections 5.8 and 5.10 to <a href="#">Section 5.9, Production Distribution of LPM Supply Currents</a> .....                                                                                       | <a href="#">19</a> |
| • Added the $t_{TB, cap}$ parameter in <a href="#">Table 5-13, Timer_B</a> .....                                                                                                                                   | <a href="#">30</a> |
| • Removed ADCDIV from the formula for the TYP value in the second row of the $t_{CONVERT}$ parameter in <a href="#">Table 5-21, ADC, 10-Bit Timing Parameters</a> (removed because ADCCLK is after division) ..... | <a href="#">36</a> |
| • Changed the entries for eUSCI_A0 and eUSCI_B0 in the LPM3 column from Off to Optional in <a href="#">Table 6-1,</a>                                                                                              |                    |

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| • Added the sentence that begins "This device supports blank device detection..." in <a href="#">Section 6.6, Bootloader (BSL)</a> ..                                                                            | 47 |
| • Added the note "Controlled by the RTCCLK bit in the SYSCFG2 register" on <a href="#">Table 6-8, Clock Distribution</a> .....                                                                                   | 51 |
| • Added <a href="#">Figure 6-1, Clock Distribution Block Diagram</a> .....                                                                                                                                       | 51 |
| • Added <a href="#">Figure 6-2, Timer_B Connections</a> .....                                                                                                                                                    | 55 |
| • Removed SYSBERRIV register (not supported) in <a href="#">Table 6-26, SYS Registers</a> .....                                                                                                                  | 64 |
| • Changed from "If the $\overline{\text{RST}}/\text{NMI}$ pin is unused...with a 2.2-nF pulldown capacitor" to "If the $\overline{\text{RST}}/\text{NMI}$ pin is unused...with a 10-nF pulldown capacitor" ..... | 76 |

## リビジョン A からリビジョン B への変更点

### 2016年3月30日発行分から2016年05月31日発行分への変更

### Page

|                                                                                                                                                                    |    |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------------|----|
| • デバイスのステータスを「製品プレビュー」から「量産データ」に変更 .....                                                                                                                           | 1  |
| • Changed the value of $f_{\text{XT1}}$ in the table note that starts "Low-power mode 4, VLO,..." .....                                                            | 17 |
| • Combined former sections 5.8 and 5.10 to <a href="#">Section 5.9, Production Distribution of LPM Supply Currents</a> .....                                       | 19 |
| • Added Test Conditions to module Timer_B in <a href="#">Section 5.10, Typical Characteristics – Current Consumption Per Module</a> .....                          | 20 |
| • Added "16 MHz" to the parameter description of $t_{\text{FLL, lock}}$ in <a href="#">Table 5-5, DCO FLL</a> .....                                                | 25 |
| • Added the $t_{\text{TB, cap}}$ parameter in <a href="#">Table 5-13, Timer_B</a> .....                                                                            | 30 |
| • Removed $\pm 3^\circ\text{C}$ from calibration temperatures in the table note that starts "The device descriptor structure contains calibration values..." ..... | 37 |
| • Changed the unit on the $E_{\text{NI}}$ parameter in <a href="#">Table 5-24, SAC0 (SAC-L1, OA)</a> .....                                                         | 39 |
| • Changed the unit on the $E_{\text{NI}}$ parameter in <a href="#">Table 5-25, TIA0</a> .....                                                                      | 40 |

## 初版からリビジョン A への変更点

### 2016年2月23日発行分から2016年03月29日発行分への変更

### Page

|                                                                                                                                                                                               |    |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----|
| • ドキュメント全体で、TIAモジュールの名称をTRI0からTIA0に変更 .....                                                                                                                                                   | 3  |
| • Changed TYP values for the $I_{\text{AM, FRAM}}(0\%)$ parameter in <a href="#">Section 5.4, Active Mode Supply Current Into <math>V_{\text{CC}}</math> Excluding External Current</a> ..... | 16 |
| • Combined former sections 5.8 and 5.10 to <a href="#">Section 5.9, Production Distribution of LPM Supply Currents</a> .....                                                                  | 19 |
| • Added the $t_{\text{TB, cap}}$ parameter in <a href="#">Table 5-13, Timer_B</a> .....                                                                                                       | 30 |
| • Changed MAX values of the $t_{\text{VALID, SO}}$ parameter in <a href="#">Table 5-18, eUSCI (SPI Slave Mode) Switching Characteristics</a> .....                                            | 33 |
| • Changed the TYP value of the CMRR parameter with Test Conditions of "TRIPM = 0" from 70 dB to 80 dB in <a href="#">Table 5-25, TIA0</a> .....                                               | 40 |
| • Changed the TYP value of the PSRR parameter with Test Conditions of "TRIPM = 0" from 70 dB to 80 dB in <a href="#">Table 5-25, TIA0</a> .....                                               | 40 |
| • 以前の「開発ツールのサポート」セクションを、 <a href="#">8.3「ツールとソフトウェア」</a> に置き換え .....                                                                                                                          | 80 |

### 3 Device Comparison

Table 3-1 summarizes the features of the available family members.

**Table 3-1. Device Comparison<sup>(1) (2)</sup>**

| DEVICE            | PROGRAM<br>FRAM (KB) | SRAM<br>(Bytes) | TB0, TB1                | eUSCI_A | eUSCI_B | 10-BIT ADC<br>CHANNELS | SAC0<br>(OA) | TIA0 | eCOMP0 | I/O | PACKAGE          |
|-------------------|----------------------|-----------------|-------------------------|---------|---------|------------------------|--------------|------|--------|-----|------------------|
| MSP430FR2311IPW20 | 3.75                 | 1024            | 3 CCR <sup>(3)</sup>    | 1       | 1       | 8                      | 1            | 1    | 1      | 16  | 20 PW<br>(TSSOP) |
| MSP430FR2310IPW20 | 2                    | 1024            | 3 CCR <sup>(3)</sup>    | 1       | 1       | 8                      | 1            | 1    | 1      | 16  | 20 PW<br>(TSSOP) |
| MSP430FR2311IPW16 | 3.75                 | 1024            | 3 CCR <sup>(3)(4)</sup> | 1       | 1       | 8                      | 1            | 1    | 1      | 11  | 16 PW<br>(TSSOP) |
| MSP430FR2310IPW16 | 2                    | 1024            | 3 CCR <sup>(3)(4)</sup> | 1       | 1       | 8                      | 1            | 1    | 1      | 11  | 16 PW<br>(TSSOP) |
| MSP430FR2311IRGY  | 3.75                 | 1024            | 3 CCR <sup>(3)</sup>    | 1       | 1       | 8                      | 1            | 1    | 1      | 12  | 16 RGY<br>(VQFN) |
| MSP430FR2310IRGY  | 2                    | 1024            | 3 CCR <sup>(3)</sup>    | 1       | 1       | 8                      | 1            | 1    | 1      | 12  | 16 RGY<br>(VQFN) |

- (1) For the most current device, package, and ordering information, see the *Package Option Addendum* in 9, or see the TI website at [www.ti.com](http://www.ti.com).
- (2) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at [www.ti.com/packaging](http://www.ti.com/packaging).
- (3) A CCR register is a configurable register that provides internal and external capture or compare inputs, or internal and external PWM outputs.
- (4) TB1 provides only one external connection (TB1.1) on this package.

#### 3.1 Related Products

For information about other devices in this family of products or related products, see the following links.

[TI 16-bit and 32-bit microcontrollers](#)

High-performance, low-power solutions to enable the autonomous future

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Find reference designs leveraging the best in TI technology – from analog and power management to embedded processors

## 4 Terminal Configuration and Functions

### 4.1 Pin Diagrams

Figure 4-1 shows the pinout of the 20-pin PW package.

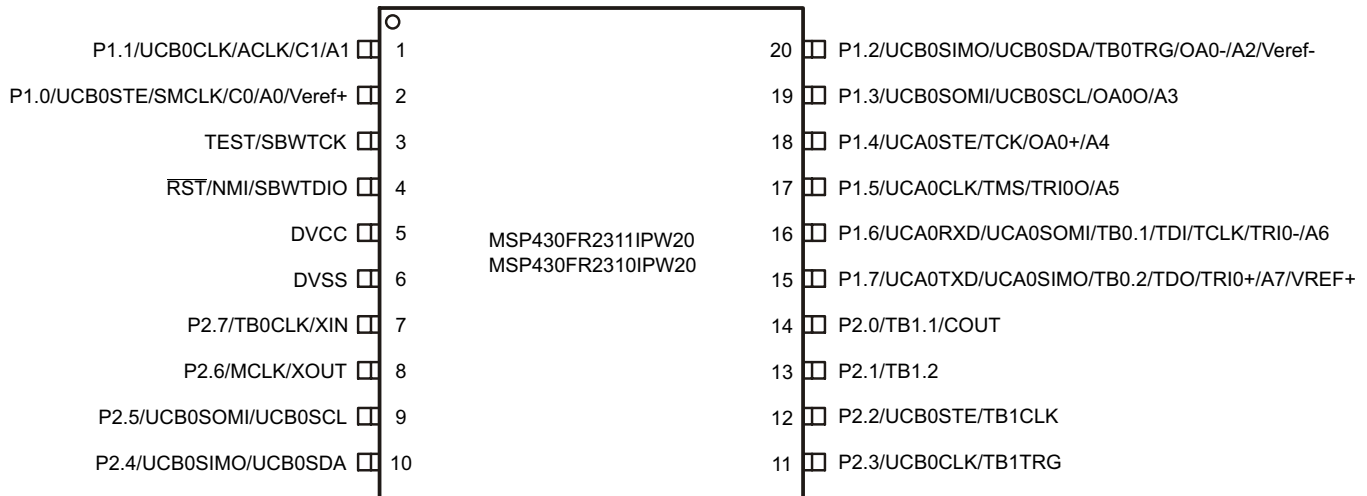


Figure 4-1. 20-Pin PW (TSSOP) (Top View)

Figure 4-2 shows the pinout of the 16-pin PW package.

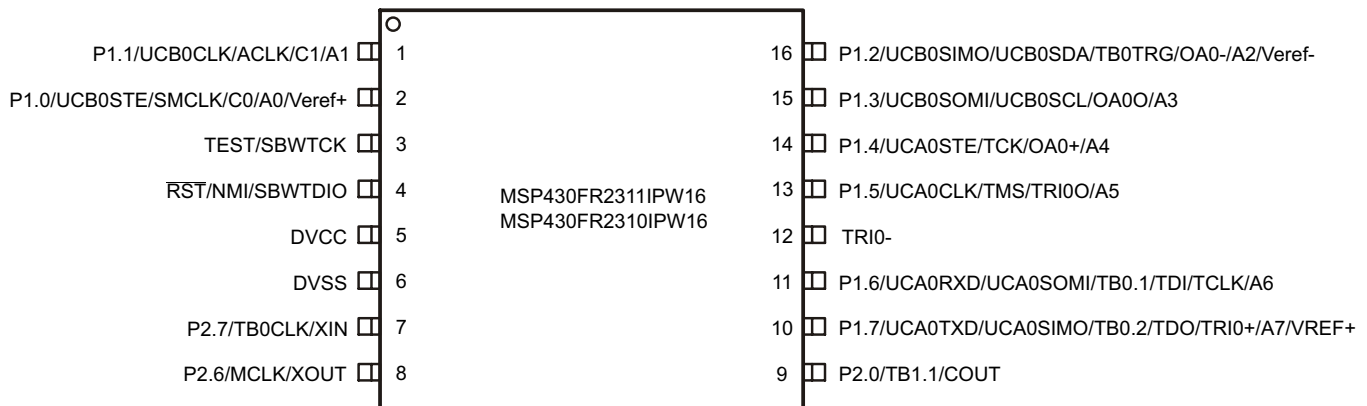
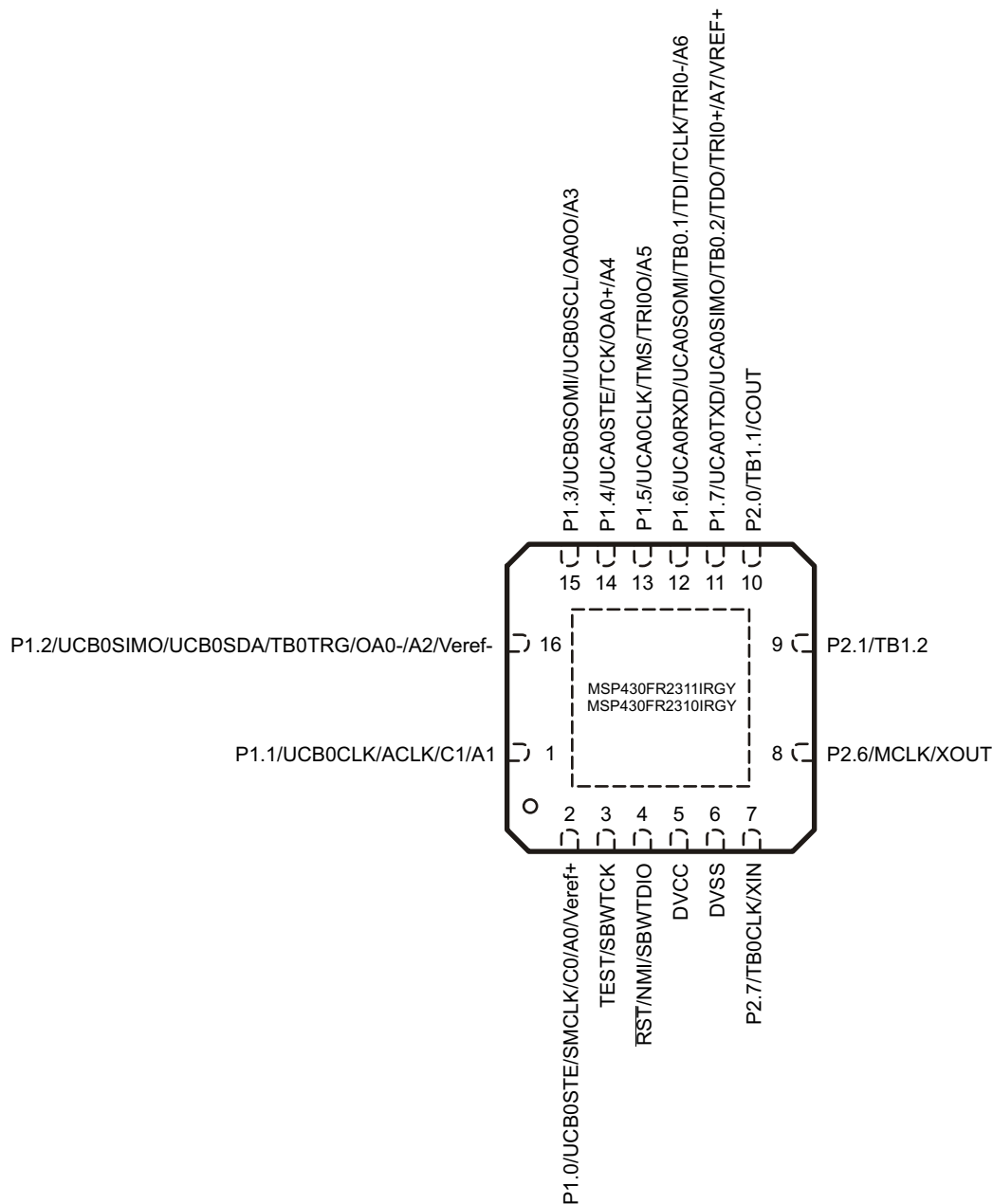


Figure 4-2. 16-Pin PW (TSSOP) (Top View)

Figure 4-3 shows the pinout of the 16-pin RGY package.



**Figure 4-3. 16-Pin RGY (VQFN) (Top View)**

## 4.2 Pin Attributes

Table 4-1 lists the attributes of all pins.

**Table 4-1. Pin Attributes**

| PIN NUMBER |     |      | SIGNAL NAME <sup>(1) (2)</sup> | SIGNAL TYPE <sup>(3)</sup> | BUFFER TYPE <sup>(4)</sup> | POWER SOURCE | RESET STATE AFTER BOR <sup>(5)</sup> |
|------------|-----|------|--------------------------------|----------------------------|----------------------------|--------------|--------------------------------------|
| PW20       | RGY | PW16 |                                |                            |                            |              |                                      |
| 1          | 1   | 1    | P1.1 (RD)                      | I/O                        | LVMOS                      | DVCC         | OFF                                  |
|            |     |      | UCB0CLK                        | I/O                        | LVMOS                      | DVCC         | N/A                                  |
|            |     |      | ACLK                           | O                          | LVMOS                      | DVCC         | N/A                                  |
|            |     |      | C1                             | I                          | Analog                     | DVCC         | N/A                                  |
|            |     |      | A1                             | I                          | Analog                     | DVCC         | N/A                                  |
| 2          | 2   | 2    | P1.0 (RD)                      | I/O                        | LVMOS                      | DVCC         | OFF                                  |
|            |     |      | UCB0STE                        | I/O                        | LVMOS                      | DVCC         | N/A                                  |
|            |     |      | SMCLK                          | O                          | LVMOS                      | DVCC         | N/A                                  |
|            |     |      | C0                             | I                          | Analog                     | DVCC         | N/A                                  |
|            |     |      | A0                             | I                          | Analog                     | DVCC         | N/A                                  |
|            |     |      | Veref+                         | I                          | Power                      | DVCC         | N/A                                  |
| 3          | 3   | 3    | TEST (RD)                      | I                          | LVMOS                      | DVCC         | OFF                                  |
|            |     |      | SBWTCK                         | I                          | LVMOS                      | DVCC         | N/A                                  |
| 4          | 4   | 4    | $\overline{\text{RST}}$ (RD)   | I/O                        | LVMOS                      | DVCC         | OFF                                  |
|            |     |      | NMI                            | I                          | LVMOS                      | DVCC         | N/A                                  |
|            |     |      | SBWTDIO                        | I/O                        | LVMOS                      | DVCC         | N/A                                  |
| 5          | 5   | 5    | DVCC                           | P                          | Power                      | DVCC         | N/A                                  |
| 6          | 6   | 6    | DVSS                           | P                          | Power                      | DVCC         | N/A                                  |
| 7          | 7   | 7    | P2.7 (RD)                      | I/O                        | LVMOS                      | DVCC         | OFF                                  |
|            |     |      | TB0CLK                         | I                          | LVMOS                      | DVCC         | N/A                                  |
|            |     |      | XIN                            | I                          | LVMOS                      | DVCC         | N/A                                  |
| 8          | 8   | 8    | P2.6 (RD)                      | I/O                        | LVMOS                      | DVCC         | OFF                                  |
|            |     |      | MCLK                           | O                          | LVMOS                      | DVCC         | N/A                                  |
|            |     |      | XOUT                           | O                          | LVMOS                      | DVCC         | N/A                                  |
| 9          | –   | –    | P2.5 (RD)                      | I/O                        | LVMOS                      | DVCC         | OFF                                  |
|            |     |      | UCB0SOMI                       | I/O                        | LVMOS                      | DVCC         | N/A                                  |
|            |     |      | UCB0SCL                        | I/O                        | LVMOS                      | DVCC         | N/A                                  |
| 10         | –   | –    | P2.4 (RD)                      | I/O                        | LVMOS                      | DVCC         | OFF                                  |
|            |     |      | UCB0SIMO                       | I/O                        | LVMOS                      | DVCC         | N/A                                  |
|            |     |      | UCB0SDA                        | I/O                        | LVMOS                      | DVCC         | N/A                                  |
| 11         | –   | –    | P2.3 (RD)                      | I/O                        | LVMOS                      | DVCC         | OFF                                  |
|            |     |      | UCB0CLK                        | I/O                        | LVMOS                      | DVCC         | N/A                                  |
|            |     |      | TB1TRG                         | I                          | LVMOS                      | DVCC         | N/A                                  |
| 12         | –   | –    | P2.2 (RD)                      | I/O                        | LVMOS                      | DVCC         | OFF                                  |
|            |     |      | UCB0STE                        | I/O                        | LVMOS                      | DVCC         | N/A                                  |
|            |     |      | TB1CLK                         | I                          | LVMOS                      | DVCC         | N/A                                  |
| 13         | 9   | –    | P2.1(RD)                       | I/O                        | LVMOS                      | DVCC         | OFF                                  |
|            |     |      | TB1.2                          | I/O                        | LVMOS                      | DVCC         | N/A                                  |

(1) Signals names with (RD) denote the reset default pin name.

(2) To determine the pin mux encodings for each pin, see [Section 6.12, Input/Output Diagrams](#).

(3) Signal Types: I = Input, O = Output, I/O = Input or Output.

(4) Buffer Types: LVMOS, Analog, or Power

(5) Reset States:

OFF = High-impedance input with pullup or pulldown disabled (if available)

N/A = Not applicable

**Table 4-1. Pin Attributes (continued)**

| PIN NUMBER |     |      | SIGNAL NAME <sup>(1) (2)</sup> | SIGNAL TYPE <sup>(3)</sup> | BUFFER TYPE <sup>(4)</sup> | POWER SOURCE | RESET STATE AFTER BOR <sup>(5)</sup> |
|------------|-----|------|--------------------------------|----------------------------|----------------------------|--------------|--------------------------------------|
| PW20       | RGY | PW16 |                                |                            |                            |              |                                      |
| 14         | 10  | 9    | P2.0 (RD)                      | I/O                        | LVC MOS                    | DVCC         | OFF                                  |
|            |     |      | TB1.1                          | I/O                        | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | COUT                           | O                          | LVC MOS                    | DVCC         | N/A                                  |
| 15         | 11  | 10   | P1.7 (RD)                      | I/O                        | LVC MOS                    | DVCC         | OFF                                  |
|            |     |      | UCA0TXD                        | O                          | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | UCA0SIMO                       | I/O                        | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | TB0.2                          | I/O                        | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | TDO                            | O                          | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | TRI0+                          | I                          | Analog                     | DVCC         | N/A                                  |
|            |     |      | A7                             | I                          | Analog                     | DVCC         | N/A                                  |
|            |     |      | VREF+                          | O                          | Power                      | DVCC         | N/A                                  |
| 16         | 12  | 11   | P1.6 (RD)                      | I/O                        | LVC MOS                    | DVCC         | OFF                                  |
|            |     |      | UCA0RXD                        | I                          | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | UCA0SOMI                       | I/O                        | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | TB0.1                          | I/O                        | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | TDI                            | I                          | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | TCLK                           | I                          | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | TRI0- <sup>(6)</sup>           | I                          | Analog                     | DVCC         | N/A                                  |
|            |     |      | A6                             | I                          | Analog                     | DVCC         | N/A                                  |
| –          | –   | 12   | TRI0-                          | I                          | Analog                     | DVCC         | N/A                                  |
| 17         | 13  | 13   | P1.5 (RD)                      | I/O                        | LVC MOS                    | DVCC         | OFF                                  |
|            |     |      | UCA0CLK                        | I/O                        | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | TMS                            | I                          | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | TRI0O                          | O                          | Analog                     | DVCC         | N/A                                  |
|            |     |      | A5                             | I                          | Analog                     | DVCC         | N/A                                  |
| 18         | 14  | 14   | P1.4 (RD)                      | I/O                        | LVC MOS                    | DVCC         | OFF                                  |
|            |     |      | UCA0STE                        | I/O                        | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | TCK                            | I                          | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | OA0+                           | I                          | Analog                     | DVCC         | N/A                                  |
|            |     |      | A4                             | I                          | Analog                     | DVCC         | N/A                                  |
| 19         | 15  | 15   | P1.3 (RD)                      | I/O                        | LVC MOS                    | DVCC         | OFF                                  |
|            |     |      | UCB0SOMI                       | I/O                        | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | UCB0SCL                        | I/O                        | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | OA0O                           | O                          | Analog                     | DVCC         | N/A                                  |
|            |     |      | A3                             | I                          | Analog                     | DVCC         | N/A                                  |
| 20         | 16  | 16   | P1.2 (RD)                      | I/O                        | LVC MOS                    | DVCC         | OFF                                  |
|            |     |      | UCB0SIMO                       | I/O                        | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | UCB0SDA                        | I/O                        | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | TB0TRG                         | I                          | LVC MOS                    | DVCC         | N/A                                  |
|            |     |      | OA0-                           | I                          | Analog                     | DVCC         | N/A                                  |
|            |     |      | A2                             | I                          | Analog                     | DVCC         | N/A                                  |
|            |     |      | Veref-                         | I                          | Power                      | DVCC         | N/A                                  |

(6) Not available on TSSOP-16 package

## 4.3 Signal Descriptions

Table 4-2 describes the signals for all device variants and package options.

**Table 4-2. Signal Descriptions**

| FUNCTION | SIGNAL NAME | PIN NUMBER |     |      | PIN TYPE | DESCRIPTION                                                   |
|----------|-------------|------------|-----|------|----------|---------------------------------------------------------------|
|          |             | PW20       | RGY | PW16 |          |                                                               |
| ADC      | A0          | 2          | 2   | 2    | I        | Analog input A0                                               |
|          | A1          | 1          | 1   | 1    | I        | Analog input A1                                               |
|          | A2          | 20         | 16  | 16   | I        | Analog input A2                                               |
|          | A3          | 19         | 15  | 15   | I        | Analog input A3                                               |
|          | A4          | 18         | 14  | 14   | I        | Analog input A4                                               |
|          | A5          | 17         | 13  | 13   | I        | Analog input A5                                               |
|          | A6          | 16         | 12  | 11   | I        | Analog input A6                                               |
|          | A7          | 15         | 11  | 10   | I        | Analog input A7                                               |
|          | Vref+       | 2          | 2   | 2    | I        | ADC positive reference                                        |
|          | Vref-       | 20         | 16  | 16   | I        | ADC negative reference                                        |
| eCOMP0   | C0          | 2          | 2   | 2    | I        | Comparator input channel C0                                   |
|          | C1          | 1          | 1   | 1    | I        | Comparator input channel C1                                   |
|          | COU         | 14         | 10  | 9    | O        | Comparator output channel COU                                 |
| TIA0     | TRI0+       | 15         | 11  | 10   | I        | TIA0 positive input                                           |
|          | TRI0-       | 16         | 12  | 12   | I        | TIA0 negative input                                           |
|          | TRI0O       | 17         | 13  | 13   | O        | TIA0 output                                                   |
| SAC0     | OA0+        | 18         | 14  | 14   | I        | SAC0, OA positive input                                       |
|          | OA0-        | 20         | 16  | 16   | I        | SAC0, OA negative input                                       |
|          | OA0O        | 19         | 15  | 15   | O        | SAC0, OA output                                               |
| Clock    | ACLK        | 1          | 1   | 1    | O        | ACLK output                                                   |
|          | MCLK        | 8          | 8   | 8    | O        | MCLK output                                                   |
|          | SMCLK       | 2          | 2   | 2    | O        | SMCLK output                                                  |
|          | XIN         | 7          | 7   | 7    | I        | Input terminal for crystal oscillator                         |
|          | XOUT        | 8          | 8   | 8    | O        | Output terminal for crystal oscillator                        |
| Debug    | SBWTCK      | 3          | 3   | 3    | I        | Spy-Bi-Wire input clock                                       |
|          | SBWTDIO     | 4          | 4   | 4    | I/O      | Spy-Bi-Wire data input/output                                 |
|          | TCK         | 18         | 14  | 14   | I        | Test clock                                                    |
|          | TCLK        | 16         | 12  | 11   | I        | Test clock input                                              |
|          | TDI         | 16         | 12  | 11   | I        | Test data input                                               |
|          | TDO         | 15         | 11  | 10   | O        | Test data output                                              |
|          | TMS         | 17         | 13  | 13   | I        | Test mode select                                              |
|          | TEST        | 3          | 3   | 3    | I        | Test Mode pin – selected digital I/O on JTAG pins             |
| System   | NMI         | 4          | 4   | 4    | I        | Nonmaskable interrupt input                                   |
|          | RST         | 4          | 4   | 4    | I/O      | Reset input, active-low                                       |
| Power    | DVCC        | 5          | 5   | 5    | P        | Power supply                                                  |
|          | DVSS        | 6          | 6   | 6    | P        | Power ground                                                  |
|          | VREF+       | 15         | 11  | 10   | P        | Output of positive reference voltage with ground as reference |

**Table 4-2. Signal Descriptions (continued)**

| FUNCTION | SIGNAL NAME             | PIN NUMBER |     |      | PIN TYPE | DESCRIPTION                                                |
|----------|-------------------------|------------|-----|------|----------|------------------------------------------------------------|
|          |                         | PW20       | RGY | PW16 |          |                                                            |
| GPIO     | P1.1                    | 1          | 1   | 1    | I/O      | General-purpose I/O                                        |
|          | P1.2                    | 20         | 16  | 16   | I/O      | General-purpose I/O                                        |
|          | P1.3                    | 19         | 12  | 15   | I/O      | General-purpose I/O                                        |
|          | P1.4                    | 18         | 14  | 14   | I/O      | General-purpose I/O <sup>(1)</sup>                         |
|          | P1.5                    | 17         | 13  | 13   | I/O      | General-purpose I/O <sup>(1)</sup>                         |
|          | P1.6                    | 16         | 12  | 11   | I/O      | General-purpose I/O <sup>(1)</sup>                         |
|          | P1.7                    | 15         | 11  | 10   | I/O      | General-purpose I/O <sup>(1)</sup>                         |
|          | P2.0                    | 14         | 10  | 9    | I/O      | General-purpose I/O                                        |
|          | P2.1                    | 13         | 9   | –    | I/O      | General-purpose I/O                                        |
|          | P2.2                    | 12         | –   | –    | I/O      | General-purpose I/O                                        |
|          | P2.3                    | 11         | –   | –    | I/O      | General-purpose I/O                                        |
|          | P2.4                    | 10         | –   | –    | I/O      | General-purpose I/O                                        |
|          | P2.5                    | 9          | –   | –    | I/O      | General-purpose I/O                                        |
|          | P2.6                    | 8          | 8   | 8    | I/O      | General-purpose I/O                                        |
|          | P2.7                    | 7          | 7   | 7    | I/O      | General-purpose I/O                                        |
| I2C      | UCB0SCL                 | 19         | 15  | 15   | I/O      | eUSCI_B0 I <sup>2</sup> C clock                            |
|          | UCB0SDA                 | 20         | 16  | 16   | I/O      | eUSCI_B0 I <sup>2</sup> C data                             |
|          | UCB0SCL <sup>(2)</sup>  | 9          | –   | –    | I/O      | eUSCI_B0 I <sup>2</sup> C clock                            |
|          | UCB0SDA <sup>(2)</sup>  | 10         | –   | –    | I/O      | eUSCI_B0 I <sup>2</sup> C data                             |
| SPI      | UCA0STE                 | 18         | 14  | 14   | I/O      | eUSCI_A0 SPI slave transmit enable                         |
|          | UCA0CLK                 | 17         | 13  | 13   | I/O      | eUSCI_A0 SPI clock input/output                            |
|          | UCA0SOMI                | 16         | 12  | 11   | I/O      | eUSCI_A0 SPI slave out/master in                           |
|          | UCA0SIMO                | 15         | 11  | 10   | I/O      | eUSCI_A0 SPI slave in/master out                           |
|          | UCB0STE                 | 2          | 2   | 2    | I/O      | eUSCI_B0 slave transmit enable                             |
|          | UCB0CLK                 | 1          | 1   | 1    | I/O      | eUSCI_B0 clock input/output                                |
|          | UCB0SIMO                | 20         | 16  | 16   | I/O      | eUSCI_B0 SPI slave in/master out                           |
|          | UCB0SOMI                | 19         | 15  | 15   | I/O      | eUSCI_B0 SPI slave out/master in                           |
|          | UCB0STE <sup>(2)</sup>  | 12         | –   | –    | I/O      | eUSCI_B0 slave transmit enable                             |
|          | UCB0CLK <sup>(2)</sup>  | 11         | –   | –    | I/O      | eUSCI_B0 clock input/output                                |
|          | UCB0SIMO <sup>(2)</sup> | 10         | –   | –    | I/O      | eUSCI_B0 SPI slave in/master out                           |
|          | UCB0SOMI <sup>(2)</sup> | 9          | –   | –    | I/O      | eUSCI_B0 SPI slave out/master in                           |
| UART     | UCA0RXD                 | 16         | 12  | 11   | I        | eUSCI_A0 UART receive data                                 |
|          | UCA0TXD                 | 15         | 11  | 10   | O        | eUSCI_A0 UART transmit data                                |
| Timer_B  | TB0.1                   | 16         | 12  | 11   | I/O      | Timer TB0 CCR1 capture: CCI1A input, compare: Out1 outputs |
|          | TB0.2                   | 15         | 11  | 10   | I/O      | Timer TB0 CCR2 capture: CCI2A input, compare: Out2 outputs |
|          | TB0CLK                  | 7          | 7   | 7    | I        | Timer clock input TBCLK for TB0                            |
|          | TB0TRG                  | 20         | 16  | 16   | I        | TB0 external trigger input for TB0OUTH                     |
|          | TB1.1                   | 14         | 10  | 9    | I/O      | Timer TB1 CCR1 capture: CCI1A input, compare: Out1 outputs |
|          | TB1.2                   | 13         | 9   | –    | I/O      | Timer TB1 CCR2 capture: CCI2A input, compare: Out2 outputs |
|          | TB1CLK                  | 12         | –   | –    | I        | Timer clock input TBCLK for TB1                            |
|          | TB1TRG                  | 11         | –   | –    | I        | TB1 external trigger input for TB1OUTH                     |

(1) Because this pin is multiplexed with the JTAG function, TI recommends disabling the pin interrupt function while in JTAG debug to prevent collisions.

(2) This is the remapped functionality controlled by the USCIBRMP bit of the SYSCFG2 register. Only one selected port is valid at any time.

**Table 4-2. Signal Descriptions (continued)**

| FUNCTION | SIGNAL NAME      | PIN NUMBER |     |      | PIN TYPE | DESCRIPTION                                                                     |
|----------|------------------|------------|-----|------|----------|---------------------------------------------------------------------------------|
|          |                  | PW20       | RGY | PW16 |          |                                                                                 |
| VQFN Pad | VQFN Thermal pad | –          | Pad | –    |          | VQFN package exposed thermal pad. TI recommends connection to V <sub>SS</sub> . |

**NOTE**

Functions shared with the four JTAG pins cannot be debugged if 4-wire JTAG is used for debug.

**4.4 Pin Multiplexing**

Pin multiplexing for these devices is controlled by both register settings and operating modes (for example, if the device is in test mode). For details of the settings for each pin and schematics of the multiplexed ports, see [Section 6.12](#).

**4.5 Buffer Type**

[Table 4-3](#) defines the pin buffer types that are listed in [Table 4-1](#).

**Table 4-3. Buffer Type**

| BUFFER TYPE (STANDARD) | NOMINAL VOLTAGE | HYSTERESIS       | PU OR PD     | NOMINAL PU OR PD STRENGTH (μA)     | OUTPUT DRIVE STRENGTH (mA)           | OTHER CHARACTERISTICS                                        |
|------------------------|-----------------|------------------|--------------|------------------------------------|--------------------------------------|--------------------------------------------------------------|
| LVC MOS                | 3.0 V           | Y <sup>(1)</sup> | Programmable | See <a href="#">Section 5.12.4</a> | See <a href="#">Section 5.12.4.1</a> |                                                              |
| Analog                 | 3.0 V           | N                | N            | N/A                                | N/A                                  | See analog modules in <a href="#">Section 5</a> for details. |
| Power (DVCC)           | 3.0 V           | N                | N            | N/A                                | N/A                                  | SVS enables hysteresis on DVCC.                              |
| Power (AVCC)           | 3.0 V           | N                | N            | N/A                                | N/A                                  |                                                              |

(1) Only for input pins.

**4.6 Connection of Unused Pins**

[Table 4-4](#) shows the correct termination of unused pins.

**Table 4-4. Connection of Unused Pins<sup>(1)</sup>**

| PIN          | POTENTIAL | COMMENT                                                                                  |
|--------------|-----------|------------------------------------------------------------------------------------------|
| Px.0 to Px.7 | Open      | Set to port function, output direction (PxDIR.n = 1)                                     |
| RST/NMI      | DVCC      | 47-kΩ pullup or internal pullup selected with 10-nF (or 1.1-nF <sup>(2)</sup> ) pulldown |
| TEST         | Open      | This pin always has an internal pulldown enabled.                                        |
| TRI0-        | Open      | This pin is a high-impedance output.                                                     |

(1) Any unused pin with a secondary function that is shared with general-purpose I/O should follow the Px.0 to Px.7 unused pin connection guidelines.

(2) The pulldown capacitor should not exceed 1.1 nF when using devices with Spy-Bi-Wire interface in Spy-Bi-Wire mode with TI tools like FET interfaces or GANG programmers. TI recommends a 1-nF capacitor to enable high-speed SBW communication.

## 5 Specifications

### 5.1 Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

|                                                      | MIN  | MAX                                  | UNIT |
|------------------------------------------------------|------|--------------------------------------|------|
| Voltage applied at DVCC pin to V <sub>SS</sub>       | −0.3 | 4.1                                  | V    |
| Voltage applied to any pin <sup>(2)</sup>            | −0.3 | V <sub>CC</sub> + 0.3<br>(4.1 V Max) | V    |
| Diode current at any device pin                      |      | ±2                                   | mA   |
| Maximum junction temperature, T <sub>J</sub>         |      | 85                                   | °C   |
| Storage temperature, T <sub>stg</sub> <sup>(3)</sup> | −40  | 125                                  | °C   |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages referenced to V<sub>SS</sub>.
- (3) Higher temperature may be applied during board soldering according to the current JEDEC J-STD-020 specification with peak reflow temperatures not higher than classified on the device label on the shipping boxes or reels.

### 5.2 ESD Ratings

|                                            |                                                                                | VALUE | UNIT |
|--------------------------------------------|--------------------------------------------------------------------------------|-------|------|
| V <sub>(ESD)</sub> Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>              | ±1000 | V    |
|                                            | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> | ±250  |      |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 500-V HBM is possible with the necessary precautions. Pins listed as ±1000 V may actually have higher performance.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 250-V CDM is possible with the necessary precautions. Pins listed as ±250 V may actually have higher performance.

### 5.3 Recommended Operating Conditions

|                     |                                                                | MIN                                                   | NOM | MAX               | UNIT |
|---------------------|----------------------------------------------------------------|-------------------------------------------------------|-----|-------------------|------|
| V <sub>CC</sub>     | Supply voltage applied at DVCC pin <sup>(1)(2)(3)(4)</sup>     | 1.8                                                   |     | 3.6               | V    |
| V <sub>SS</sub>     | Supply voltage applied at DVSS pin                             |                                                       | 0   |                   | V    |
| T <sub>A</sub>      | Operating free-air temperature                                 | −40                                                   |     | 85                | °C   |
| T <sub>J</sub>      | Operating junction temperature                                 | −40                                                   |     | 85                | °C   |
| C <sub>DVCC</sub>   | Recommended capacitor at DVCC <sup>(5)</sup>                   | 4.7                                                   | 10  |                   | μF   |
| f <sub>SYSTEM</sub> | Processor frequency (maximum MCLK frequency) <sup>(4)(6)</sup> | No FRAM wait states<br>(NWAITSx = 0)                  |     | 8                 | MHz  |
|                     |                                                                | With FRAM wait states<br>(NWAITSx = 1) <sup>(7)</sup> |     | 16 <sup>(8)</sup> |      |
| f <sub>ACLK</sub>   | Maximum ACLK frequency                                         |                                                       |     | 40                | kHz  |
| f <sub>SMCLK</sub>  | Maximum SMCLK frequency                                        |                                                       |     | 16 <sup>(8)</sup> | MHz  |

- (1) Supply voltage changes faster than 0.2 V/μs can trigger a BOR reset even within the recommended supply voltage range. Following the data sheet recommendation for capacitor C<sub>DVCC</sub> limits the slopes accordingly.
- (2) Modules may have a different supply voltage range specification. See the specification of the respective module in this data sheet.
- (3) TI recommends that power to the DVCC pin must not exceed the limits specified in *Recommended Operating Conditions*. Exceeding the specified limits can cause malfunction of the device including erroneous writes to RAM and FRAM.
- (4) The minimum supply voltage is defined by the SVS levels. See the SVS threshold parameters in [Table 5-1](#).
- (5) A capacitor tolerance of ±20% or better is required. A low-ESR ceramic capacitor of 100 nF (minimum) should be placed as close as possible (within a few millimeters) to the respective pin pair.
- (6) Modules may have a different maximum input clock specification. See the specification of the respective module in this data sheet.
- (7) Wait states only occur on actual FRAM accesses (that is, on FRAM cache misses). RAM and peripheral accesses are always executed without wait states.
- (8) If clock sources such as HF crystals or the DCO with frequencies >16 MHz are used, the clock must be divided in the clock system to comply with this operating condition.

## 5.4 Active Mode Supply Current Into $V_{CC}$ Excluding External Current<sup>(1)</sup>

| PARAMETER                           | EXECUTION MEMORY             | TEST CONDITIONS | FREQUENCY (f <sub>MCLK</sub> = f <sub>SMCLK</sub> ) |     |                                                     |     |                                                     |     | UNIT |
|-------------------------------------|------------------------------|-----------------|-----------------------------------------------------|-----|-----------------------------------------------------|-----|-----------------------------------------------------|-----|------|
|                                     |                              |                 | 1 MHz<br>0 WAIT STATES<br>(NWAITS <sub>x</sub> = 0) |     | 8 MHz<br>0 WAIT STATES<br>(NWAITS <sub>x</sub> = 0) |     | 16 MHz<br>1 WAIT STATE<br>(NWAITS <sub>x</sub> = 1) |     |      |
|                                     |                              |                 | TYP                                                 | MAX | TYP                                                 | MAX | TYP                                                 | MAX |      |
| I <sub>AM, FRAM</sub> (0%)          | FRAM<br>0% cache hit ratio   | 3.0 V, 25°C     | 474                                                 |     | 2639                                                |     | 3156                                                | μA  |      |
|                                     |                              | 3.0 V, 85°C     | 516                                                 |     | 2919                                                |     | 3205                                                |     |      |
| I <sub>AM, FRAM</sub> (100%)        | FRAM<br>100% cache hit ratio | 3.0 V, 25°C     | 196                                                 |     | 585                                                 |     | 958                                                 | μA  |      |
|                                     |                              | 3.0 V, 85°C     | 205                                                 |     | 598                                                 |     | 974                                                 |     |      |
| I <sub>AM, RAM</sub> <sup>(2)</sup> | RAM                          | 3.0 V, 25°C     | 219                                                 |     | 750                                                 |     | 1250                                                | μA  |      |

(1) All inputs are tied to 0 V or to  $V_{CC}$ . Outputs do not source or sink any current. Characterized with program executing typical data processing.

$f_{ACLK} = 32768$  Hz,  $f_{MCLK} = f_{SMCLK} = f_{DCO}$  at specified frequency

Program and data entirely reside in FRAM. All execution is from FRAM.

(2) Program and data reside entirely in RAM. All execution is from RAM. No access to FRAM.

## 5.5 Active Mode Supply Current Per MHz

$V_{CC} = 3.0$  V,  $T_A = 25^\circ C$  (unless otherwise noted)

| PARAMETER         | TEST CONDITIONS                                                                                                                                                                            | TYP | UNIT        |
|-------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|-------------|
| $dI_{AM,FRAM}/df$ | Active mode current consumption per MHz, execution from FRAM, no wait states <sup>(1)</sup><br>[[ $I_{AM}$ 75% cache hit rate at 8 MHz] – [ $I_{AM}$ 75% cache hit rate at 1 MHz]] / 7 MHz | 126 | $\mu A/MHz$ |

(1) All peripherals are turned on in default settings.

## 5.6 Low-Power Mode LPM0 Supply Currents Into $V_{CC}$ Excluding External Current

$V_{CC} = 3.0$  V,  $T_A = 25^\circ C$  (unless otherwise noted)<sup>(1) (2)</sup>

| PARAMETER         | V <sub>CC</sub> | FREQUENCY (f <sub>SMCLK</sub> ) |     |       |     |        |     | UNIT |
|-------------------|-----------------|---------------------------------|-----|-------|-----|--------|-----|------|
|                   |                 | 1 MHz                           |     | 8 MHz |     | 16 MHz |     |      |
|                   |                 | TYP                             | MAX | TYP   | MAX | TYP    | MAX |      |
| I <sub>LPM0</sub> | 2.0 V           | 158                             |     | 307   |     | 415    |     | μA   |
|                   | 3.0 V           | 169                             |     | 318   |     | 427    |     |      |

(1) All inputs are tied to 0 V or to  $V_{CC}$ . Outputs do not source or sink any current.

(2) Current for watchdog timer clocked by SMCLK included.

$f_{ACLK} = 32768$  Hz,  $f_{MCLK} = 0$  MHz,  $f_{SMCLK}$  at specified frequency.

## 5.7 Low-Power Mode LPM3 and LPM4 Supply Currents (Into $V_{CC}$ ) Excluding External Current

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(1)</sup> (see [Figure 5-1](#))

| PARAMETER                                                                                      | $V_{CC}$ | –40°C |     | 25°C |     | 85°C |      | UNIT    |
|------------------------------------------------------------------------------------------------|----------|-------|-----|------|-----|------|------|---------|
|                                                                                                |          | TYP   | MAX | TYP  | MAX | TYP  | MAX  |         |
| $I_{LPM3,XT1}$ Low-power mode 3, includes SVS <sup>(2) (3) (4)</sup>                           | 3.0 V    | 1.01  |     | 1.16 |     | 2.53 | 5.25 | $\mu A$ |
|                                                                                                | 2.0 V    | 0.99  |     | 1.13 |     | 2.49 |      |         |
| $I_{LPM3,VLO}$ Low-power mode 3, VLO, excludes SVS <sup>(5)</sup>                              | 3.0 V    | 0.88  |     | 1.02 |     | 2.39 | 5.06 | $\mu A$ |
|                                                                                                | 2.0 V    | 0.86  |     | 1.00 |     | 2.35 |      |         |
| $I_{LPM3, RTC}$ Low-power mode 3, RTC, excludes SVS <sup>(6)</sup>                             | 3.0 V    | 0.96  |     | 1.11 |     | 2.49 |      | $\mu A$ |
|                                                                                                | 2.0 V    | 0.94  |     | 1.09 |     | 2.45 |      |         |
| $I_{LPM4, SVS}$ Low-power mode 4, includes SVS <sup>(7)</sup>                                  | 3.0 V    | 0.50  |     | 0.60 |     | 1.93 |      | $\mu A$ |
|                                                                                                | 2.0 V    | 0.48  |     | 0.59 |     | 1.91 |      |         |
| $I_{LPM4}$ Low-power mode 4, excludes SVS <sup>(7)</sup>                                       | 3.0 V    | 0.34  |     | 0.45 |     | 1.77 |      | $\mu A$ |
|                                                                                                | 2.0 V    | 0.34  |     | 0.44 |     | 1.75 |      |         |
| $I_{LPM4, RTC, VLO}$ Low-power mode 4, RTC is sourced from VLO, excludes SVS <sup>(8)</sup>    | 3.0 V    | 0.48  |     | 0.59 |     | 1.91 |      | $\mu A$ |
|                                                                                                | 2.0 V    | 0.48  |     | 0.58 |     | 1.89 |      |         |
| $I_{LPM4, RTC, XT1}$ Low-power mode 4, RTC is sourced from XT1, excludes SVS <sup>(6)(9)</sup> | 3.0 V    | 0.89  |     | 1.04 |     | 2.41 |      | $\mu A$ |
|                                                                                                | 2.0 V    | 0.88  |     | 1.02 |     | 2.38 |      |         |

- (1) All inputs are tied to 0 V or to  $V_{CC}$ . Outputs do not source or sink any current.
- (2) Not applicable for devices with HF crystal oscillator only.
- (3) Characterized with a Seiko Crystal SC-32S crystal with a load capacitance chosen to closely match the required load.
- (4) Low-power mode 3, includes SVS test conditions:  
Current for watchdog timer clocked by ACLK and RTC clocked by XT1 included. Current for brownout and SVS included (SVSHE = 1).  
CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 0 (LPM3),  
 $f_{XT1} = 32768$  Hz,  $f_{ACLK} = f_{XT1}$ ,  $f_{MCLK} = f_{SMCLK} = 0$  MHz
- (5) Low-power mode 3, VLO, excludes SVS test conditions:  
Current for watchdog timer clocked by VLO included. RTC disabled. Current for brownout included. SVS disabled (SVSHE = 0).  
CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 0 (LPM3),  
 $f_{XT1} = 32768$  Hz,  $f_{MCLK} = f_{SMCLK} = 0$  MHz
- (6) RTC is sourced from external 32768-Hz crystal.
- (7) CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPM4), CPU and all clocks are disabled, WDT and RTC disabled
- (8) Low-power mode 4, VLO, excludes SVS test conditions:  
Current for RTC clocked by VLO included. Current for brownout included. SVS disabled (SVSHE = 0).  
CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPM4),  
 $f_{XT1} = 0$  Hz,  $f_{MCLK} = f_{SMCLK} = 0$  MHz
- (9) Low-power mode 4, XT1, excludes SVS test conditions:  
Current for RTC clocked by XT1 included. Current for brownout included. SVS disabled (SVSHE = 0).  
CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPM4),  
 $f_{XT1} = 32768$  Hz,  $f_{MCLK} = f_{SMCLK} = 0$  MHz

## 5.8 Low-Power Mode LPMx.5 Supply Currents (Into $V_{CC}$ ) Excluding External Current

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER         |                                                                                                                         | $V_{CC}$ | –40°C |     | 25°C  |     | 85°C  |       | UNIT    |
|-------------------|-------------------------------------------------------------------------------------------------------------------------|----------|-------|-----|-------|-----|-------|-------|---------|
|                   |                                                                                                                         |          | TYP   | MAX | TYP   | MAX | TYP   | MAX   |         |
| $I_{LPM3.5, XT1}$ | Low-power mode 3.5, includes SVS <sup>(1)</sup> <sup>(2)</sup> <sup>(3)</sup><br>(also see <a href="#">Figure 5-2</a> ) | 3.0 V    | 0.64  |     | 0.71  |     | 0.86  | 1.23  | $\mu A$ |
|                   |                                                                                                                         | 2.0 V    | 0.61  |     | 0.69  |     | 0.83  |       |         |
| $I_{LPM4.5, SVS}$ | Low-power mode 4.5, includes SVS <sup>(4)</sup> (also see <a href="#">Figure 5-3</a> )                                  | 3.0 V    | 0.23  |     | 0.25  |     | 0.30  | 0.45  | $\mu A$ |
|                   |                                                                                                                         | 2.0 V    | 0.21  |     | 0.24  |     | 0.29  |       |         |
| $I_{LPM4.5}$      | Low-power mode 4.5, excludes SVS <sup>(5)</sup>                                                                         | 3.0 V    | 0.020 |     | 0.032 |     | 0.071 | 0.120 | $\mu A$ |
|                   |                                                                                                                         | 2.0 V    | 0.022 |     | 0.034 |     | 0.068 |       |         |

(1) Not applicable for devices with HF crystal oscillator only.

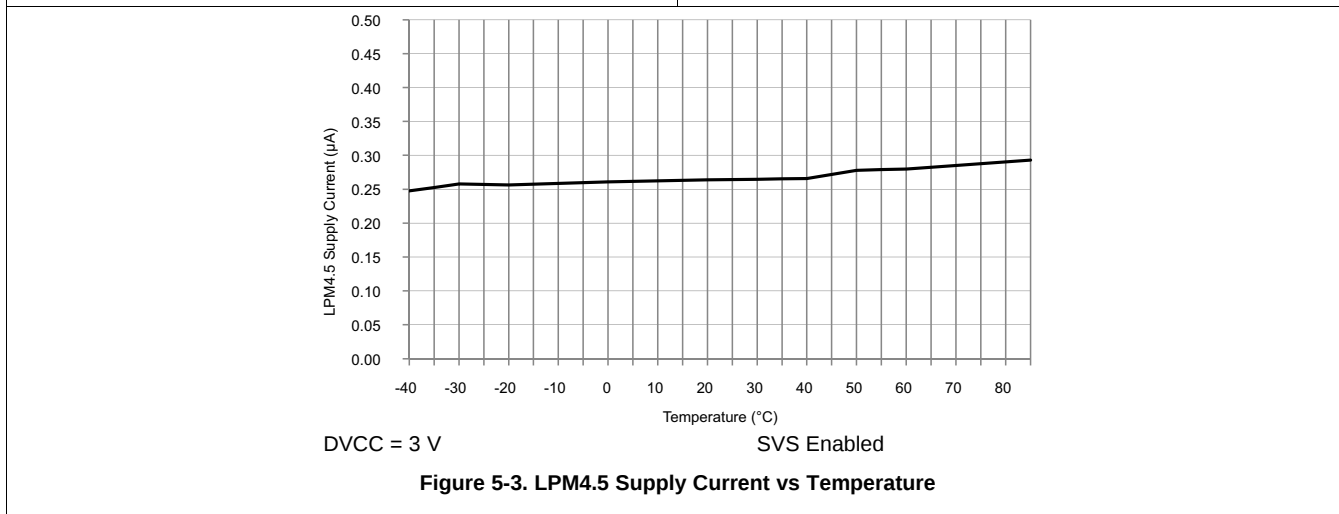
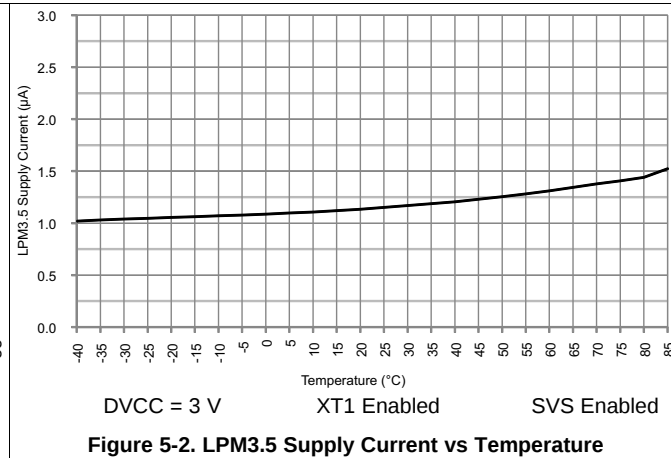
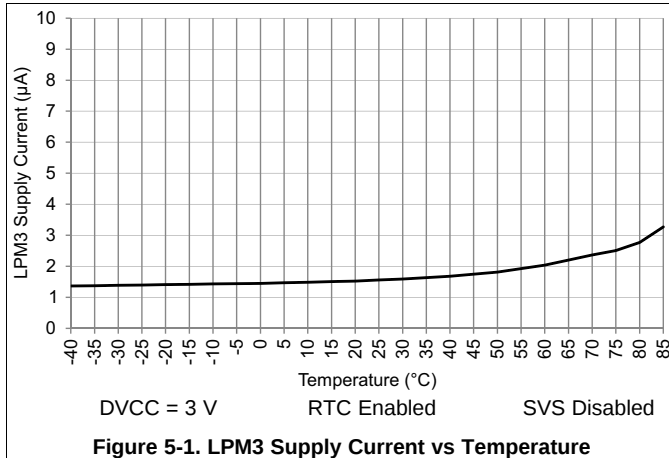
(2) Characterized with a Seiko Crystal SC-32S crystal with a load capacitance chosen to closely match the required load.

(3) Low-power mode 3.5, includes SVS test conditions:  
Current for RTC clocked by XT1 included. Current for brownout and SVS included (SVSHE = 1). Core regulator disabled.  
PMMREGOFF = 1, CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPMx.5),  
 $f_{XT1} = 32768$  Hz,  $f_{ACLK} = f_{XT1}$ ,  $f_{MCLK} = f_{SMCLK} = 0$  MHz

(4) Low-power mode 4.5, includes SVS test conditions:  
Current for brownout and SVS included (SVSHE = 1). Core regulator disabled.  
PMMREGOFF = 1, CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPMx.5),  
 $f_{XT1} = 0$  Hz,  $f_{ACLK} = f_{MCLK} = f_{SMCLK} = 0$  MHz

(5) Low-power mode 4.5, excludes SVS test conditions:  
Current for brownout included. SVS disabled (SVSHE = 0). Core regulator disabled.  
PMMREGOFF = 1, CPUOFF = 1, SCG0 = 1 SCG1 = 1, OSCOFF = 1 (LPMx.5),  
 $f_{XT1} = 0$  Hz,  $f_{ACLK} = f_{MCLK} = f_{SMCLK} = 0$  MHz

## 5.9 Production Distribution of LPM Supply Currents



## 5.10 Typical Characteristics – Current Consumption Per Module

| MODULE  | TEST CONDITIONS                  | REFERENCE CLOCK    | TYP | UNIT   |
|---------|----------------------------------|--------------------|-----|--------|
| Timer_B | SMCLK = 8 MHz, MC = 10b          | Module input clock | 5   | μA/MHz |
| eUSCI_A | UART mode                        | Module input clock | 7   | μA/MHz |
| eUSCI_A | SPI mode                         | Module input clock | 5   | μA/MHz |
| eUSCI_B | SPI mode                         | Module input clock | 5   | μA/MHz |
| eUSCI_B | I <sup>2</sup> C mode, 100 kbaud | Module input clock | 5   | μA/MHz |
| RTC     |                                  | 32 kHz             | 85  | nA     |
| CRC     | From start to end of operation   | MCLK               | 8.5 | μA/MHz |

## 5.11 Thermal Resistance Characteristics

|               |                                                                  |                     | VALUE | UNIT |
|---------------|------------------------------------------------------------------|---------------------|-------|------|
| $\theta_{JA}$ | Junction-to-ambient thermal resistance, still air <sup>(1)</sup> | VQFN 16 pin (RGY)   | 41.8  | °C/W |
|               |                                                                  | TSSOP 20 pin (PW20) | 92.6  |      |
|               |                                                                  | TSSOP 16 pin (PW16) | 104.1 |      |
| $\theta_{JC}$ | Junction-to-case (top) thermal resistance <sup>(2)</sup>         | VQFN 16 pin (RGY)   | 49.1  | °C/W |
|               |                                                                  | TSSOP 20 pin (PW20) | 26.1  |      |
|               |                                                                  | TSSOP 16 pin (PW16) | 38.5  |      |
| $\theta_{JB}$ | Junction-to-board thermal resistance <sup>(3)</sup>              | VQFN 16 pin (RGY)   | 18.5  | °C/W |
|               |                                                                  | TSSOP 20 pin (PW20) | 45.0  |      |
|               |                                                                  | TSSOP 16 pin (PW16) | 49.1  |      |

- (1) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, High-K board, as specified in JESD51-7, in an environment described in JESD51-2a.
- (2) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDEC-standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.
- (3) The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.

## 5.12 Timing and Switching Characteristics

### 5.12.1 Power Supply Sequencing

Table 5-1 lists the characteristics of the SVS and BOR.

**Table 5-1. PMM, SVS and BOR**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5-4)

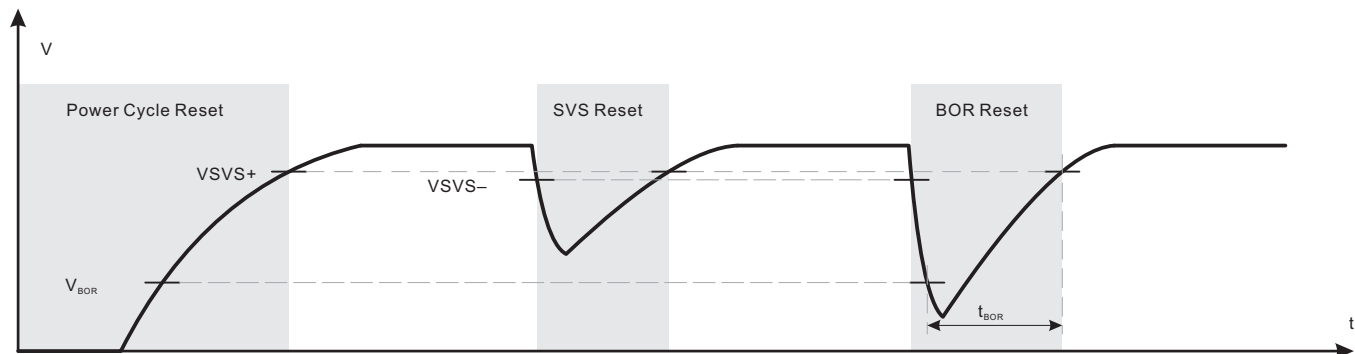
| PARAMETER               | TEST CONDITIONS                                       | MIN  | TYP  | MAX  | UNIT |
|-------------------------|-------------------------------------------------------|------|------|------|------|
| $V_{BOR, \text{ safe}}$ | Safe BOR power-down level <sup>(1)</sup>              | 0.1  |      |      | V    |
| $t_{BOR, \text{ safe}}$ | Safe BOR reset delay <sup>(2)</sup>                   | 10   |      |      | ms   |
| $I_{SVSH, AM}$          | SVS <sub>H</sub> current consumption, active mode     |      |      | 1.5  | μA   |
| $I_{SVSH, LPM}$         | SVS <sub>H</sub> current consumption, low-power modes |      | 240  |      | nA   |
| $V_{SVSH-}$             | SVS <sub>H</sub> power-down level <sup>(3)</sup>      | 1.71 | 1.80 | 1.87 | V    |
| $V_{SVSH+}$             | SVS <sub>H</sub> power-up level <sup>(3)</sup>        | 1.76 | 1.88 | 1.99 | V    |
| $V_{SVSH, \text{ hys}}$ | SVS <sub>H</sub> hysteresis                           |      | 80   |      | mV   |
| $t_{PD, SVSH, AM}$      | SVS <sub>H</sub> propagation delay, active mode       |      |      | 10   | μs   |
| $t_{PD, SVSH, LPM}$     | SVS <sub>H</sub> propagation delay, low-power modes   |      |      | 100  | μs   |

(1) A safe BOR is correctly generated only if DVCC drops below this voltage before it rises.

(2) When an BOR occurs, a safe BOR is correctly generated only if DVCC is kept low longer than this period before it reaches  $V_{SVSH+}$ .

(3) For additional information, see the [Dynamic Voltage Scaling Power Solution for MSP430 Devices With Single-Channel LDO Reference Design](#).

Figure 5-4 shows the reset conditions.



**Figure 5-4. Power Cycle, SVS, and BOR Reset Conditions**

### 5.12.2 Reset Timing

Table 5-2 lists the wake-up times from low-power modes and reset.

**Table 5-2. Wake-up Times From Low-Power Modes and Reset**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                   |                                                                                                                                                                                     | TEST CONDITIONS | V <sub>CC</sub> | MIN | TYP                             | MAX | UNIT |
|-----------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------|-----------------|-----|---------------------------------|-----|------|
| t <sub>WAKE-UP FRAM</sub>   | (Additional) wake-up time to activate the FRAM in AM if previously disabled through the FRAM controller or from a LPM if immediate activation is selected for wakeup <sup>(1)</sup> |                 | 3 V             |     | 10                              |     | μs   |
| t <sub>WAKE-UP LPM0</sub>   | Wake-up time from LPM0 to active mode <sup>(1)</sup>                                                                                                                                |                 | 3 V             |     | 200 +<br>2.5 / f <sub>DCO</sub> |     | ns   |
| t <sub>WAKE-UP LPM3</sub>   | Wake-up time from LPM3 to active mode <sup>(1)</sup>                                                                                                                                |                 | 3 V             |     | 10                              |     | μs   |
| t <sub>WAKE-UP LPM4</sub>   | Wake-up time from LPM4 to active mode <sup>(2)</sup>                                                                                                                                |                 | 3 V             |     | 10                              |     | μs   |
| t <sub>WAKE-UP LPM3.5</sub> | Wake-up time from LPM3.5 to active mode <sup>(2)</sup>                                                                                                                              |                 | 3 V             |     | 350                             |     | μs   |
| t <sub>WAKE-UP LPM4.5</sub> | Wake-up time from LPM4.5 to active mode <sup>(2)</sup>                                                                                                                              | SVSHE = 1       | 3 V             |     | 350                             |     | μs   |
|                             |                                                                                                                                                                                     | SVSHE = 0       | 3 V             |     | 1                               |     | ms   |
| t <sub>WAKE-UP-RESET</sub>  | Wake-up time from $\overline{\text{RST}}$ or BOR event to active mode <sup>(2)</sup>                                                                                                |                 | 3 V             |     | 1                               |     | ms   |
| t <sub>RESET</sub>          | Pulse duration required at $\overline{\text{RST}}$ /NMI pin to accept a reset                                                                                                       |                 |                 |     | 2                               |     | μs   |

- (1) The wake-up time is measured from the edge of an external wake-up signal (for example, port interrupt or wake-up event) to the first externally observable MCLK clock edge.
- (2) The wake-up time is measured from the edge of an external wake-up signal (for example, port interrupt or wake-up event) until the first instruction of the user program is executed.

### 5.12.3 Clock Specifications

Table 5-3 lists the characteristics of the XT1 crystal oscillator (low frequency).

**Table 5-3. XT1 Crystal Oscillator (Low Frequency)**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(1)(2)</sup>

| PARAMETER                |                                                          | TEST CONDITIONS                                                                                                        | V <sub>CC</sub> | MIN | TYP              | MAX  | UNIT |
|--------------------------|----------------------------------------------------------|------------------------------------------------------------------------------------------------------------------------|-----------------|-----|------------------|------|------|
| f <sub>XT1, LF</sub>     | XT1 oscillator crystal, low frequency                    | LFXTBYPASS = 0                                                                                                         |                 |     | 32768            |      | Hz   |
| DC <sub>XT1, LF</sub>    | XT1 oscillator LF duty cycle                             | Measured at MCLK,<br>f <sub>LFXT</sub> = 32768 Hz                                                                      |                 | 30% |                  | 70%  |      |
| f <sub>XT1, SW</sub>     | XT1 oscillator logic-level square-wave input frequency   | LFXTBYPASS = 1 <sup>(3) (4)</sup>                                                                                      |                 |     | 32768            |      | Hz   |
| DC <sub>XT1, SW</sub>    | LFXT oscillator logic-level square-wave input duty cycle | LFXTBYPASS = 1                                                                                                         |                 | 40% |                  | 60%  |      |
| OA <sub>LFXT</sub>       | Oscillation allowance for LF crystals <sup>(5)</sup>     | LFXTBYPASS = 0, LFXTDRIVE = {3},<br>f <sub>LFXT</sub> = 32768 Hz, C <sub>L,eff</sub> = 12.5 pF                         |                 |     | 200              |      | kΩ   |
| C <sub>L,eff</sub>       | Integrated effective load capacitance <sup>(6)</sup>     |                                                                                                                        |                 |     | <sup>(7)</sup> 1 |      | pF   |
| t <sub>START, LFXT</sub> | Start-up time <sup>(8)</sup>                             | f <sub>OSC</sub> = 32768 Hz<br>LFXTBYPASS = 0, LFXTDRIVE = {3},<br>T <sub>A</sub> = 25°C, C <sub>L,eff</sub> = 12.5 pF |                 |     | 1000             |      | ms   |
| f <sub>Fault, LFXT</sub> | Oscillator fault frequency <sup>(9)</sup>                | XTS = 0 <sup>(10)</sup>                                                                                                |                 | 0   |                  | 3500 | Hz   |

- (1) To improve EMI on the LFXT oscillator, observe the following guidelines.
  - Keep the trace between the device and the crystal as short as possible.
  - Design a good ground plane around the oscillator pins.
  - Prevent crosstalk from other clock or data lines into oscillator pins XIN and XOUT.
  - Avoid running PCB traces under or adjacent to the XIN and XOUT pins.
  - Use assembly materials and processes that avoid any parasitic load on the oscillator XIN and XOUT pins.
  - If conformal coating is used, make sure that it does not induce capacitive or resistive leakage between the oscillator pins.
- (2) See [MSP430 32-kHz Crystal Oscillators](#) for details on crystal section, layout, and testing.
- (3) When LFXTBYPASS is set, LFXT circuits are automatically powered down. Input signal is a digital square wave with parametrics defined in the Schmitt-trigger inputs section of this data sheet. Duty cycle requirements are defined by DC<sub>LFXT, SW</sub>.
- (4) Maximum frequency of operation of the entire device cannot be exceeded.
- (5) Oscillation allowance is based on a safety factor of 5 for recommended crystals. The oscillation allowance is a function of the LFXTDRIVE settings and the effective load. In general, comparable oscillator allowance can be achieved based on the following guidelines, but should be evaluated based on the actual crystal selected for the application:
  - For LFXTDRIVE = {0}, C<sub>L,eff</sub> = 3.7 pF.
  - For LFXTDRIVE = {1}, 6 pF ≤ C<sub>L,eff</sub> ≤ 9 pF.
  - For LFXTDRIVE = {2}, 6 pF ≤ C<sub>L,eff</sub> ≤ 10 pF.
  - For LFXTDRIVE = {3}, 6 pF ≤ C<sub>L,eff</sub> ≤ 12 pF.
- (6) Includes parasitic bond and package capacitance (approximately 2 pF per pin).
- (7) Requires external capacitors at both terminals to meet the effective load capacitance specified by crystal manufacturers. Recommended effective load capacitance values supported are 3.7 pF, 6 pF, 9 pF, and 12.5 pF. Maximum shunt capacitance of 1.6 pF. The PCB adds additional capacitance, so it must also be considered in the overall capacitance. Verify that the recommended effective load capacitance of the selected crystal is met.
- (8) Includes start-up counter of 1024 clock cycles.
- (9) Frequencies above the MAX specification do not set the fault flag. Frequencies in between the MIN and MAX specification may set the flag. A static condition or stuck at fault condition sets the flag.
- (10) Measured with logic-level input frequency but also applies to operation with crystals.

Table 5-4 lists the characteristics of the XT1 crystal oscillator (high frequency).

**Table 5-4. XT1 Crystal Oscillator (High Frequency)**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(1)</sup>

| PARAMETER               |                                                                      | TEST CONDITIONS                                                                                                                                    | V <sub>CC</sub> | MIN  | TYP | MAX | UNIT |
|-------------------------|----------------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------|-----------------|------|-----|-----|------|
| f <sub>HFXT</sub>       | HFXT oscillator crystal frequency, crystal mode                      | XT1BYPASS = 0, XTS = 1, XT1HFFREQ = 00                                                                                                             |                 | 1    |     | 4   | MHz  |
|                         |                                                                      | XT1BYPASS = 0, XTS = 1, XT1HFFREQ = 01                                                                                                             |                 | 4.01 |     | 6   |      |
|                         |                                                                      | XT1BYPASS = 0, XTS = 1, XT1HFFREQ = 10                                                                                                             |                 | 6.01 |     | 16  |      |
| f <sub>HFXT,SW</sub>    | HFXT oscillator logic-level square-wave input frequency, bypass mode | XT1BYPASS = 1, XTS = 1 <sup>(2) (3)</sup>                                                                                                          |                 | 1    |     | 16  | MHz  |
| DC <sub>HFXT</sub>      | HFXT oscillator duty cycle                                           | Measured at ACLK, f <sub>HFXT,HF</sub> = 4 MHz <sup>(4)</sup>                                                                                      |                 | 40%  |     | 60% |      |
| DC <sub>HFXT,SW</sub>   | HFXT oscillator logic-level square-wave input duty cycle             | XT1BYPASS = 1                                                                                                                                      |                 | 40%  |     | 60% |      |
| OA <sub>HFXT</sub>      | Oscillation allowance for HFXT crystals <sup>(5)</sup>               | XT1BYPASS = 0, XT1HFSEL = 1, f <sub>HFXT,HF</sub> = 16 MHz, C <sub>L,eff</sub> = 18 pF                                                             |                 |      | 2.4 |     | kΩ   |
| t <sub>START,HFXT</sub> | Start-up time <sup>(6)</sup>                                         | f <sub>OSC</sub> = 4 MHz, XTS = 1 <sup>(4)</sup> , XT1BYPASS = 0, XT1HFFREQ = 00, XT1DRIVE = 3, T <sub>A</sub> = 25°C, C <sub>L,eff</sub> = 18 pF  |                 |      | 1.6 |     | ms   |
|                         |                                                                      | f <sub>OSC</sub> = 16 MHz, XTS = 1 <sup>(4)</sup> , XT1BYPASS = 0, XT1HFFREQ = 00, XT1DRIVE = 3, T <sub>A</sub> = 25°C, C <sub>L,eff</sub> = 18 pF |                 |      | 1.1 |     |      |
| C <sub>L,eff</sub>      | Integrated effective load capacitance <sup>(7) (8)</sup>             |                                                                                                                                                    |                 |      | 1   |     | pF   |
| f <sub>Fault,HFXT</sub> | Oscillator fault frequency <sup>(9) (10)</sup>                       |                                                                                                                                                    |                 | 0    |     | 800 | kHz  |

- (1) To improve EMI on the HFXT oscillator, the following guidelines should be observed.
  - Keep the trace between the device and the crystal as short as possible.
  - Design a good ground plane around the oscillator pins.
  - Prevent crosstalk from other clock or data lines into oscillator pins XIN and XOUT.
  - Avoid running PCB traces under or adjacent to the XIN and XOUT pins.
  - Use assembly materials and processes that avoid any parasitic load on the oscillator XIN and XOUT pins.
  - If conformal coating is used, make sure that it does not induce capacitive or resistive leakage between the oscillator pins.
- (2) When XT1BYPASS is set, HFXT circuits are automatically powered down. Input signal is a digital square wave with parametrics defined in the Schmitt-trigger Inputs section of this datasheet. Duty cycle requirements are defined by DC<sub>HFXT, SW</sub>.
- (3) Maximum frequency of operation of the entire device cannot be exceeded.
- (4) 4-MHz crystal used for lab characterization: Abracon HC49/U AB-4.000MHZ-B2  
16-MHz crystal used for lab characterization: Abracon HC49/U AB-16.000MHZ-B2
- (5) Oscillation allowance is based on a safety factor of 5 for recommended crystals.
- (6) Includes start-up counter of 4096 clock cycles.
- (7) Includes parasitic bond and package capacitance (approximately 2 pF per pin).  
Because the PCB adds additional capacitance, TI recommends verifying the correct load by measuring the oscillator frequency through MCLK or SMCLK. For a correct setup, the effective load capacitance should always match the specification of the used crystal.
- (8) Requires external capacitors at both terminals. Values are specified by crystal manufacturers. Recommended values supported are 14 pF, 16 pF, and 18 pF. Maximum shunt capacitance of 7 pF.
- (9) Frequencies above the MAX specification do not set the fault flag. Frequencies between the MIN and MAX might set the flag. A static condition or stuck at fault condition sets the flag.
- (10) Measured with logic-level input frequency but also applies to operation with crystals.

Table 5-5 lists the characteristics of the DCO FLL.

**Table 5-5. DCO FLL**

over recommended operating free-air temperature (unless otherwise noted)

| PARAMETER              |                                           | TEST CONDITIONS                                      | V <sub>CC</sub> | MIN   | TYP    | MAX  | UNIT |
|------------------------|-------------------------------------------|------------------------------------------------------|-----------------|-------|--------|------|------|
| f <sub>DCO, FLL</sub>  | FLL lock frequency, 16 MHz, 25°C          | Measured at MCLK, internal trimmed REFO as reference | 3.0 V           | –1.0% |        | 1.0% |      |
|                        | FLL lock frequency, 16 MHz, –40°C to 85°C |                                                      |                 | –2.0% |        | 2.0% |      |
|                        | FLL lock frequency, 16 MHz, –40°C to 85°C | Measured at MCLK, XT1 crystal as reference           |                 | –0.5% |        | 0.5% |      |
| f <sub>DUTY</sub>      | Duty cycle                                | Measured at MCLK, XT1 crystal as reference           | 3.0 V           | 40%   | 50%    | 60%  |      |
| Jitter <sub>cc</sub>   | Cycle-to-cycle jitter, 16 MHz             | Measured at MCLK, XT1 crystal as reference           | 3.0 V           |       | 0.25%  |      |      |
| Jitter <sub>long</sub> | Long-term jitter, 16 MHz                  | Measured at MCLK, XT1 crystal as reference           | 3.0 V           |       | 0.022% |      |      |
| t <sub>FLL, lock</sub> | FLL lock time, 16 MHz                     | Measured at MCLK, XT1 crystal as reference           | 3.0 V           |       | 200    |      | ms   |

Table 5-6 lists the characteristics of the DCO frequency.

**Table 5-6. DCO Frequency**

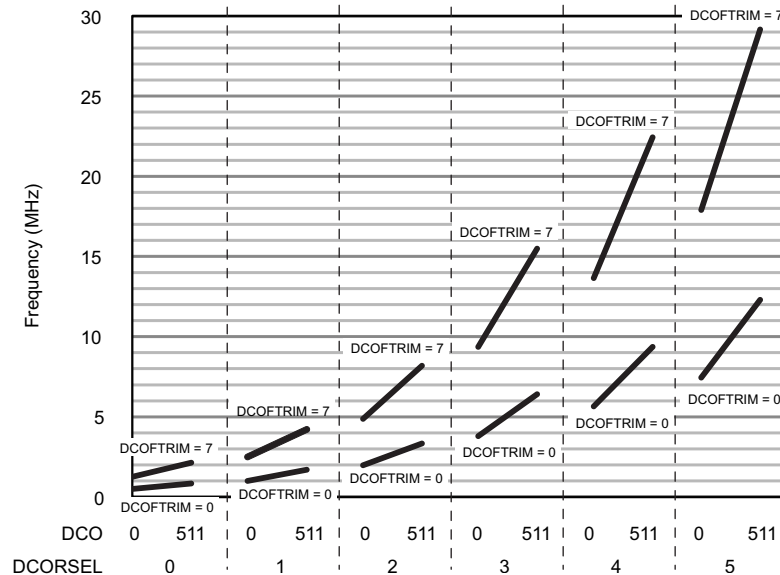
over recommended operating free-air temperature (unless otherwise noted) (see Figure 5-5)

| PARAMETER                |                       | TEST CONDITIONS                                         | MIN | TYP  | MAX | UNIT |
|--------------------------|-----------------------|---------------------------------------------------------|-----|------|-----|------|
| f <sub>DCO, 16 MHz</sub> | DCO frequency, 16 MHz | DCORSEL = 101b, DISMOD = 1b, DCOFTRIM = 000b, DCO = 0   |     | 7.8  |     | MHz  |
|                          |                       | DCORSEL = 101b, DISMOD = 1b, DCOFTRIM = 000b, DCO = 511 |     | 12.5 |     |      |
|                          |                       | DCORSEL = 101b, DISMOD = 1b, DCOFTRIM = 111b, DCO = 0   |     | 18   |     |      |
|                          |                       | DCORSEL = 101b, DISMOD = 1b, DCOFTRIM = 111b, DCO = 511 |     | 30   |     |      |
| f <sub>DCO, 12 MHz</sub> | DCO frequency, 12 MHz | DCORSEL = 100b, DISMOD = 1b, DCOFTRIM = 000b, DCO = 0   |     | 6    |     | MHz  |
|                          |                       | DCORSEL = 100b, DISMOD = 1b, DCOFTRIM = 000b, DCO = 511 |     | 9.5  |     |      |
|                          |                       | DCORSEL = 100b, DISMOD = 1b, DCOFTRIM = 111b, DCO = 0   |     | 13.5 |     |      |
|                          |                       | DCORSEL = 100b, DISMOD = 1b, DCOFTRIM = 111b, DCO = 511 |     | 22   |     |      |
| f <sub>DCO, 8 MHz</sub>  | DCO frequency, 8 MHz  | DCORSEL = 011b, DISMOD = 1b, DCOFTRIM = 000b, DCO = 0   |     | 3.8  |     | MHz  |
|                          |                       | DCORSEL = 011b, DISMOD = 1b, DCOFTRIM = 000b, DCO = 511 |     | 6.5  |     |      |
|                          |                       | DCORSEL = 011b, DISMOD = 1b, DCOFTRIM = 111b, DCO = 0   |     | 9.5  |     |      |
|                          |                       | DCORSEL = 011b, DISMOD = 1b, DCOFTRIM = 111b, DCO = 511 |     | 16   |     |      |
| f <sub>DCO, 4 MHz</sub>  | DCO frequency, 4 MHz  | DCORSEL = 010b,, DISMOD = 1b, DCOFTRIM = 000b, DCO = 0  |     | 2    |     | MHz  |
|                          |                       | DCORSEL = 010b, DISMOD = 1b, DCOFTRIM = 000b, DCO = 511 |     | 3.2  |     |      |
|                          |                       | DCORSEL = 010b, DISMOD = 1b, DCOFTRIM = 111b, DCO = 0   |     | 4.8  |     |      |
|                          |                       | DCORSEL = 010b, DISMOD = 1b, DCOFTRIM = 111b, DCO = 511 |     | 8    |     |      |

**Table 5-6. DCO Frequency (continued)**

over recommended operating free-air temperature (unless otherwise noted) (see [Figure 5-5](#))

| PARAMETER                                    | TEST CONDITIONS                                         | MIN | TYP  | MAX | UNIT |
|----------------------------------------------|---------------------------------------------------------|-----|------|-----|------|
| $f_{\text{DCO, 2 MHz}}$ DCO frequency, 2 MHz | DCORSEL = 001b, DISMOD = 1b, DCOFTRIM = 000b, DCO = 0   |     | 1    |     | MHz  |
|                                              | DCORSEL = 001b, DISMOD = 1b, DCOFTRIM = 000b, DCO = 511 |     | 1.7  |     |      |
|                                              | DCORSEL = 001b, DISMOD = 1b, DCOFTRIM = 111b, DCO = 0   |     | 2.5  |     |      |
|                                              | DCORSEL = 001b, DISMOD = 1b, DCOFTRIM = 111b, DCO = 511 |     | 4.2  |     |      |
| $f_{\text{DCO, 1 MHz}}$ DCO frequency, 1 MHz | DCORSEL = 000b, DISMOD = 1b, DCOFTRIM = 000b, DCO = 0   |     | 0.5  |     | MHz  |
|                                              | DCORSEL = 000b, DISMOD = 1b, DCOFTRIM = 000b, DCO = 511 |     | 0.85 |     |      |
|                                              | DCORSEL = 000b, DISMOD = 1b, DCOFTRIM = 111b, DCO = 0   |     | 1.2  |     |      |
|                                              | DCORSEL = 000b, DISMOD = 1b, DCOFTRIM = 111b, DCO = 511 |     | 2.1  |     |      |

**Figure 5-5. Typical DCO Frequency**

[Table 5-7](#) lists the characteristics of the REFO.

**Table 5-7. REFO**

over recommended operating free-air temperature (unless otherwise noted)

| PARAMETER                         | TEST CONDITIONS                     | V <sub>CC</sub>                                       | MIN            | TYP   | MAX   | UNIT                |
|-----------------------------------|-------------------------------------|-------------------------------------------------------|----------------|-------|-------|---------------------|
| $I_{\text{REFO}}$                 | REFO oscillator current consumption | $T_A = 25^\circ\text{C}$                              | 3.0 V          | 15    |       | $\mu\text{A}$       |
| $f_{\text{REFO}}$                 | REFO calibrated frequency           | Measured at MCLK                                      | 3.0 V          | 32768 |       | Hz                  |
|                                   | REFO absolute calibrated tolerance  | $T_A = -40^\circ\text{C}$ to $85^\circ\text{C}$       | 1.8 V to 3.6 V | -3.5% | +3.5% |                     |
| $df_{\text{REFO}}/dT$             | REFO frequency temperature drift    | Measured at MCLK <sup>(1)</sup>                       | 3.0 V          | 0.01  |       | $\%/^\circ\text{C}$ |
| $df_{\text{REFO}}/dV_{\text{CC}}$ | REFO frequency supply voltage drift | Measured at MCLK at $25^\circ\text{C}$ <sup>(2)</sup> | 1.8 V to 3.6 V | 1     |       | $\%/V$              |
| $f_{\text{DC}}$                   | REFO duty cycle                     | Measured at MCLK                                      | 1.8 V to 3.6 V | 40%   | 50%   | 60%                 |
| $t_{\text{START}}$                | REFO start-up time                  | 40% to 60% duty cycle                                 |                | 50    |       | $\mu\text{s}$       |

(1) Calculated using the box method:  $(\text{MAX}(-40^\circ\text{C to } 85^\circ\text{C}) - \text{MIN}(-40^\circ\text{C to } 85^\circ\text{C})) / \text{MIN}(-40^\circ\text{C to } 85^\circ\text{C}) / (85^\circ\text{C} - (-40^\circ\text{C}))$

(2) Calculated using the box method:  $(\text{MAX}(1.8 \text{ V to } 3.6 \text{ V}) - \text{MIN}(1.8 \text{ V to } 3.6 \text{ V})) / \text{MIN}(1.8 \text{ V to } 3.6 \text{ V}) / (3.6 \text{ V} - 1.8 \text{ V})$

Table 5-8 lists the characteristics of the internal very-low-power low-frequency oscillator (VLO).

**Table 5-8. Internal Very-Low-Power Low-Frequency Oscillator (VLO)**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                                              | TEST CONDITIONS                 | V <sub>CC</sub> | MIN | TYP | MAX | UNIT |
|------------------------------------------------------------------------|---------------------------------|-----------------|-----|-----|-----|------|
| f <sub>VLO</sub> VLO frequency                                         | Measured at MCLK                | 3.0 V           |     | 10  |     | kHz  |
| df <sub>VLO</sub> /dT VLO frequency temperature drift                  | Measured at MCLK <sup>(1)</sup> | 3.0 V           |     | 0.5 |     | %/°C |
| df <sub>VLO</sub> /dV <sub>CC</sub> VLO frequency supply voltage drift | Measured at MCLK <sup>(2)</sup> | 1.8 V to 3.6 V  |     | 4   |     | %/V  |
| f <sub>VLO,DC</sub> Duty cycle                                         | Measured at MCLK                | 3.0 V           |     | 50% |     |      |

(1) Calculated using the box method: (MAX(–40°C to 85°C) – MIN(–40°C to 85°C)) / MIN(–40°C to 85°C) / (85°C – (–40°C))

(2) Calculated using the box method: (MAX(1.8 V to 3.6 V) – MIN(1.8 V to 3.6 V)) / MIN(1.8 V to 3.6 V) / (3.6 V – 1.8 V)

#### NOTE

The VLO clock frequency is reduced by 15% (typical) when the device switches from active mode or LPM0 to LPM3 or LPM4, because the reference changes. This lower frequency is not a violation of the VLO specifications (see Table 5-8).

Table 5-9 lists the characteristics of the module oscillator (MODOSC).

**Table 5-9. Module Oscillator (MODOSC)**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                                                   | V <sub>CC</sub> | MIN | TYP   | MAX | UNIT |
|-----------------------------------------------------------------------------|-----------------|-----|-------|-----|------|
| f <sub>MODOSC</sub> MODOSC frequency                                        | 3.0 V           | 3.8 | 4.8   | 5.8 | MHz  |
| f <sub>MODOSC</sub> /dT MODOSC frequency temperature drift                  | 3.0 V           |     | 0.102 |     | %/°C |
| f <sub>MODOSC</sub> /dV <sub>CC</sub> MODOSC frequency supply voltage drift | 1.8 V to 3.6 V  |     | 1.02  |     | %/V  |
| f <sub>MODOSC,DC</sub> Duty cycle                                           | 3.0 V           | 40% | 50%   | 60% |      |

## 5.12.4 Digital I/Os

Table 5-10 lists the characteristics of the digital inputs.

**Table 5-10. Digital Inputs**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                                                                                           | TEST CONDITIONS                                                                                  | V <sub>CC</sub> | MIN  | TYP | MAX  | UNIT |
|---------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------|-----------------|------|-----|------|------|
| V <sub>IT+</sub> Positive-going input threshold voltage                                                             |                                                                                                  | 2 V             | 0.90 |     | 1.50 | V    |
|                                                                                                                     |                                                                                                  | 3 V             | 1.35 |     | 2.25 |      |
| V <sub>IT-</sub> Negative-going input threshold voltage                                                             |                                                                                                  | 2 V             | 0.50 |     | 1.10 | V    |
|                                                                                                                     |                                                                                                  | 3 V             | 0.75 |     | 1.65 |      |
| V <sub>hys</sub> Input voltage hysteresis (V <sub>IT+</sub> – V <sub>IT-</sub> )                                    |                                                                                                  | 2 V             | 0.3  |     | 0.8  | V    |
|                                                                                                                     |                                                                                                  | 3 V             | 0.4  |     | 1.2  |      |
| R <sub>Pull</sub> Pullup or pulldown resistor                                                                       | For pullup: V <sub>IN</sub> = V <sub>SS</sub><br>For pulldown: V <sub>IN</sub> = V <sub>CC</sub> |                 | 20   | 35  | 50   | kΩ   |
| C <sub>i,dig</sub> Input capacitance, digital only port pins                                                        | V <sub>IN</sub> = V <sub>SS</sub> or V <sub>CC</sub>                                             |                 |      | 3   |      | pF   |
| C <sub>i,ana</sub> Input capacitance, port pins with shared analog functions                                        | V <sub>IN</sub> = V <sub>SS</sub> or V <sub>CC</sub>                                             |                 |      | 5   |      | pF   |
| I <sub>lkg(Px.y)</sub> High-impedance leakage current <sup>(1)(2)</sup>                                             |                                                                                                  | 2 V, 3 V        | –20  |     | +20  | nA   |
| t <sub>(int)</sub> External interrupt timing (external trigger pulse duration to set interrupt flag) <sup>(3)</sup> | Ports with interrupt capability (see block diagram and terminal function descriptions)           | 2 V, 3 V        | 50   |     |      | ns   |

(1) The leakage current is measured with V<sub>SS</sub> or V<sub>CC</sub> applied to the corresponding pins, unless otherwise noted.

(2) The leakage of the digital port pins is measured individually. The port pin is selected for input and the pullup or pulldown resistor is disabled.

(3) An external signal sets the interrupt flag every time the minimum interrupt pulse duration t<sub>(int)</sub> is met. The interrupt flag may be set by trigger signals shorter than t<sub>(int)</sub>.

Table 5-11 lists the characteristics of the digital outputs. Also see Figure 5-6 through Figure 5-9.

**Table 5-11. Digital Outputs**

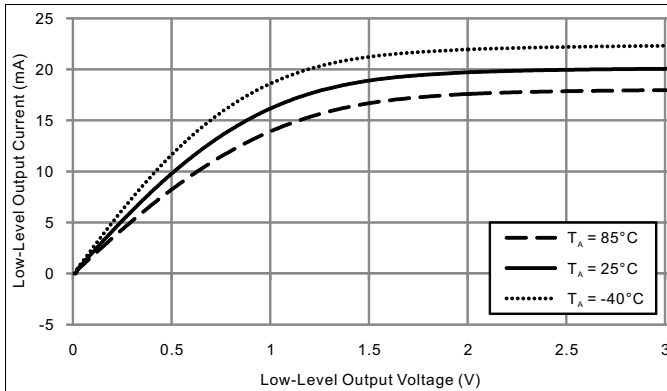
over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                                           | TEST CONDITIONS                             | V <sub>CC</sub> | MIN | TYP | MAX  | UNIT |
|---------------------------------------------------------------------|---------------------------------------------|-----------------|-----|-----|------|------|
| V <sub>OH</sub> High-level output voltage                           | I <sub>(OHmax)</sub> = –3 mA <sup>(1)</sup> | 2.0 V           | 1.4 |     | 2.0  | V    |
|                                                                     | I <sub>(OHmax)</sub> = –5 mA <sup>(1)</sup> | 3.0 V           | 2.4 |     | 3.0  |      |
| V <sub>OL</sub> Low-level output voltage                            | I <sub>(OLmax)</sub> = 3 mA <sup>(1)</sup>  | 2.0 V           | 0.0 |     | 0.60 | V    |
|                                                                     | I <sub>(OLmax)</sub> = 5 mA <sup>(1)</sup>  | 3.0 V           | 0.0 |     | 0.60 |      |
| f <sub>Port_CLK</sub> Clock output frequency                        | C <sub>L</sub> = 20 pF <sup>(2)</sup>       | 2.0 V           | 16  |     |      | MHz  |
|                                                                     |                                             | 3.0 V           | 16  |     |      |      |
| t <sub>rise,dig</sub> Port output rise time, digital only port pins | C <sub>L</sub> = 20 pF                      | 2.0 V           |     | 10  |      | ns   |
|                                                                     |                                             | 3.0 V           |     | 7   |      |      |
| t <sub>fall,dig</sub> Port output fall time, digital only port pins | C <sub>L</sub> = 20 pF                      | 2.0 V           |     | 10  |      | ns   |
|                                                                     |                                             | 3.0 V           |     | 5   |      |      |

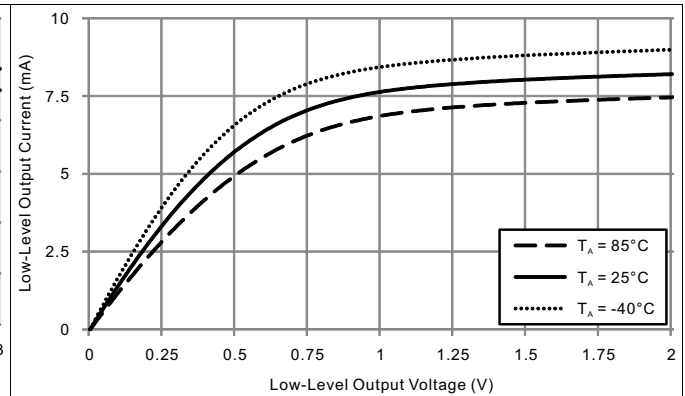
(1) The maximum total current, I<sub>(OHmax)</sub> and I<sub>(OLmax)</sub>, for all outputs combined should not exceed ±48 mA to hold the maximum voltage drop specified.

(2) The port can output frequencies at least up to the specified limit and might support higher frequencies.

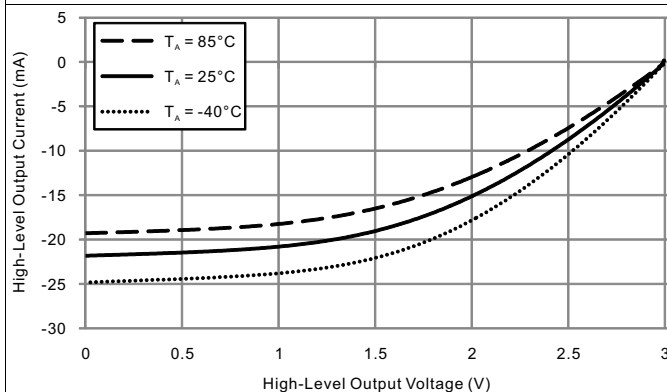
#### 5.12.4.1 Digital I/O Typical Characteristics



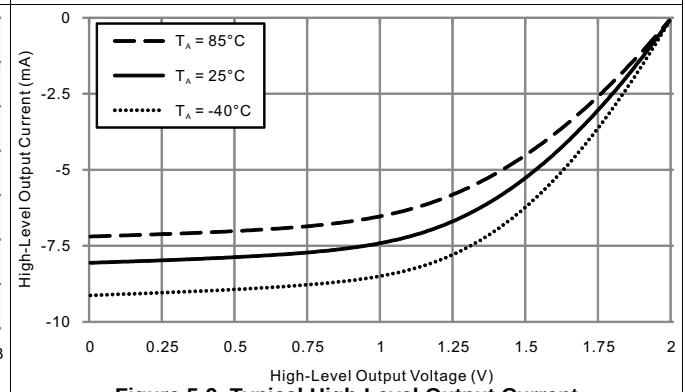
**Figure 5-6. Typical Low-Level Output Current  
vs  
Low-Level Output Voltage (DVCC = 3 V)**



**Figure 5-7. Typical Low-Level Output Current  
vs  
Low-Level Output Voltage (DVCC = 2 V)**



**Figure 5-8. Typical High-Level Output Current  
vs  
High-Level Output Voltage (DVCC = 3 V)**



**Figure 5-9. Typical High-Level Output Current  
vs  
High-Level Output Voltage (DVCC = 2 V)**

### 5.12.5 VREF+ Built-in Reference

Table 5-12 lists the characteristics of the VREF+.

**Table 5-12. VREF+**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER          |                                                       | TEST CONDITIONS                               | V <sub>CC</sub> | MIN  | TYP  | MAX  | UNIT  |
|--------------------|-------------------------------------------------------|-----------------------------------------------|-----------------|------|------|------|-------|
| V <sub>REF+</sub>  | Positive built-in reference voltage                   | EXTREFEN = 1 with 1-mA load current to ground | 2.0 V, 3.0 V    | 1.15 | 1.19 | 1.23 | V     |
| T <sub>CREF+</sub> | Temperature coefficient of built-in reference voltage | EXTREFEN = 1 with 1-mA load current           |                 |      | 30   |      | μV/°C |

### 5.12.6 Timer\_B

Table 5-13 lists the characteristics of the Timer\_B clock frequency.

**Table 5-13. Timer\_B**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER           |                               | TEST CONDITIONS                                                       | V <sub>CC</sub> | MIN | MAX | UNIT |
|---------------------|-------------------------------|-----------------------------------------------------------------------|-----------------|-----|-----|------|
| f <sub>TB</sub>     | Timer_B input clock frequency | Internal: SMCLK or ACLK,<br>External: TBCLK,<br>Duty cycle = 50% ±10% | 2.0 V, 3.0 V    |     | 16  | MHz  |
| t <sub>TB,cap</sub> | Timer_B capture timing        | All capture inputs, minimum pulse duration required for capture       | 2.0 V, 3.0 V    | 20  |     | ns   |

### 5.12.7 eUSCI

Table 5-14 lists the clock frequency of the eUSCI in UART mode.

**Table 5-14. eUSCI (UART Mode) Clock Frequency**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                                                 | TEST CONDITIONS                                                        | V <sub>CC</sub> | MIN | MAX | UNIT |
|---------------------------------------------------------------------------|------------------------------------------------------------------------|-----------------|-----|-----|------|
| f <sub>eUSCI</sub> eUSCI input clock frequency                            | Internal: SMCLK or MODCLK,<br>External: UCLK,<br>Duty cycle = 50% ±10% | 2.0 V, 3.0 V    |     | 16  | MHz  |
| f <sub>BITCLK</sub> BITCLK clock frequency<br>(equals baud rate in Mbaud) |                                                                        | 2.0 V, 3.0 V    |     | 5   | MHz  |

Table 5-15 lists the switching characteristics of the eUSCI in UART mode.

**Table 5-15. eUSCI (UART Mode) Switching Characteristics**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                                | TEST CONDITIONS | V <sub>CC</sub> | MIN | TYP | MAX | UNIT |
|----------------------------------------------------------|-----------------|-----------------|-----|-----|-----|------|
| t <sub>t</sub> UART receive deglitch time <sup>(1)</sup> | UCGLITx = 0     | 2.0 V,<br>3.0 V |     | 12  |     | ns   |
|                                                          | UCGLITx = 1     |                 |     | 40  |     |      |
|                                                          | UCGLITx = 2     |                 |     | 68  |     |      |
|                                                          | UCGLITx = 3     |                 |     | 110 |     |      |

- (1) Pulses on the UART receive input (UCxRX) shorter than the UART receive deglitch time are suppressed. To make sure that pulses are correctly recognized, their duration must exceed the maximum specification of the deglitch time.

Table 5-16 lists the clock frequency of the eUSCI in SPI master mode.

**Table 5-16. eUSCI (SPI Master Mode) Clock Frequency**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                                      | CONDITIONS                                          | MIN | MAX | UNIT |
|------------------------------------------------|-----------------------------------------------------|-----|-----|------|
| f <sub>eUSCI</sub> eUSCI input clock frequency | Internal: SMCLK or MODCLK,<br>Duty cycle = 50% ±10% |     | 8   | MHz  |

Table 5-17 lists the switching characteristics of the eUSCI in SPI master mode.

**Table 5-17. eUSCI (SPI Master Mode) Switching Characteristics**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(1)</sup>

| PARAMETER                                                        | TEST CONDITIONS                                 | V <sub>CC</sub> | MIN | MAX | UNIT          |
|------------------------------------------------------------------|-------------------------------------------------|-----------------|-----|-----|---------------|
| t <sub>STE,LEAD</sub> STE lead time, STE active to clock         | UCSTEM = 1, UCMODEx = 01 or 10                  |                 | 1   |     | UCxCLK cycles |
| t <sub>STE,LAG</sub> STE lag time, last clock to STE inactive    | UCSTEM = 1, UCMODEx = 01 or 10                  |                 | 1   |     | UCxCLK cycles |
| t <sub>SU,MI</sub> SOMI input data setup time                    |                                                 | 2.0 V           | 47  |     | ns            |
|                                                                  |                                                 | 3.0 V           | 35  |     |               |
| t <sub>HD,MI</sub> SOMI input data hold time                     |                                                 | 2.0 V           | 0   |     | ns            |
|                                                                  |                                                 | 3.0 V           | 0   |     |               |
| t <sub>VALID,MO</sub> SIMO output data valid time <sup>(2)</sup> | UCLK edge to SIMO valid, C <sub>L</sub> = 20 pF | 2.0 V           |     | 20  | ns            |
|                                                                  |                                                 | 3.0 V           |     | 20  |               |
| t <sub>HD,MO</sub> SIMO output data hold time <sup>(3)</sup>     | C <sub>L</sub> = 20 pF                          | 2.0 V           | 0   |     | ns            |
|                                                                  |                                                 | 3.0 V           | 0   |     |               |

- (1) f<sub>UCxCLK</sub> = 1/2(t<sub>LO/Hi</sub>) with t<sub>LO/Hi</sub> = max(t<sub>VALID,MO</sub>(eUSCI) + t<sub>SU,SI</sub>(Slave), t<sub>SU,MI</sub>(eUSCI) + t<sub>VALID,SO</sub>(Slave))  
For the slave parameters t<sub>SU,SI</sub>(Slave) and t<sub>VALID,SO</sub>(Slave), see the SPI parameters of the attached slave.
- (2) Specifies the time to drive the next valid data to the SIMO output after the output changing UCLK clock edge. See the timing diagrams in Figure 5-10 and Figure 5-11.
- (3) Specifies how long data on the SIMO output is valid after the output changing UCLK clock edge. Negative values indicate that the data on the SIMO output can become invalid before the output changing clock edge observed on UCLK. See the timing diagrams in Figure 5-10 and Figure 5-11.

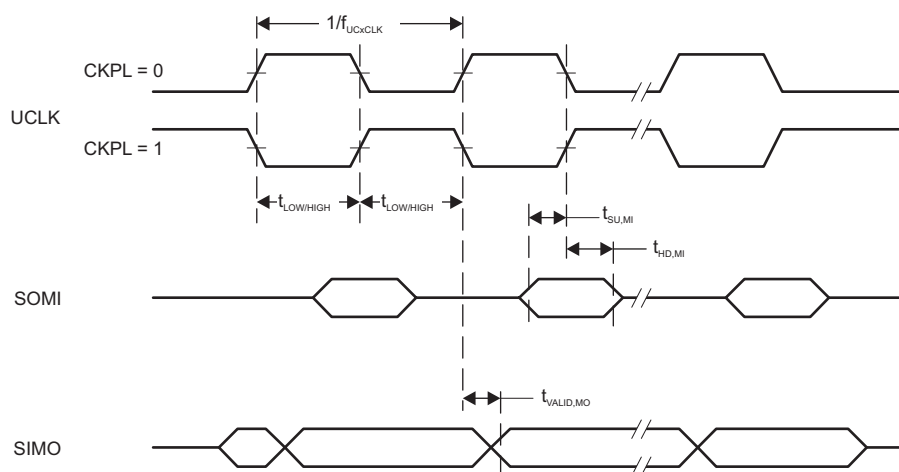


Figure 5-10. SPI Master Mode, CKPH = 0

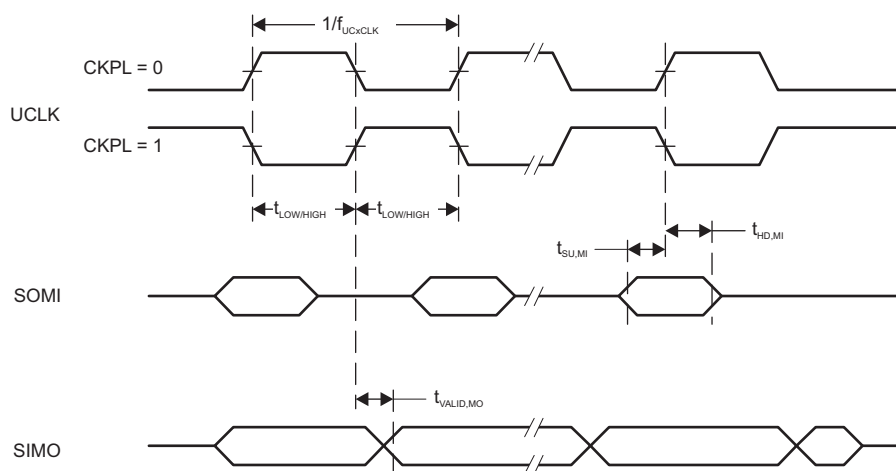


Figure 5-11. SPI Master Mode, CKPH = 1

Table 5-18 lists the switching characteristics of the eUSCI in SPI slave mode.

**Table 5-18. eUSCI (SPI Slave Mode) Switching Characteristics**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(1)</sup>

| PARAMETER                                                                  | TEST CONDITIONS                                 | V <sub>CC</sub> | MIN | MAX | UNIT |
|----------------------------------------------------------------------------|-------------------------------------------------|-----------------|-----|-----|------|
| t <sub>STE,LEAD</sub> STE lead time, STE active to clock                   |                                                 | 2.0 V           | 55  |     | ns   |
|                                                                            |                                                 | 3.0 V           | 45  |     |      |
| t <sub>STE,LAG</sub> STE lag time, last clock to STE inactive              |                                                 | 2.0 V           | 20  |     | ns   |
|                                                                            |                                                 | 3.0 V           | 20  |     |      |
| t <sub>STE,ACC</sub> STE access time, STE active to SOMI data out          |                                                 | 2.0 V           |     | 65  | ns   |
|                                                                            |                                                 | 3.0 V           |     | 40  |      |
| t <sub>STE,DIS</sub> STE disable time, STE inactive to SOMI high impedance |                                                 | 2.0 V           |     | 40  | ns   |
|                                                                            |                                                 | 3.0 V           |     | 35  |      |
| t <sub>SU,SI</sub> SIMO input data setup time                              |                                                 | 2.0 V           | 8   |     | ns   |
|                                                                            |                                                 | 3.0 V           | 6   |     |      |
| t <sub>HD,SI</sub> SIMO input data hold time                               |                                                 | 2.0 V           | 12  |     | ns   |
|                                                                            |                                                 | 3.0 V           | 12  |     |      |
| t <sub>VALID,SO</sub> SOMI output data valid time <sup>(2)</sup>           | UCLK edge to SOMI valid, C <sub>L</sub> = 20 pF | 2.0 V           |     | 68  | ns   |
|                                                                            |                                                 | 3.0 V           |     | 42  |      |
| t <sub>HD,SO</sub> SOMI output data hold time <sup>(3)</sup>               | C <sub>L</sub> = 20 pF                          | 2.0 V           | 5   |     | ns   |
|                                                                            |                                                 | 3.0 V           | 5   |     |      |

- (1)  $f_{UCXCLK} = 1/2t_{LO/HI}$  with  $t_{LO/HI} \geq \max(t_{VALID,MO(Master)} + t_{SU,SI(eUSCI)}, t_{SU,MI(Master)} + t_{VALID,SO(eUSCI)})$   
For the master parameters  $t_{SU,MI(Master)}$  and  $t_{VALID,MO(Master)}$ , see the SPI parameters of the attached master.
- (2) Specifies the time to drive the next valid data to the SOMI output after the output changing UCLK clock edge. See the timing diagrams in [Figure 5-12](#) and [Figure 5-13](#).
- (3) Specifies how long data on the SOMI output is valid after the output changing UCLK clock edge. See the timing diagrams in [Figure 5-12](#) and [Figure 5-13](#).

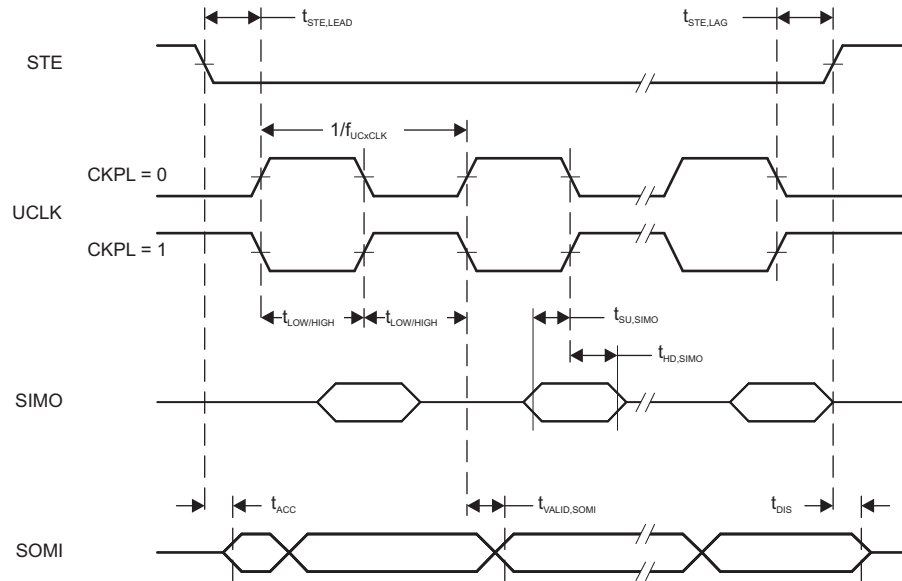


Figure 5-12. SPI Slave Mode, CKPH = 0

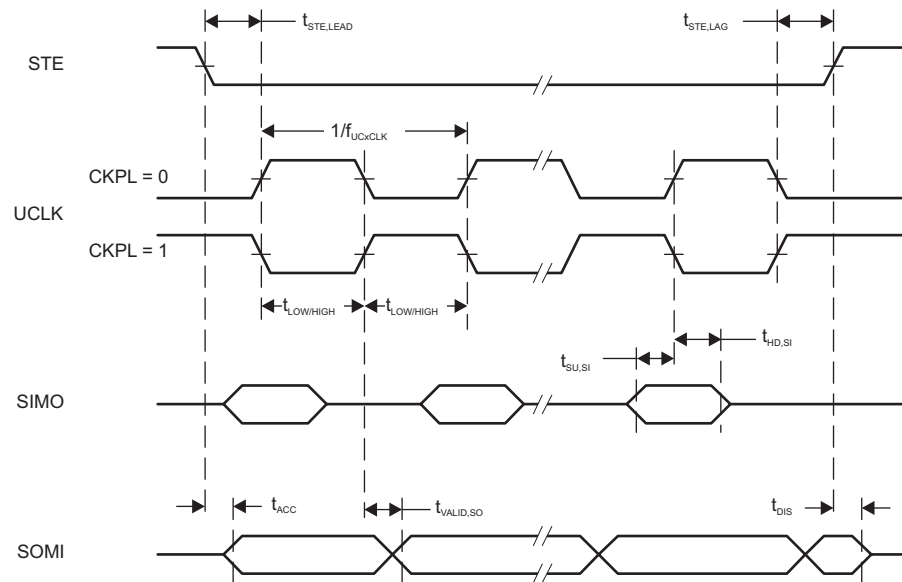


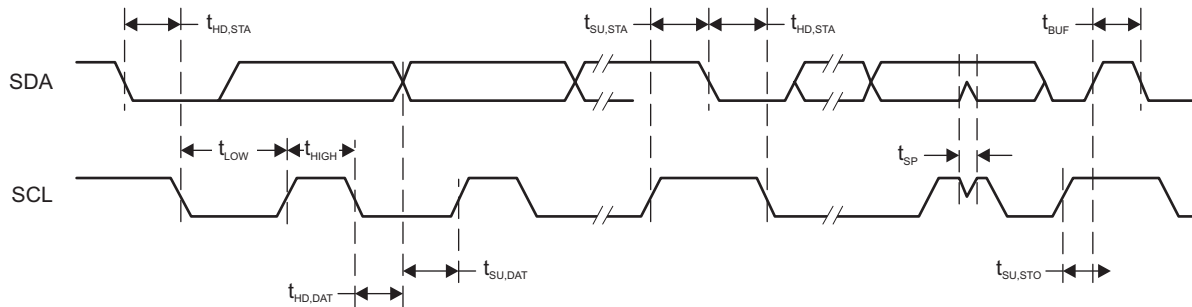
Figure 5-13. SPI Slave Mode, CKPH = 1

Table 5-19 lists the switching characteristics of the eUSCI (I<sup>2</sup>C mode).

**Table 5-19. eUSCI (I<sup>2</sup>C Mode) Switching Characteristics**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5-14)

| PARAMETER            | TEST CONDITIONS                                     | V <sub>CC</sub>                                                        | MIN  | TYP | MAX | UNIT |
|----------------------|-----------------------------------------------------|------------------------------------------------------------------------|------|-----|-----|------|
| f <sub>eUSCI</sub>   | eUSCI input clock frequency                         | Internal: SMCLK or MODCLK,<br>External: UCLK,<br>Duty cycle = 50% ±10% |      |     | 16  | MHz  |
| f <sub>SCL</sub>     | SCL clock frequency                                 | 2.0 V, 3.0 V                                                           | 0    |     | 400 | kHz  |
| t <sub>HD,STA</sub>  | Hold time (repeated) START                          | f <sub>SCL</sub> = 100 kHz                                             | 4.0  |     |     | μs   |
|                      |                                                     | f <sub>SCL</sub> > 100 kHz                                             | 0.6  |     |     |      |
| t <sub>SU,STA</sub>  | Setup time for a repeated START                     | f <sub>SCL</sub> = 100 kHz                                             | 4.7  |     |     | μs   |
|                      |                                                     | f <sub>SCL</sub> > 100 kHz                                             | 0.6  |     |     |      |
| t <sub>HD,DAT</sub>  | Data hold time                                      | 2.0 V, 3.0 V                                                           | 0    |     |     | ns   |
| t <sub>SU,DAT</sub>  | Data setup time                                     | 2.0 V, 3.0 V                                                           | 250  |     |     | ns   |
| t <sub>SU,STO</sub>  | Setup time for STOP                                 | f <sub>SCL</sub> = 100 kHz                                             | 4.0  |     |     | μs   |
|                      |                                                     | f <sub>SCL</sub> > 100 kHz                                             | 0.6  |     |     |      |
| t <sub>SP</sub>      | Pulse duration of spikes suppressed by input filter | UCGLITx = 0                                                            | 50   |     | 600 | ns   |
|                      |                                                     | UCGLITx = 1                                                            | 25   |     | 300 |      |
|                      |                                                     | UCGLITx = 2                                                            | 12.5 |     | 150 |      |
|                      |                                                     | UCGLITx = 3                                                            | 6.3  |     | 75  |      |
| t <sub>TIMEOUT</sub> | Clock low time-out                                  | UCCLTOx = 1                                                            |      | 27  |     | ms   |
|                      |                                                     | UCCLTOx = 2                                                            |      | 30  |     |      |
|                      |                                                     | UCCLTOx = 3                                                            |      | 33  |     |      |



**Figure 5-14. I<sup>2</sup>C Mode Timing**

### 5.12.8 ADC

Table 5-20 lists the characteristics of the ADC power supply and input range conditions.

**Table 5-20. ADC, Power Supply and Input Range Conditions**

over operating free-air temperature range (unless otherwise noted)

| PARAMETER                                                                                                                            | TEST CONDITIONS                                                                                                    | V <sub>CC</sub> | MIN | TYP | MAX              | UNIT |
|--------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------|-----------------|-----|-----|------------------|------|
| DV <sub>CC</sub> ADC supply voltage                                                                                                  |                                                                                                                    |                 | 2.0 |     | 3.6              | V    |
| V <sub>(Ax)</sub> Analog input voltage range                                                                                         | All ADC pins                                                                                                       |                 | 0   |     | DV <sub>CC</sub> | V    |
| I <sub>ADC</sub> Operating supply current into DV <sub>CC</sub> terminal, reference current not included, repeat-single-channel mode | f <sub>ADCCLK</sub> = 5 MHz, ADCON = 1, REFON = 0, SHT0 = 0, SHT1 = 0, ADCDIV = 0, ADCCONSEQx = 10b                | 2 V             |     | 185 |                  | μA   |
|                                                                                                                                      |                                                                                                                    | 3 V             |     | 207 |                  |      |
| C <sub>I</sub> Input capacitance                                                                                                     | Only one terminal Ax can be selected at one time from the pad to the ADC capacitor array, including wiring and pad | 2.2 V           |     | 2.5 | 3.5              | pF   |
| R <sub>I,MUX</sub> Input MUX ON resistance                                                                                           | DV <sub>CC</sub> = 2 V, 0 V ≤ V <sub>Ax</sub> ≤ DV <sub>CC</sub>                                                   |                 |     |     | 2                | kΩ   |
| R <sub>I,Misc</sub> Input miscellaneous resistance                                                                                   |                                                                                                                    |                 |     | 34  |                  | kΩ   |

Table 5-21 lists the ADC 10-bit timing parameters.

**Table 5-21. ADC, 10-Bit Timing Parameters**

over operating free-air temperature range (unless otherwise noted)

| PARAMETER                                            | TEST CONDITIONS                                                                                                                                                                   | V <sub>CC</sub> | MIN  | TYP                             | MAX  | UNIT |
|------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------|------|---------------------------------|------|------|
| f <sub>ADCCLK</sub>                                  | For specified performance of ADC linearity parameters                                                                                                                             | 2 V to 3.6 V    | 0.45 | 5                               | 5.5  | MHz  |
| f <sub>ADCOSC</sub> Internal ADC oscillator (MODOSC) | ADCDIV = 0, f <sub>ADCCLK</sub> = f <sub>ADCOSC</sub>                                                                                                                             | 2 V to 3.6 V    | 3.8  | 4.8                             | 5.8  | MHz  |
| t <sub>CONVERT</sub> Conversion time                 | REFON = 0, Internal oscillator, 10 ADCCLK cycles, 10-bit mode, f <sub>ADCOSC</sub> = 4.5 MHz to 5.5 MHz                                                                           | 2 V to 3.6 V    | 2.18 |                                 | 2.67 | μs   |
|                                                      | External f <sub>ADCCLK</sub> from ACLK, MCLK, or SMCLK, ADCSSEL ≠ 0                                                                                                               | 2 V to 3.6 V    |      | 12 ×<br>1 / f <sub>ADCCLK</sub> |      |      |
| t <sub>ADCON</sub> Turn-on settling time of the ADC  | The error in a conversion started after t <sub>ADCON</sub> is less than ±0.5 LSB. Reference and input signal are already settled.                                                 |                 |      |                                 | 100  | ns   |
| t <sub>Sample</sub> Sampling time                    | R <sub>S</sub> = 1000 Ω, R <sub>I</sub> <sup>(1)</sup> = 36000 Ω, C <sub>I</sub> = 3.5 pF, Approximately 8 Tau (t) are required for an error of less than ±0.5 LSB <sup>(2)</sup> | 2 V             | 1.5  |                                 |      | μs   |
|                                                      |                                                                                                                                                                                   | 3 V             | 2.0  |                                 |      |      |

(1) R<sub>I</sub> = R<sub>I,MUX</sub> + R<sub>I,Misc</sub>

(2) t<sub>Sample</sub> = ln(2<sup>n+1</sup>) × τ, where n = ADC resolution, τ = (R<sub>I</sub> + R<sub>S</sub>) × C<sub>I</sub>

Table 5-22 lists the ADC 10-bit linearity parameters.

**Table 5-22. ADC, 10-Bit Linearity Parameters**

over operating free-air temperature range (unless otherwise noted)

| PARAMETER                       |                                                               | TEST CONDITIONS                                                                      | V <sub>CC</sub> | MIN   | TYP  | MAX  | UNIT  |
|---------------------------------|---------------------------------------------------------------|--------------------------------------------------------------------------------------|-----------------|-------|------|------|-------|
| E <sub>I</sub>                  | Integral linearity error (10-bit mode)                        | V <sub>REF+</sub> reference                                                          | 2.4 V to 3.6 V  | –2    |      | 2    | LSB   |
|                                 | Integral linearity error (8-bit mode)                         |                                                                                      | 2.0 V to 3.6 V  | –2    |      | 2    |       |
| E <sub>D</sub>                  | Differential linearity error (10-bit mode)                    | V <sub>REF+</sub> reference                                                          | 2.4 V to 3.6 V  | –1    |      | 1    | LSB   |
|                                 | Differential linearity error (8-bit mode)                     |                                                                                      | 2.0 V to 3.6 V  | –1    |      | 1    |       |
| E <sub>O</sub>                  | Offset error (10-bit mode)                                    | V <sub>REF+</sub> reference                                                          | 2.4 V to 3.6 V  | –6.5  |      | 6.5  | mV    |
|                                 | Offset error (8-bit mode)                                     |                                                                                      | 2.0 V to 3.6 V  | –6.5  |      | 6.5  |       |
| E <sub>G</sub>                  | Gain error (10-bit mode)                                      | V <sub>REF+</sub> as reference                                                       | 2.4 V to 3.6 V  | –2.0  |      | 2.0  | LSB   |
|                                 |                                                               | Internal 1.5-V reference                                                             |                 | –3.0% |      | 3.0% |       |
|                                 | Gain error (8-bit mode)                                       | V <sub>REF+</sub> as reference                                                       | 2.0 V to 3.6 V  | –2.0  |      | 2.0  | LSB   |
|                                 |                                                               | Internal 1.5-V reference                                                             |                 | –3.0% |      | 3.0% |       |
| E <sub>T</sub>                  | Total unadjusted error (10-bit mode)                          | V <sub>REF+</sub> as reference                                                       | 2.4 V to 3.6 V  | –2.0  |      | 2.0  | LSB   |
|                                 |                                                               | Internal 1.5-V reference                                                             |                 | –3.0% |      | 3.0% |       |
|                                 | Total unadjusted error (8-bit mode)                           | V <sub>REF+</sub> as reference                                                       | 2.0 V to 3.6 V  | –2.0  |      | 2.0  | LSB   |
|                                 |                                                               | Internal 1.5-V reference                                                             |                 | –3.0% |      | 3.0% |       |
| V <sub>SENSOR</sub>             | See <sup>(1)</sup>                                            | ADCON = 1, INCH = 0Ch, T <sub>A</sub> = 0°C                                          | 3 V             |       | 913  |      | mV    |
| TC <sub>SENSOR</sub>            | See <sup>(2)</sup>                                            | ADCON = 1, INCH = 0Ch                                                                | 3 V             |       | 3.35 |      | mV/°C |
| t <sub>SENSOR</sub><br>(sample) | Sample time required if channel 12 is selected <sup>(3)</sup> | ADCON = 1, INCH = 0Ch, Error of conversion result ≤1 LSB, AM and all LPMs above LPM3 | 3 V             |       | 30   |      | μs    |
|                                 |                                                               | ADCON = 1, INCH = 0Ch, Error of conversion result ≤1 LSB, LPM3                       | 3 V             |       | 100  |      |       |

- (1) The temperature sensor offset can vary significantly. TI recommends a single-point calibration to minimize the offset error of the built-in temperature sensor.
- (2) The device descriptor structure contains calibration values for 30°C and 85°C for each available reference voltage level. The sensor voltage can be computed as  $V_{SENSE} = TC_{SENSOR} \times (\text{Temperature, } ^\circ\text{C}) + V_{SENSOR}$ , where TC<sub>SENSOR</sub> and V<sub>SENSOR</sub> can be computed from the calibration values for higher accuracy.
- (3) The typical equivalent impedance of the sensor is 700 kΩ. The sample time required includes the sensor on time, t<sub>SENSOR(on)</sub>.

### 5.12.9 Enhanced Comparator (eCOMP)

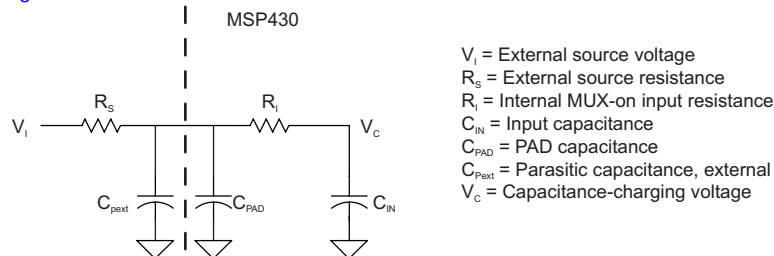
Table 5-23 lists the characteristics of eCOMP0.

**Table 5-23. eCOMP0**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER         | TEST CONDITIONS                                        | MIN                                                                                     | TYP  | MAX      | UNIT       |
|-------------------|--------------------------------------------------------|-----------------------------------------------------------------------------------------|------|----------|------------|
| $V_{CC}$          | Supply voltage                                         | 2.0                                                                                     |      | 3.6      | V          |
| $V_{IC}$          | Common-mode input range                                | 0                                                                                       |      | $V_{CC}$ | V          |
| $V_{HYS}$         | DC input hysteresis                                    | CPEN = 1, CPHSEL = 00                                                                   |      | 0        | mV         |
|                   |                                                        | CPEN = 1, CPHSEL = 01                                                                   |      | 10       |            |
|                   |                                                        | CPEN = 1, CPHSEL = 10                                                                   |      | 20       |            |
|                   |                                                        | CPEN = 1, CPHSEL = 11                                                                   |      | 30       |            |
| $V_{OFFSET}$      | Input offset voltage                                   | CPEN = 1, CPMSEL = 0                                                                    |      | –30      | mV         |
|                   |                                                        | CPEN = 1, CPMSEL = 1                                                                    |      | –40      |            |
| $I_{COMP}$        | Quiescent current draw from $V_{CC}$ , only comparator | $V_{IC} = V_{CC} / 2$ , CPEN = 1, CPMSEL = 0                                            |      | 24       | $\mu A$    |
|                   |                                                        | $V_{IC} = V_{CC} / 2$ , CPEN = 1, CPMSEL = 1                                            |      | 1.6      |            |
| $C_{IN}$          | Input channel capacitance <sup>(1)</sup>               |                                                                                         | 1    |          | pF         |
| $R_{IN}$          | Input channel series resistance                        | On (switch closed)                                                                      |      | 10       | k $\Omega$ |
|                   |                                                        | Off (switch open)                                                                       |      | 50       |            |
| $t_{PD}$          | Propagation delay, response time                       | CPMSEL = 0, CPFLT = 0, $V_{IC} = V_{CC} / 2$ , Overdrive = 20 mV                        |      |          | $\mu s$    |
|                   |                                                        | CPMSEL = 1, CPFLT = 0, $V_{IC} = V_{CC} / 2$ , Overdrive = 20 mV                        |      | 3.2      |            |
| $t_{EN\_CP}$      | Comparator enable time                                 | CPEN = 0→1, CPMSEL = 0, V+ and V- from pads, Overdrive = 20 mV                          |      | 8.5      | $\mu s$    |
|                   |                                                        | CPEN = 0→1, CPMSEL = 1, V+ and V- from pads, Overdrive = 20 mV                          |      | 1.4      |            |
| $t_{EN\_CP\_DAC}$ | Comparator with reference DAC enable time              | CPEN = 0→1, CPDACEN = 0→1, CPMSEL = 0, CPDACREFS = 1, CPDACBUF1 = 0F, Overdrive = 20 mV |      | 8.5      | $\mu s$    |
|                   |                                                        | CPEN = 0→1, CPDACEN = 0→1, CPMSEL = 1, CPDACREFS = 1, CPDACBUF1 = 0F, Overdrive = 20 mV |      | 101      |            |
| $t_{FDLY}$        | Propagation delay with analog filter active            | CPMSEL = 0, CPFLT = 00, Overdrive = 20 mV, CPFLT = 1                                    |      | 0.7      | $\mu s$    |
|                   |                                                        | CPMSEL = 0, CPFLT = 01, Overdrive = 20 mV, CPFLT = 1                                    |      | 1.1      |            |
|                   |                                                        | CPMSEL = 0, CPFLT = 10, Overdrive = 20 mV, CPFLT = 1                                    |      | 1.9      |            |
|                   |                                                        | CPMSEL = 0, CPFLT = 11, Overdrive = 20 mV, CPFLT = 1                                    |      | 3.4      |            |
| INL               | Integral nonlinearity                                  |                                                                                         | –0.5 | 0.5      | LSB        |
| DNL               | Differential nonlinearity                              |                                                                                         | –0.5 | 0.5      | LSB        |

(1) eCOMP  $C_{IN}$  model, see Figure 5-15 for details.



**Figure 5-15. eCOMP Input Circuit**

### 5.12.10 Smart Analog Combo (SAC)

Table 5-24 lists the characteristics of SAC0 (SAC-L1, OA).

**Table 5-24. SAC0 (SAC-L1, OA)**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER    |                                            | TEST CONDITIONS                                                    | MIN  | TYP            | MAX | UNIT              |
|--------------|--------------------------------------------|--------------------------------------------------------------------|------|----------------|-----|-------------------|
| $V_{CC}$     | Supply voltage                             |                                                                    | 2.0  |                | 3.6 | V                 |
| $V_{OS}$     | Input offset voltage                       |                                                                    | –5   |                | 5   | mV                |
| $dV_{OS}/dT$ | Offset drift                               | OAPM = 0                                                           |      | 3              |     | $\mu V/^{\circ}C$ |
|              |                                            | OAPM = 1                                                           |      | 5              |     |                   |
| $I_B$        | Input bias current                         |                                                                    |      | 50             |     | pA                |
| $V_{CM}$     | Input voltage range                        |                                                                    | –0.1 | $V_{CC} + 0.1$ |     | V                 |
| $I_{IDD}$    | Quiescent current                          | OAPM = 0                                                           |      | 350            |     | $\mu A$           |
|              |                                            | OAPM = 1                                                           |      | 120            |     |                   |
| $E_{NI}$     | Input noise voltage, $f = 0.1$ Hz to 10 Hz | $V_{in} = V_{CC} / 2$ , OAPM = 0                                   |      | 40             |     | $\mu V$           |
|              | Input noise voltage density, $f = 1$ kHz   | $V_{in} = V_{CC} / 2$ , OAPM = 0                                   |      | 40             |     | $nV/\sqrt{Hz}$    |
|              | Input noise voltage, $f = 10$ kHz          | $V_{in} = V_{CC} / 2$ , OAPM = 0                                   |      | 20             |     |                   |
| CMRR         | Common-mode rejection ratio                | OAPM = 0                                                           |      | 70             |     | dB                |
|              |                                            | OAPM = 1                                                           |      | 80             |     |                   |
| PSRR         | Power supply rejection ratio               | OAPM = 0                                                           |      | 70             |     | dB                |
|              |                                            | OAPM = 1                                                           |      | 80             |     |                   |
| GBW          | Gain bandwidth                             | OAPM = 0                                                           |      | 4              |     | MHz               |
|              |                                            | OAPM = 1                                                           |      | 1.4            |     |                   |
| $A_{OL}$     | Open-loop voltage gain                     | OAPM = 0                                                           |      | 100            |     | dB                |
|              |                                            | OAPM = 1                                                           |      | 100            |     |                   |
| $\phi_M$     | Phase margin                               | $C_L = 50$ pF, $R_L = 2$ k $\Omega$                                |      | 65             |     | deg               |
|              | Positive slew rate                         | $C_L = 50$ pF, OAPM = 0                                            |      | 3              |     | V/ $\mu s$        |
|              |                                            | $C_L = 50$ pF, OAPM = 1                                            |      | 1              |     |                   |
| $C_{in}$     | Input capacitance                          | Common mode                                                        |      | 2              |     | pF                |
| $V_O$        | Voltage output swing from supply rails     | $R_L = 10$ k $\Omega$                                              |      | 40             | 100 | mV                |
| $t_{ST}$     | OA settling time                           | To 0.1% final value, $G = +1$ , 1-V setup, $C_L = 50$ pF, OAPM = 0 |      | 1              |     | $\mu s$           |
|              |                                            | To 0.1% final value, $G = +1$ , 1-V setup, $C_L = 50$ pF, OAPM = 1 |      | 4.5            |     |                   |

### 5.12.11 Transimpedance Amplifier (TIA)

Table 5-25 lists the characteristics of TIA0.

**Table 5-25. TIA0**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER    |                                            | TEST CONDITIONS                                                            | MIN  | TYP        | MAX | UNIT              |
|--------------|--------------------------------------------|----------------------------------------------------------------------------|------|------------|-----|-------------------|
| $V_{CC}$     | Supply voltage                             |                                                                            | 2.0  |            | 3.6 | V                 |
| $V_{OS}$     | Input offset voltage                       |                                                                            | –5   |            | 5   | mV                |
| $dV_{OS}/dT$ | Offset drift                               | TRIPM = 0                                                                  |      | 3          |     | $\mu V/^{\circ}C$ |
|              |                                            | TRIPM = 1                                                                  |      | 5          |     |                   |
| $I_B$        | Input bias current                         | $V_B = 0$ V, TSSOP-16 package with OA-dedicated pin input (see Figure 4-2) |      | 5          |     | pA                |
|              |                                            | TSSOP-20 and VQFN-16 packages                                              |      | 50         |     | pA                |
| $V_{CM}$     | Input voltage range                        |                                                                            | –0.1 | $V_{CC}/2$ |     | V                 |
| $I_{DD}$     | Quiescent current                          | TRIPM = 0                                                                  |      | 350        |     | $\mu A$           |
|              |                                            | TRIPM = 1                                                                  |      | 120        |     |                   |
| $E_{NI}$     | Input noise voltage, $f = 0.1$ Hz to 10 Hz | $V_{in} = V_{CC}/2$ , TRIPM = 0                                            |      | 40         |     | $\mu V$           |
|              | Input noise voltage density, $f = 1$ kHz   | $V_{in} = V_{CC}/2$ , TRIPM = 0                                            |      | 40         |     | $nV/\sqrt{Hz}$    |
|              | Input noise voltage, $f = 10$ kHz          | $V_{in} = V_{CC}/2$ , TRIPM = 0                                            |      | 16         |     |                   |
| CMRR         | Common-mode rejection ratio                | TRIPM = 0                                                                  |      | 80         |     | dB                |
|              |                                            | TRIPM = 1                                                                  |      | 70         |     |                   |
| PSRR         | Power supply rejection ratio               | TRIPM = 0                                                                  |      | 80         |     | dB                |
|              |                                            | TRIPM = 1                                                                  |      | 70         |     |                   |
| GBW          | Gain bandwidth                             | TRIPM = 0                                                                  |      | 5          |     | MHz               |
|              |                                            | TRIPM = 1                                                                  |      | 1.8        |     |                   |
| $A_{OL}$     | Open-loop voltage gain                     | TRIPM = 0                                                                  |      | 100        |     | dB                |
|              |                                            | TRIPM = 1                                                                  |      | 100        |     |                   |
| $\phi_M$     | Phase margin                               | $C_L = 50$ pF, $R_L = 2$ k $\Omega$ , TRIPM = 0                            |      | 40         |     | deg               |
|              |                                            | $C_L = 50$ pF, $R_L = 2$ k $\Omega$ , TRIPM = 1                            |      | 70         |     |                   |
|              | Positive slew rate                         | $C_L = 50$ pF, TRIPM = 0                                                   |      | 4          |     | V/ $\mu s$        |
|              |                                            | $C_L = 50$ pF, TRIPM = 1                                                   |      | 1          |     |                   |
| $C_{in}$     | Input capacitance                          | Common mode                                                                |      | 7          |     | pF                |
| $V_O$        | Voltage output swing from supply rails     | $R_L = 10$ k $\Omega$                                                      |      | 40         | 100 | mV                |
| $t_{ST}$     | TIA settling time                          | To 0.1% final value, $G = +1$ , 1-V setup, $C_L = 50$ pF, TRIPM = 0        |      | 3          |     | $\mu s$           |
|              |                                            | To 0.1% final value, $G = +1$ , 1-V setup, $C_L = 50$ pF, TRIPM = 1        |      | 5          |     |                   |

### 5.12.12 FRAM

Table 5-26 lists the characteristics of the FRAM.

**Table 5-26. FRAM**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER                |                            | TEST CONDITIONS       | MIN              | TYP                                  | MAX | UNIT   |
|--------------------------|----------------------------|-----------------------|------------------|--------------------------------------|-----|--------|
| Read and write endurance |                            |                       | 10 <sup>15</sup> |                                      |     | cycles |
| t <sub>Retention</sub>   | Data retention duration    | T <sub>J</sub> = 25°C | 100              |                                      |     | years  |
|                          |                            | T <sub>J</sub> = 70°C | 40               |                                      |     |        |
|                          |                            | T <sub>J</sub> = 85°C | 10               |                                      |     |        |
| I <sub>WRITE</sub>       | Current to write into FRAM |                       |                  | I <sub>READ</sub> <sup>(1)</sup>     |     | nA     |
| I <sub>ERASE</sub>       | Erase current              |                       |                  | N/A <sup>(2)</sup>                   |     | nA     |
| t <sub>WRITE</sub>       | Write time                 |                       |                  | t <sub>READ</sub> <sup>(3)</sup>     |     | ns     |
| t <sub>READ</sub>        | Read time                  | NWAITSx = 0           |                  | 1/f <sub>SYSTEM</sub> <sup>(4)</sup> |     | ns     |
|                          |                            | NWAITSx = 1           |                  | 2/f <sub>SYSTEM</sub> <sup>(4)</sup> |     |        |

- (1) Writing to FRAM does not require a setup sequence or additional power when compared to reading from FRAM. The FRAM read current I<sub>READ</sub> is included in the active mode current consumption numbers I<sub>AM, FRAM</sub>.
- (2) FRAM does not require a special erase sequence.
- (3) Writing into FRAM is as fast as reading.
- (4) The maximum read (and write) speed is specified by f<sub>SYSTEM</sub> using the appropriate wait state settings (NWAITSx).

### 5.12.13 Emulation and Debug

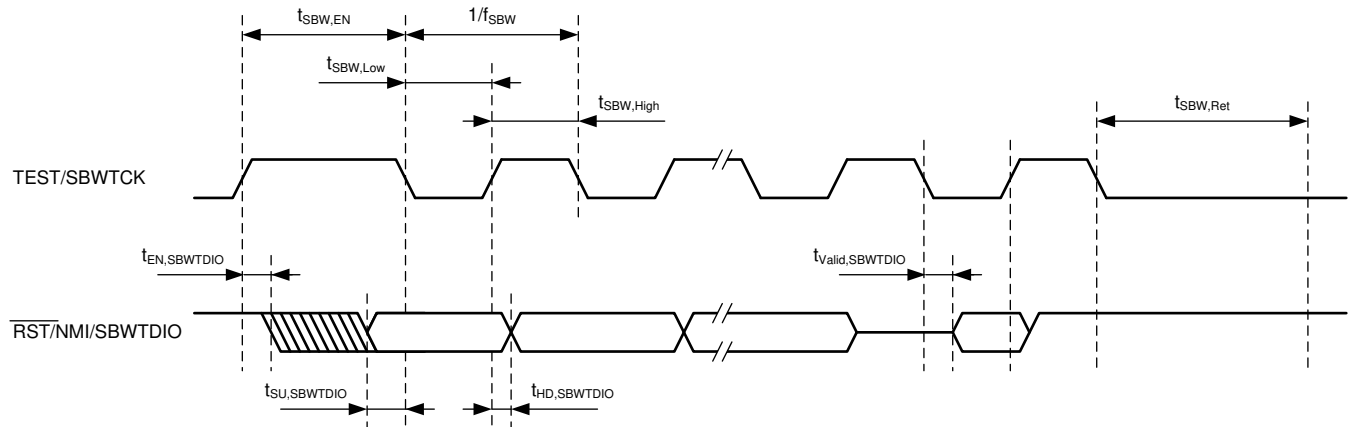
Table 5-27 lists the characteristics of the 2-wire Spy-Bi-Wire interface.

**Table 5-27. JTAG, Spy-Bi-Wire Interface**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5-16)

| PARAMETER                  |                                                                                      | V <sub>CC</sub> | MIN   | TYP | MAX | UNIT |
|----------------------------|--------------------------------------------------------------------------------------|-----------------|-------|-----|-----|------|
| f <sub>SBW</sub>           | Spy-Bi-Wire input frequency                                                          | 2.0 V, 3.0 V    | 0     |     | 8   | MHz  |
| t <sub>SBW,Low</sub>       | Spy-Bi-Wire low clock pulse duration                                                 | 2.0 V, 3.0 V    | 0.028 |     | 15  | μs   |
| t <sub>SU,SBWTDIO</sub>    | SBWTDIO setup time (before falling edge of SBWTCK in TMS and TDI slot Spy-Bi-Wire)   | 2.0 V, 3.0 V    | 4     |     |     | ns   |
| t <sub>HD,SBWTDIO</sub>    | SBWTDIO hold time (after rising edge of SBWTCK in TMS and TDI slot Spy-Bi-Wire)      | 2.0 V, 3.0 V    | 19    |     |     | ns   |
| t <sub>valid,SBWTDIO</sub> | SBWTDIO data valid time (after falling edge of SBWTCK in TDO slot Spy-Bi-Wire)       | 2.0 V, 3.0 V    |       |     | 31  | ns   |
| t <sub>SBW,En</sub>        | Spy-Bi-Wire enable time (TEST high to acceptance of first clock edge) <sup>(1)</sup> | 2.0 V, 3.0 V    |       |     | 110 | μs   |
| t <sub>SBW,Ret</sub>       | Spy-Bi-Wire return to normal operation time <sup>(2)</sup>                           |                 | 15    |     | 100 | μs   |
| R <sub>internal</sub>      | Internal pulldown resistance on TEST                                                 | 2.0 V, 3.0 V    | 20    | 35  | 50  | kΩ   |

- (1) Tools that access the Spy-Bi-Wire interface must wait for the t<sub>SBW,En</sub> time after pulling the TEST/SBWTCK pin high before applying the first SBWTCK clock edge.
- (2) Maximum t<sub>SBW,Rst</sub> time after pulling or releasing the TEST/SBWTCK pin low, the Spy-Bi-Wire pins revert from their Spy-Bi-Wire function to their application function. This time applies only if the Spy-Bi-Wire mode was selected.



**Figure 5-16. JTAG Spy-Bi-Wire Timing**

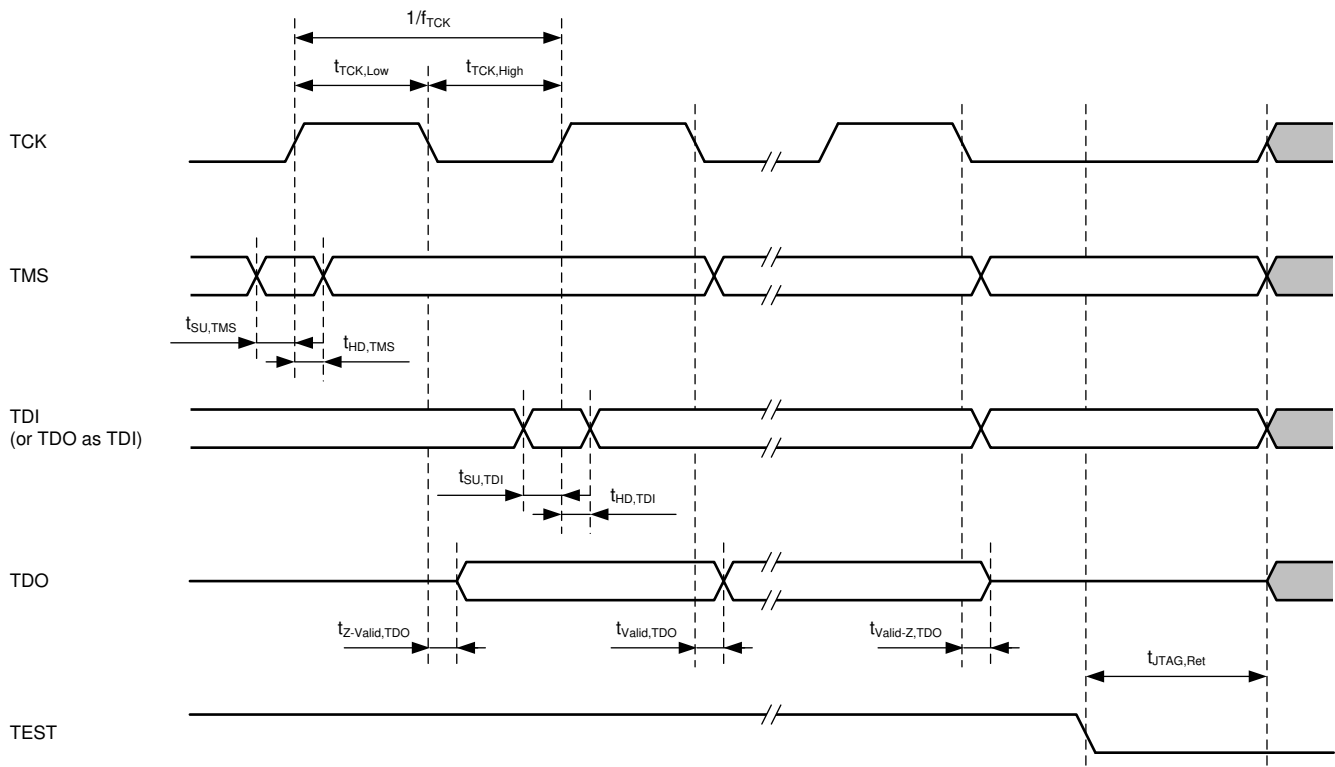
Table 5-28 lists the characteristics of the JTAG 4-wire interface.

**Table 5-28. JTAG, 4-Wire Interface**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5-17)

| PARAMETER                |                                                                     | V <sub>CC</sub> | MIN | TYP | MAX | UNIT |
|--------------------------|---------------------------------------------------------------------|-----------------|-----|-----|-----|------|
| f <sub>TCK</sub>         | TCK input frequency <sup>(1)</sup>                                  | 2.0 V, 3.0 V    | 0   |     | 10  | MHz  |
| t <sub>TCK,Low</sub>     | Spy-Bi-Wire low clock pulse duration                                | 2.0 V, 3.0 V    | 15  |     |     | ns   |
| t <sub>TCK,high</sub>    | Spy-Bi-Wire high clock pulse duration                               | 2.0 V, 3.0 V    | 15  |     |     | ns   |
| t <sub>SU,TMS</sub>      | TMS setup time (before rising edge of TCK)                          | 2.0 V, 3.0 V    | 11  |     |     | ns   |
| t <sub>HD,TMS</sub>      | TMS hold time (after rising edge of TCK)                            | 2.0 V, 3.0 V    | 3   |     |     | ns   |
| t <sub>SU,TDI</sub>      | TDI setup time (before rising edge of TCK)                          | 2.0 V, 3.0 V    | 13  |     |     | ns   |
| t <sub>HD,TDI</sub>      | TDI hold time (after rising edge of TCK)                            | 2.0 V, 3.0 V    | 5   |     |     | ns   |
| t <sub>z-Valid,TDO</sub> | TDO high impedance to valid output time (after falling edge of TCK) | 2.0 V, 3.0 V    |     |     | 26  | ns   |
| t <sub>Valid,TDO</sub>   | TDO to new valid output time (after falling edge of TCK)            | 2.0 V, 3.0 V    |     |     | 26  | ns   |
| t <sub>Valid-Z,TDO</sub> | TDO valid to high-impedance output time (after falling edge of TCK) | 2.0 V, 3.0 V    |     |     | 26  | ns   |
| t <sub>JTAG,Ret</sub>    | Spy-Bi-Wire return to normal operation time                         |                 | 15  |     | 100 | μs   |
| R <sub>internal</sub>    | Internal pulldown resistance on TEST                                | 2.0 V, 3.0 V    | 20  | 35  | 50  | kΩ   |

(1) Tools that access the Spy-Bi-Wire interface must wait for the t<sub>SBW,En</sub> time after pulling the TEST/SBW<sub>TCK</sub> pin high before applying the first SBWTCK clock edge.



**Figure 5-17. JTAG 4-Wire Timing**

## 6 Detailed Description

### 6.1 Overview

The MSP430FR231x FRAM MCU features a powerful 16-bit RISC CPU, 16-bit registers, and constant generators that contribute to maximum code efficiency. The DCO also allows the device to wake up from low-power modes to active mode typically in less than 10  $\mu$ s. The feature set of this microcontroller is ideal for applications ranging from smoke detectors to portable health and fitness accessories.

### 6.2 CPU

The MSP430 CPU has a 16-bit RISC architecture that is highly transparent to the application. All operations, other than program-flow instructions, are performed as register operations in conjunction with seven addressing modes for source operand and four addressing modes for destination operand.

The CPU is integrated with 16 registers that provide reduced instruction execution time. The register-to-register operation execution time is one cycle of the CPU clock.

Four of the registers, R0 to R3, are dedicated as program counter (PC), stack pointer (SP), status register (SR), and constant generator (CG), respectively. The remaining registers are general-purpose registers.

Peripherals are connected to the CPU using data, address, and control buses, and can be handled with all instructions.

### 6.3 Operating Modes

The MSP430 has one active mode and several software-selectable low-power modes of operation (see [Table 6-1](#)). An interrupt event can wake up the device from low-power mode (LPM0, LPM3, or LPM4), service the request, and restore back to the low-power mode on return from the interrupt program. Low-power modes LPM3.5 and LPM4.5 disable the core supply to minimize power consumption.

**Table 6-1. Operating Modes**

| MODE                           |           | AM              | LPM0            | LPM3                                       | LPM4                     | LPM3.5                                     | LPM4.5            |
|--------------------------------|-----------|-----------------|-----------------|--------------------------------------------|--------------------------|--------------------------------------------|-------------------|
|                                |           | ACTIVE MODE     | CPU OFF         | STANDBY                                    | OFF                      | ONLY RTC COUNTER                           | SHUTDOWN          |
| Maximum system clock           |           | 16 MHz          | 16 MHz          | 40 kHz                                     | 0                        | 40 kHz                                     | 0                 |
| Power consumption at 25°C, 3 V |           | 126 $\mu$ A/MHz | 40 $\mu$ A/MHz  | 1.11 $\mu$ A with RTC counter only in LFXT | 0.45 $\mu$ A without SVS | 0.71 $\mu$ A with RTC counter only in LFXT | 32 nA without SVS |
| Wake-up time                   |           | N/A             | instant         | 10 $\mu$ s                                 | 10 $\mu$ s               | 350 $\mu$ s                                | 350 $\mu$ s       |
| Wake-up events                 |           | N/A             | All             | All                                        | I/O                      | RTC Counter I/O                            | I/O               |
| Power                          | Regulator | Full Regulation | Full Regulation | Partial Power Down                         | Partial Power Down       | Partial Power Down                         | Power Down        |
|                                | SVS       | On              | On              | Optional                                   | Optional                 | Optional                                   | Optional          |
|                                | Brownout  | On              | On              | On                                         | On                       | On                                         | On                |

**Table 6-1. Operating Modes (continued)**

| MODE                 |                              | AM          | LPM0     | LPM3       | LPM4               | LPM3.5           | LPM4.5     |
|----------------------|------------------------------|-------------|----------|------------|--------------------|------------------|------------|
|                      |                              | ACTIVE MODE | CPU OFF  | STANDBY    | OFF                | ONLY RTC COUNTER | SHUTDOWN   |
| Clock <sup>(1)</sup> | MCLK                         | Active      | Off      | Off        | Off                | Off              | Off        |
|                      | SMCLK                        | Optional    | Optional | Off        | Off                | Off              | Off        |
|                      | FLL                          | Optional    | Optional | Off        | Off                | Off              | Off        |
|                      | DCO                          | Optional    | Optional | Off        | Off                | Off              | Off        |
|                      | MODCLK                       | Optional    | Optional | Off        | Off                | Off              | Off        |
|                      | REFO                         | Optional    | Optional | Optional   | Off                | Off              | Off        |
|                      | ACLK                         | Optional    | Optional | Optional   | Off                | Off              | Off        |
|                      | XT1HFCLK <sup>(2)</sup>      | Optional    | Optional | Off        | Off                | Off              | Off        |
|                      | XT1LFCLK                     | Optional    | Optional | Optional   | Off <sup>(3)</sup> | Optional         | Off        |
|                      | VLOCLK                       | Optional    | Optional | Optional   | Off <sup>(3)</sup> | Optional         | Off        |
| Core                 | CPU                          | On          | Off      | Off        | Off                | Off              | Off        |
|                      | FRAM                         | On          | On       | Off        | Off                | Off              | Off        |
|                      | RAM                          | On          | On       | On         | On                 | Off              | Off        |
|                      | Backup Memory <sup>(4)</sup> | On          | On       | On         | On                 | On               | Off        |
| Peripherals          | Timer0_B3                    | Optional    | Optional | Optional   | Off                | Off              | Off        |
|                      | Timer1_B3                    | Optional    | Optional | Optional   | Off                | Off              | Off        |
|                      | WDT                          | Optional    | Optional | Optional   | Off                | Off              | Off        |
|                      | eUSCI_A0                     | Optional    | Optional | Optional   | Off                | Off              | Off        |
|                      | eUSCI_B0                     | Optional    | Optional | Optional   | Off                | Off              | Off        |
|                      | CRC                          | Optional    | Optional | Off        | Off                | Off              | Off        |
|                      | ADC                          | Optional    | Optional | Optional   | Off                | Off              | Off        |
|                      | eCOMP                        | Optional    | Optional | Optional   | Optional           | Off              | Off        |
|                      | TIA                          | Optional    | Optional | Optional   | Optional           | Off              | Off        |
|                      | SAC0                         | Optional    | Optional | Optional   | Optional           | Off              | Off        |
|                      | RTC Counter                  | Optional    | Optional | Optional   | Off                | Optional         | Off        |
| I/O                  | General Digital Input/Output | On          | Optional | State Held | State Held         | State Held       | State Held |
|                      | Capacitive Touch I/O         | Optional    | Optional | Optional   | Off                | Off              | Off        |

(1) The status shown for LPM4 applies to internal clocks only.

(2) HFXT must be disabled before entering into LPM3, LPM4, or LPMx.5 mode.

(3) Refer to following NOTE for details info as below.

(4) Backup memory contains one 32-byte register in the peripheral memory space. See [Table 6-23](#) and [Table 6-38](#) for the memory allocation of backup memory.

### NOTE

XT1CLK and VLOCLK can be active during LPM4 if requested by low-frequency peripherals.

## 6.4 Interrupt Vector Addresses

The interrupt vectors and the power-up start address are in the address range 0FFFFh to 0FF80h (see [Table 6-2](#)). The vector contains the 16-bit address of the interrupt-handler instruction sequence.

**Table 6-2. Interrupt Sources, Flags, and Vectors**

| INTERRUPT SOURCE                                                                                                                                                                                          | INTERRUPT FLAG                                                                                                                                                                                                                                     | SYSTEM INTERRUPT | WORD ADDRESS   | PRIORITY    |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------|----------------|-------------|
| <b>System Reset</b><br>Power-up, Brownout, Supply Supervisor<br>External Reset RST<br>Watchdog Time-out, Key Violation<br>FRAM uncorrectable bit error detection<br>Software POR, BOR<br>FLL unlock error | SVSHIFG<br>PMMRSTIFG<br>WDTIFG<br>PMMPORIFG, PMMBORIFG<br>SYSRSTIV<br>FLLULPUC                                                                                                                                                                     | Reset            | FFFEh          | 63, Highest |
| <b>System NMI</b><br>Vacant Memory Access<br>JTAG Mailbox<br>FRAM access time error<br>FRAM bit error detection                                                                                           | VMAIFG<br>JMBINIFG, JMBOUTIFG<br>CBDIFG, UBDIFG                                                                                                                                                                                                    | (Non)maskable    | FFFCh          | 62          |
| <b>User NMI</b><br>External NMI<br>Oscillator Fault                                                                                                                                                       | NMIIFG<br>OFIFG                                                                                                                                                                                                                                    | (Non)maskable    | FFFAh          | 61          |
| Timer0_B3                                                                                                                                                                                                 | TB0CCR0 CCIFG0                                                                                                                                                                                                                                     | Maskable         | FFF8h          | 60          |
| Timer0_B3                                                                                                                                                                                                 | TB0CCR1 CCIFG1, TB0CCR2 CCIFG2, TB0IFG (TB0IV)                                                                                                                                                                                                     | Maskable         | FFF6h          | 59          |
| Timer1_B3                                                                                                                                                                                                 | TB1CCR0 CCIFG0                                                                                                                                                                                                                                     | Maskable         | FFF4h          | 58          |
| Timer1_B3                                                                                                                                                                                                 | TB1CCR1 CCIFG1, TB1CCR2 CCIFG2, TB1IFG (TB1IV)                                                                                                                                                                                                     | Maskable         | FFF2h          | 57          |
| RTC Counter                                                                                                                                                                                               | RTCIFG                                                                                                                                                                                                                                             | Maskable         | FFF0h          | 56          |
| Watchdog Timer Interval mode                                                                                                                                                                              | WDTIFG                                                                                                                                                                                                                                             | Maskable         | FFEEh          | 55          |
| eUSCI_A0 Receive or Transmit                                                                                                                                                                              | UCTXCPITFG, UCSTTIFG,<br>UCRXIFG, UCTXIFG (UART mode)<br>UCRXIFG, UCTXIFG (SPI mode)<br>(UCA0IV)                                                                                                                                                   | Maskable         | FFECCh         | 54          |
| eUSCI_B0 Receive or Transmit                                                                                                                                                                              | UCB0RXIFG, UCB0TXIFG (SPI mode)<br>UCALIFG, UCNACKIFG,<br>UCSTTIFG, UCSTPIFG,<br>UCRXIFG0, UCTXIFG0,<br>UCRXIFG1, UCTXIFG1,<br>UCRXIFG2, UCTXIFG2,<br>UCRXIFG3, UCTXIFG3,<br>UCCNTIFG,<br>UCBIT9IFG, UCCLTOIFG (I <sup>2</sup> C mode)<br>(UCB0IV) | Maskable         | FFEAh          | 53          |
| ADC                                                                                                                                                                                                       | ADCIFG0, ADCINIFG,<br>ADCLOIFG, ADCHIIFG,<br>ADCTOVIFG, ADCOVIFG<br>(ADCIV)                                                                                                                                                                        | Maskable         | FFE8h          | 52          |
| P1                                                                                                                                                                                                        | P1IFG.0 to P1IFG.7 (P1IV)                                                                                                                                                                                                                          | Maskable         | FFE6h          | 51          |
| P2                                                                                                                                                                                                        | P2IFG.0 to P2IFG.7 (P2IV) <sup>(1)</sup>                                                                                                                                                                                                           | Maskable         | FFE4h          | 50          |
| eCOMP                                                                                                                                                                                                     | CPIIFG, CPIFG (CPIV)                                                                                                                                                                                                                               | Maskable         | FFE2h          | 49          |
| Reserved                                                                                                                                                                                                  | Reserved                                                                                                                                                                                                                                           | Maskable         | FFE0h to FF88h |             |

(1) P2.0, P2.1, P2.6, and P2.7 support both pin and software interrupts. Others ports support software interrupts only.

**Table 6-2. Interrupt Sources, Flags, and Vectors (continued)**

| INTERRUPT SOURCE | INTERRUPT FLAG   | SYSTEM INTERRUPT | WORD ADDRESS | PRIORITY |
|------------------|------------------|------------------|--------------|----------|
| Signatures       | BSL Signature 2  |                  | 0FF86h       |          |
|                  | BSL Signature 1  |                  | 0FF84h       |          |
|                  | JTAG Signature 2 |                  | 0FF82h       |          |
|                  | JTAG Signature 1 |                  | 0FF80h       |          |

## 6.5 Memory Organization

Table 6-3 summarizes the memory map of the MSP430FR231x MCUs.

**Table 6-3. Memory Organization**

|                                                                              | ACCESS                                                | MSP430FR2311                               | MSP430FR2310                            |
|------------------------------------------------------------------------------|-------------------------------------------------------|--------------------------------------------|-----------------------------------------|
| Memory (FRAM)<br>Main: interrupt vectors and signatures<br>Main: code memory | Read/Write<br>(Optional Write Protect) <sup>(1)</sup> | 3.75KB<br>FFFFh to FF80h<br>FFFFh to F100h | 2KB<br>FFFFh to FF80h<br>FFFFh to F800h |
| RAM                                                                          | Read/Write                                            | 1KB<br>23FFh to 2000h                      | 1KB<br>23FFh to 2000h                   |
| Bootloader (BSL1) Memory (ROM) (TI Internal Use)                             | Read only                                             | 2KB<br>17FFh to 1000h                      | 2KB<br>17FFh to 1000h                   |
| Bootloader (BSL2) Memory (ROM) (TI Internal Use)                             | Read only                                             | 1KB<br>FFFFh to FFC00h                     | 1KB<br>FFFFh to FFC00h                  |
| Peripherals                                                                  | Read/Write                                            | 4KB<br>0FFFh to 0000h                      | 4KB<br>0FFFh to 0000h                   |

(1) The Program FRAM can be write protected by setting the PFWP bit in the SYSCFG0 register. See the *System Resets, Interrupts, and Operating Modes, System Control Module (SYS)* chapter in the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#) for more details

## 6.6 Bootloader (BSL)

The BSL lets users program the FRAM or RAM using a UART or I<sup>2</sup>C serial interface. Access to the device memory through the BSL is protected by a user-defined password. Use of the BSL requires four pins (see [Table 6-4](#) and [Table 6-5](#)). BSL entry requires a specific entry sequence on the  $\overline{\text{RST}}/\text{NMI}/\text{SBWTDIO}$  and  $\text{TEST}/\text{SBWTCK}$  pins.

This device supports blank device detection to automatically invoke the BSL and skip the special entry sequence, which saves time and simplifies onboard programming. For complete description of the features of the BSL and its implementation, see [MSP430 FRAM Device Bootloader \(BSL\) User's Guide](#).

**Table 6-4. UART BSL Pin Requirements and Functions**

| DEVICE SIGNAL                                     | BSL FUNCTION          |
|---------------------------------------------------|-----------------------|
| $\overline{\text{RST}}/\text{NMI}/\text{SBWTDIO}$ | Entry sequence signal |
| $\text{TEST}/\text{SBWTCK}$                       | Entry sequence signal |
| P1.7                                              | Data transmit         |
| P1.6                                              | Data receive          |
| V <sub>CC</sub>                                   | Power supply          |
| VSS                                               | Ground supply         |

**Table 6-5. I<sup>2</sup>C BSL Pin Requirements and Functions**

| DEVICE SIGNAL                                     | BSL FUNCTION              |
|---------------------------------------------------|---------------------------|
| $\overline{\text{RST}}/\text{NMI}/\text{SBWTDIO}$ | Entry sequence signal     |
| TEST/SBWTK                                        | Entry sequence signal     |
| P1.2                                              | Data receive and transmit |
| P1.3                                              | Clock                     |
| V <sub>CC</sub>                                   | Power supply              |
| VSS                                               | Ground supply             |

## 6.7 JTAG Standard Interface

The MSP430 family supports the standard JTAG interface which requires four signals for sending and receiving data. The JTAG signals are shared with general-purpose I/O. The TEST/SBWTK pin enables the JTAG signals. In addition to these signals, the  $\overline{\text{RST}}/\text{NMI}/\text{SBWTDIO}$  pin interfaces with MSP430 development tools and device programmers. Table 6-6 lists the JTAG pin requirements. For further details on interfacing to development tools and device programmers, see the [MSP430 Hardware Tools User's Guide](#).

**Table 6-6. JTAG Pin Requirements and Function**

| DEVICE SIGNAL                                     | DIRECTION | JTAG FUNCTION                  |
|---------------------------------------------------|-----------|--------------------------------|
| P1.4/UCARSTE/TCK/OA0+/A4                          | IN        | JTAG clock input               |
| P1.5/UCACLK/TMS/TRIO0/A5                          | IN        | JTAG state control             |
| P1.6/UCARXD/UCASOMI/TB0.1/TDI/TCLK/TRIO-/A6       | IN        | JTAG data input and TCLK input |
| P1.7/UCATXD/UCASIMO/TB0.2/TDO/TRIO+/A7/VREF+      | OUT       | JTAG data output               |
| TEST/SBWTK                                        | IN        | Enable JTAG pins               |
| $\overline{\text{RST}}/\text{NMI}/\text{SBWTDIO}$ | IN        | External reset                 |
| V <sub>CC</sub>                                   |           | Power supply                   |
| VSS                                               |           | Ground supply                  |

## 6.8 Spy-Bi-Wire Interface (SBW)

The MSP430 family supports the 2-wire Spy-Bi-Wire interface. Spy-Bi-Wire can be used to interface with MSP430 development tools and device programmers. Table 6-7 lists the Spy-Bi-Wire interface pin requirements. For further details on interfacing to development tools and device programmers, see the [MSP430 Hardware Tools User's Guide](#).

**Table 6-7. Spy-Bi-Wire Pin Requirements and Functions**

| DEVICE SIGNAL                                     | DIRECTION | SBW FUNCTION                      |
|---------------------------------------------------|-----------|-----------------------------------|
| TEST/SBWTK                                        | IN        | Spy-Bi-Wire clock input           |
| $\overline{\text{RST}}/\text{NMI}/\text{SBWTDIO}$ | IN, OUT   | Spy-Bi-Wire data input and output |
| V <sub>CC</sub>                                   | –         | Power supply                      |
| VSS                                               | –         | Ground supply                     |

## 6.9 FRAM

The FRAM can be programmed using the JTAG port, Spy-Bi-Wire (SBW), the BSL, or in system by the CPU. Features of the FRAM include:

- Byte and word access capability
- Programmable wait state generation
- Error correction coding (ECC)

## 6.10 Memory Protection

The device features memory protection of user access authority and write protection include:

- Securing the whole memory map to prevent unauthorized access from JTAG port or BSL, by writing JTAG and BSL signatures using the JTAG port, SBW, the BSL, or in system by the CPU.
- Write protection enabled to prevent unwanted write operation to FRAM contents by setting the control bits with accordingly password in System Configuration register 0. For more detailed information, see the *System Resets, Interrupts, and Operating Modes, System Control Module (SYS)* chapter in the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#).

## 6.11 Peripherals

Peripherals are connected to the CPU through data, address, and control buses. All peripherals can be handled by using all instructions in the memory map. For complete module description, see the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#).

### 6.11.1 Power-Management Module (PMM) and On-chip Reference Voltages

The PMM includes an integrated voltage regulator that supplies the core voltage to the device. The PMM also includes supply voltage supervisor (SVS) and brownout protection. The brownout reset circuit (BOR) is implemented to provide the proper internal reset signal to the device during power on and power off. The SVS circuitry detects if the supply voltage drops below a user-selectable safe level. SVS circuitry is available on the primary supply.

The device contains two on-chip reference: 1.5 V for internal reference and 1.2 V for external reference.

The 1.5-V reference is internally connected to ADC channel 13. DVCC is internally connected to ADC channel 15. When DVCC is set as the reference voltage for ADC conversion, the DVCC can be easily represent as [Equation 1](#) by using ADC sampling 1.5-V reference without any external components support.

$$DVCC = (1023 \times 1.5 \text{ V}) \div 1.5\text{-V reference ADC result} \quad (1)$$

The 1.5-V reference is also internally connected to the Comparator built-in DAC as reference voltage. DVCC is internally connected to another source of DAC reference, and both are controlled by the CPDACREFS bit. For more detailed information, see the *Enhanced Comparator (eCOMP)* chapter of the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#).

A 1.2-V reference voltage can be buffered, when EXTREFEN = 1 on PMMCTL2 register, and it can be output to P1.7/UCA0TXD/UCA0SIMO/TB0.2/TDO/TRI0+/A7/VREF+ , meanwhile the ADC channel 7 can also be selected to monitor this voltage. For more detailed information, see the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#).

### 6.11.2 Clock System (CS) and Clock Distribution

The clock system includes a 32-kHz low-frequency oscillator (XT1 low frequency) or up to a 16-MHz high-frequency crystal oscillator (XT1 high frequency), an internal very low-power low-frequency oscillator (VLO), an integrated 32-kHz RC oscillator (REFO), an integrated internal digitally controlled oscillator (DCO) that can use frequency-locked loop (FLL) locking with internal or external 32-kHz reference clock, and on-chip asynchronous high-speed clock (MODOSC). The clock system is designed to target cost-effective designs with minimal external components. A fail-safe mechanism is designed for XT1. The clock system module offers the following clock signals.

- Main Clock (MCLK): system clock used by the CPU and all relevant peripherals accessed by the bus. All clock sources except MODOSC can be selected as the source with a predivider of 1, 2, 4, 8, 16, 32, 64, or 128.
- Sub-Main Clock (SMCLK): subsystem clock used by the peripheral modules. SMCLK derives from the MCLK with a predivider of 1, 2, 4, or 8. This means SMCLK is always equal to or less than MCLK.
- Auxiliary Clock (ACLK): derived from the external XT1 clock or internal REFO clock up to 40 kHz.

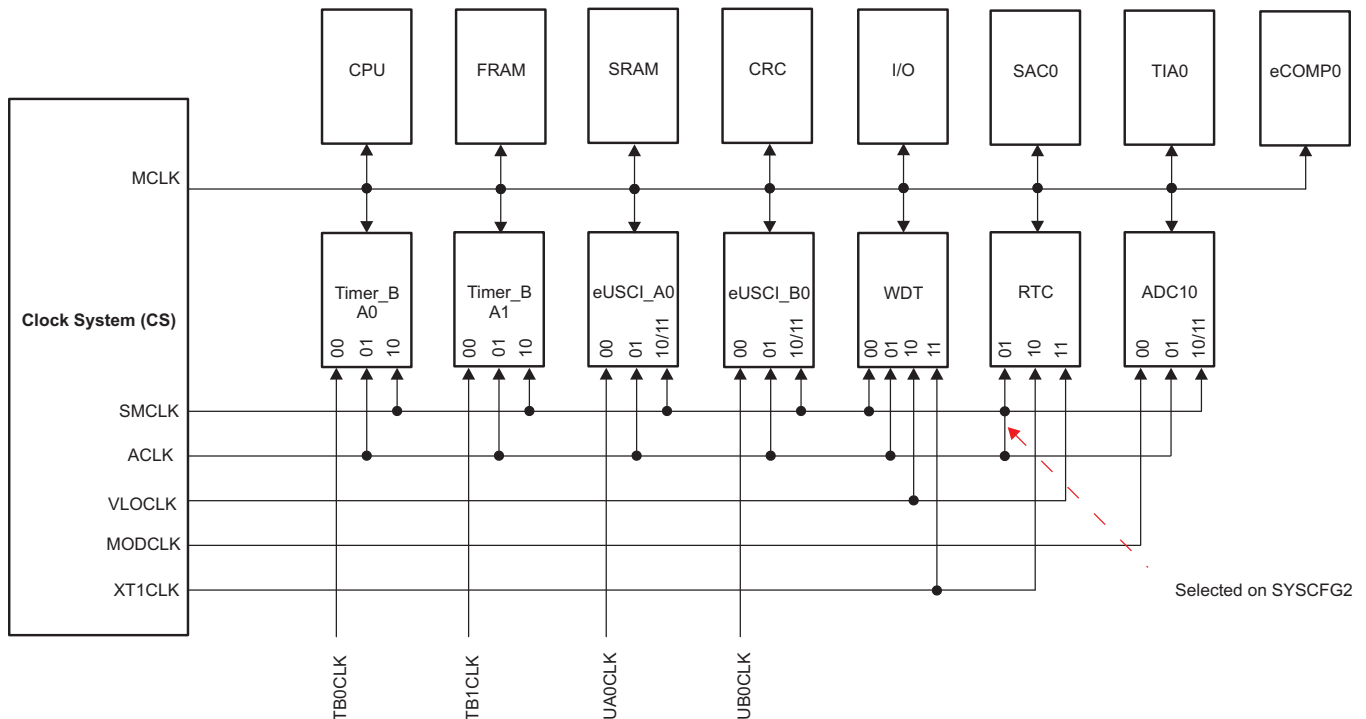
All peripherals may have one or several clock sources depending on specific functionality. [Table 6-8](#) and [Table 6-9](#) show the clock distribution used in this device.

**Table 6-8. Clock Distribution**

|                 | CLOCK SOURCE SELECT BITS <sup>(1)</sup> | MCLK         | SMCLK              | ACLK               | MODCLK     | VLOCLK      | EXTERNAL PIN      |
|-----------------|-----------------------------------------|--------------|--------------------|--------------------|------------|-------------|-------------------|
| Frequency Range |                                         | DC to 16 MHz | DC to 16 MHz       | DC to 40 kHz       | 5 MHz ±10% | 10 kHz ±50% | –                 |
| CPU             | N/A                                     | Default      | –                  | –                  | –          | –           | –                 |
| FRAM            | N/A                                     | Default      | –                  | –                  | –          | –           | –                 |
| RAM             | N/A                                     | Default      | –                  | –                  | –          | –           | –                 |
| CRC             | N/A                                     | Default      | –                  | –                  | –          | –           | –                 |
| I/O             | N/A                                     | Default      | –                  | –                  | –          | –           | –                 |
| TB0             | TBSSEL                                  | –            | 10b                | 01b                | –          | –           | 00b (TB0CLK pin)  |
| TB1             | TBSSEL                                  | –            | 10b                | 01b                | –          | –           | 00b (TB1CLK pin)  |
| eUSCI_A0        | UCSSEL                                  | –            | 10b or 11b         | 01b                | –          | –           | 00b (UCA0CLK pin) |
| eUSCI_B0        | UCSSEL                                  | –            | 10b or 11b         | 01b                | –          | –           | 00b (UCB0CLK pin) |
| WDT             | WDTSEL                                  | –            | 00b                | 01b                | –          | 10b         | –                 |
| ADC             | ADCSSEL                                 | –            | 10b or 11b         | 01b                | 00b        | –           | –                 |
| RTC             | RTCSS                                   | –            | 01b <sup>(2)</sup> | 01b <sup>(2)</sup> | –          | 11b         | –                 |

(1) N/A = not applicable

(2) Controlled by the RTCCKSEL bit in the SYSCFG2 register.



**Figure 6-1. Clock Distribution Block Diagram**

**Table 6-9. XTCLK Distribution**

| OPERATION MODE | CLOCK SOURCE SELECT BITS | XTHFCLK    | XTLFCLK    | XTLFCLK (LPMx.5) |
|----------------|--------------------------|------------|------------|------------------|
|                |                          | AM TO LPM0 | AM TO LPM3 | AM TO LPM3.5     |
| MCLK           | SELMS                    | 10b        | 10b        | 10b              |
| SMCLK          | SELMS                    | 10b        | 10b        | 10b              |
| REFO           | SELREF                   | 0b         | 0b         | 0b               |
| ACLK           | SELA                     | 0b         | 0b         | 0b               |
| RTC            | RTCSS                    | –          | 10b        | 10b              |

### 6.11.3 General-Purpose Input/Output Port (I/O)

There are up to 16 I/O ports implemented.

- P1 and P2 are full 8-bit ports.
- All individual I/O bits are independently programmable.
- Any combination of input and output is possible for P1 and P2. All inputs of P1 and four inputs of P2 (P2.0, P2.1, P2.6, P2.7) can be configured for interrupt input.
- Programmable pullup or pulldown on all ports.
- All inputs of P1 and four inputs of P2 (P2.0, P2.1, P2.6, P2.7) can be configured for edge-selectable interrupt and for LPM3.5, LPM4, and LPM4.5 wake-up input capability.
- Read and write access to port-control registers is supported by all instructions.
- Ports can be accessed byte-wise or word-wise in pairs.
- Capacitive Touch I/O functionality is supported on all pins.

#### NOTE

##### Configuration of digital I/Os after BOR reset

To prevent any cross currents during start-up of the device, all port pins are high-impedance with Schmitt triggers and module functions disabled. To enable the I/O functions after a BOR reset, the ports must be configured first and then the LOCKLPM5 bit must be cleared. For details, see the *Configuration After Reset* section in the *Digital I/O* chapter of the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#).

### 6.11.4 Watchdog Timer (WDT)

The primary function of the WDT module is to perform a controlled system restart after a software problem occurs. If the selected time interval expires, a system reset is generated. If the watchdog function is not needed in an application, the module can be configured as interval timer and can generate interrupts at selected time intervals.

**Table 6-10. WDT Clocks**

| WDTSEL | NORMAL OPERATION<br>(WATCHDOG AND INTERVAL TIMER MODE) |
|--------|--------------------------------------------------------|
| 00     | SMCLK                                                  |
| 01     | ACLK                                                   |
| 10     | VLOCLK                                                 |
| 11     | Reserved                                               |

### 6.11.5 System Module (SYS)

The SYS module handles many of the system functions within the device. These system functions include power-on reset (POR) and power-up clear (PUC) handling, NMI source selection and management, reset interrupt vector generators, bootloader entry mechanisms, and configuration management (device descriptors) (see [Table 6-11](#)). SYS also includes a data exchange mechanism through SBW called a JTAG mailbox that can be used in the application.

**Table 6-11. System Module Interrupt Vector Registers**

| INTERRUPT VECTOR REGISTER | ADDRESS | INTERRUPT EVENT                           | VALUE      | PRIORITY |
|---------------------------|---------|-------------------------------------------|------------|----------|
| SYSRSTIV, System Reset    | 015Eh   | No interrupt pending                      | 00h        |          |
|                           |         | Brownout (BOR)                            | 02h        | Highest  |
|                           |         | RSTIFG $\overline{\text{RST}}$ /NMI (BOR) | 04h        |          |
|                           |         | PMMSWBOR software BOR (BOR)               | 06h        |          |
|                           |         | LPMx.5 wakeup (BOR)                       | 08h        |          |
|                           |         | Security violation (BOR)                  | 0Ah        |          |
|                           |         | Reserved                                  | 0Ch        |          |
|                           |         | SVSHIFG SVSH event (BOR)                  | 0Eh        |          |
|                           |         | Reserved                                  | 10h        |          |
|                           |         | Reserved                                  | 12h        |          |
|                           |         | PMMSWPOR software POR (POR)               | 14h        |          |
|                           |         | WDTIFG watchdog time-out (PUC)            | 16h        |          |
|                           |         | WDTPW password violation (PUC)            | 18h        |          |
|                           |         | FRCTLPW password violation (PUC)          | 1Ah        |          |
|                           |         | Uncorrectable FRAM bit error detection    | 1Ch        |          |
|                           |         | Peripheral area fetch (PUC)               | 1Eh        |          |
|                           |         | PMMPW PMM password violation (PUC)        | 20h        |          |
|                           |         | Reserved                                  | 22h        |          |
|                           |         | FLL unlock (PUC)                          | 24h        |          |
|                           |         | Reserved                                  | 26h to 3Eh | Lowest   |
| SYSSNIV, System NMI       | 015Ch   | No interrupt pending                      | 00h        |          |
|                           |         | SVS low-power reset entry                 | 02h        | Highest  |
|                           |         | Uncorrectable FRAM bit error detection    | 04h        |          |
|                           |         | Reserved                                  | 06h        |          |
|                           |         | Reserved                                  | 08h        |          |
|                           |         | Reserved                                  | 0Ah        |          |
|                           |         | Reserved                                  | 0Ch        |          |
|                           |         | Reserved                                  | 0Eh        |          |
|                           |         | Reserved                                  | 10h        |          |
|                           |         | VMAIFG Vacant memory access               | 12h        |          |
|                           |         | JMBINIFG JTAG mailbox input               | 14h        |          |
|                           |         | JMBOUTIFG JTAG mailbox output             | 16h        |          |
|                           |         | Correctable FRAM bit error detection      | 18h        |          |
|                           |         | Reserved                                  | 1Ah to 1Eh | Lowest   |
| SYSUNIV, User NMI         | 015Ah   | No interrupt pending                      | 00h        |          |
|                           |         | NMIIFG NMI pin or SVS <sub>H</sub> event  | 02h        | Highest  |
|                           |         | OFIFG oscillator fault                    | 04h        |          |
|                           |         | Reserved                                  | 06h to 1Eh | Lowest   |

### 6.11.6 Cyclic Redundancy Check (CRC)

The 16-bit cyclic redundancy check (CRC) module produces a signature based on a sequence of data values and can be used for data checking purposes. The CRC generation polynomial is compliant with CRC-16-CCITT standard of  $x^{16} + x^{12} + x^5 + 1$ .

### 6.11.7 Enhanced Universal Serial Communication Interface (eUSCI\_A0, eUSCI\_B0)

The eUSCI modules are used for serial data communications. The eUSCI\_A module supports either UART or SPI communications. The eUSCI\_B module supports either SPI or I<sup>2</sup>C communications. In addition, the eUSCI\_A module supports automatic baud-rate detection and IrDA.. The eUSCI\_B module is connected either from P1 port or P2 port, it can be selected from the USCIBRMAP bit of the SYSCFG2 register (see [Table 6-12](#)).

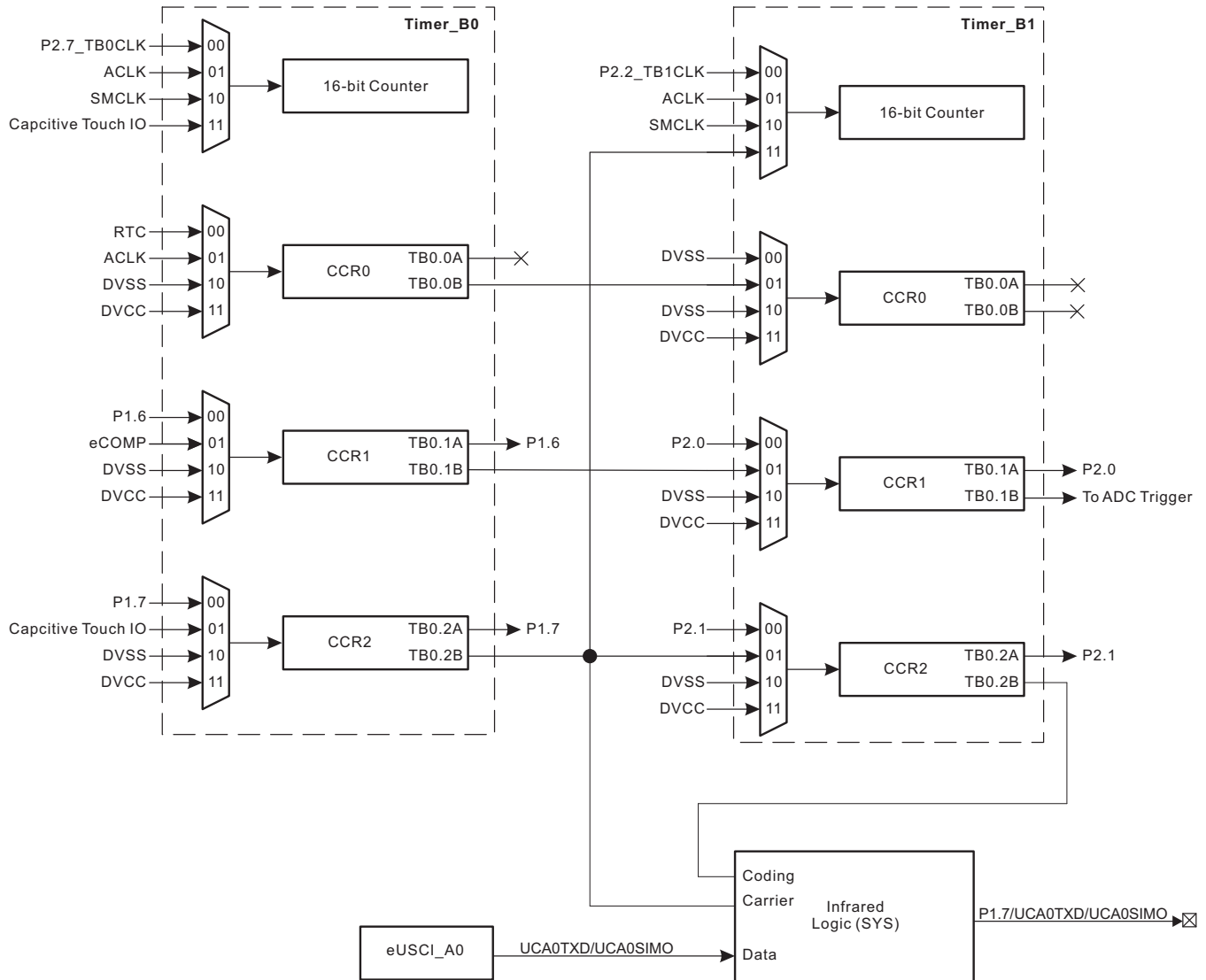
**Table 6-12. eUSCI Pin Configurations**

|          | PIN                | UART             | SPI  |
|----------|--------------------|------------------|------|
| eUSCI_A0 | P1.7               | TXD              | SIMO |
|          | P1.6               | RXD              | SOMI |
|          | P1.5               | –                | SCLK |
|          | P1.4               | –                | STE  |
|          | PIN (USCIBRMP = 0) | I <sup>2</sup> C | SPI  |
| eUSCI_B0 | P1.0               | –                | STE  |
|          | P1.1               | –                | SCLK |
|          | P1.2               | SDA              | SIMO |
|          | P1.3               | SCL              | SOMI |
|          | PIN (USCIBRMP = 1) | I <sup>2</sup> C | SPI  |
|          | P2.2               | –                | STE  |
|          | P2.3               | –                | SCLK |
|          | P2.4               | SDA              | SIMO |
|          | P2.5               | SCL              | SOMI |

### 6.11.8 Timers (Timer0\_B3, Timer1\_B3)

The Timer0\_B3 and Timer1\_B3 modules are 16-bit timers and counters with three capture/compare registers each. Each can support multiple captures or compares, PWM outputs, and interval timing (see [Table 6-13](#) and [Table 6-14](#)). Each has extensive interrupt capabilities. Interrupts may be generated from the counter on overflow conditions and from each of the capture/compare registers. The CCR0 registers on TB0 and TB1 are not externally connected and can be used only for hardware period timing and interrupt generation. In Up mode, they can set the overflow value of the counter.

The interconnection of Timer0\_B3 and Timer1\_B3 can modulate the eUSCI\_A pin of UCA0TXD/UCA0SIMO in either ASK or FSK mode, with which a user can easily acquire a modulated infrared command for directly driving an external IR diode (see [Figure 6-2](#)). The IR functions are fully controlled by the SYS configuration registers including IREN (enable), IRPSEL (polarity select), IRMSEL (mode select), IRDSSEL (data select), and IRDATA (data) bits. For more information, see the *System Resets, Interrupts, and Operating Modes, System Control Module (SYS)* chapter in the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#).



**Figure 6-2. Timer\_B Connections**

**Table 6-13. Timer0\_B3 Signal Connections**

| PORT PIN | DEVICE INPUT SIGNAL                  | MODULE INPUT NAME | MODULE BLOCK | MODULE OUTPUT SIGNAL | DEVICE OUTPUT SIGNAL                                  |
|----------|--------------------------------------|-------------------|--------------|----------------------|-------------------------------------------------------|
| P2.7     | TB0CLK                               | TBCLK             | Timer        | N/A                  |                                                       |
|          | ACLK (internal)                      | ACLK              |              |                      |                                                       |
|          | SMCLK (internal)                     | SMCLK             |              |                      |                                                       |
|          | From Capacitive Touch I/O (internal) | INCLK             |              |                      |                                                       |
|          | From RTC (internal)                  | CCI0A             |              |                      |                                                       |
|          | ACLK (internal)                      | CCI0B             | CCR0         | TB0                  | Timer1_B3 CCI0B input                                 |
|          | DVSS                                 | GND               |              |                      |                                                       |
|          | DVCC                                 | V <sub>CC</sub>   |              |                      |                                                       |
|          |                                      |                   |              |                      |                                                       |
| P1.6     | TB0.1                                | CCI1A             | CCR1         | TB1                  | TB0.1                                                 |
|          | From eCOMP (internal)                | CCI1B             |              |                      | Timer1_B3 CCI1B input                                 |
|          | DVSS                                 | GND               |              |                      |                                                       |
|          | DVCC                                 | V <sub>CC</sub>   |              |                      |                                                       |
| P1.7     | TB0.2                                | CCI2A             | CCR2         | TB2                  | TB0.2                                                 |
|          | From Capacitive Touch I/O (internal) | CCI2B             |              |                      | Timer1_B3 INCLK<br>Timer1_B3 CCI2B input,<br>IR input |
|          | DVSS                                 | GND               |              |                      |                                                       |
|          | DVCC                                 | V <sub>CC</sub>   |              |                      |                                                       |

**Table 6-14. Timer1\_B3 Signal Connections**

| PORT PIN | DEVICE INPUT SIGNAL               | MODULE INPUT NAME | MODULE BLOCK | MODULE OUTPUT SIGNAL | DEVICE OUTPUT SIGNAL |
|----------|-----------------------------------|-------------------|--------------|----------------------|----------------------|
| P2.2     | TB1CLK                            | TBCLK             | Timer        | N/A                  |                      |
|          | ACLK (internal)                   | ACLK              |              |                      |                      |
|          | SMCLK (internal)                  | SMCLK             |              |                      |                      |
|          | Timer0_B3 CCR2B output (internal) | INCLK             |              |                      |                      |
|          | DVSS                              | CCI0A             |              |                      |                      |
|          | Timer0_B3 CCR0B output (internal) | CCI0B             | CCR0         | TB0                  |                      |
|          | DVSS                              | GND               |              |                      |                      |
|          | DVCC                              | V <sub>CC</sub>   |              |                      |                      |
|          |                                   |                   |              |                      |                      |
| P2.0     | TB1.1                             | CCI1A             | CCR1         | TB1                  | TB1.1                |
|          | Timer0_B3 CCR1B output (internal) | CCI1B             |              |                      | To ADC trigger       |
|          | DVSS                              | GND               |              |                      |                      |
|          | DVCC                              | V <sub>CC</sub>   |              |                      |                      |
| P2.1     | TB1.2                             | CCI2A             | CCR2         | TB2                  | TB1.2                |
|          | Timer0_B3 CCR2B output (internal) | CCI2B             |              |                      | IR input             |
|          | DVSS                              | GND               |              |                      |                      |
|          | DVCC                              | V <sub>CC</sub>   |              |                      |                      |

The Timer\_B module includes a feature that puts all Timer\_B outputs into a high-impedance state when the selected source is triggered. The source can be selected from an external pin or an internal signal, and it is controlled by TBxTRG in SYS. For more information, see the *System Resets, Interrupts, and Operating Modes, System Control Module (SYS)* chapter in the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#).

Table 6-15 lists the Timer\_B high-impedance trigger source selections.

**Table 6-15. TBxOUTH**

| TBxTRGSEL     | TBxOUTH TRIGGER SOURCE SELECTION | Timer_B PAD OUTPUT HIGH IMPEDANCE |
|---------------|----------------------------------|-----------------------------------|
| TB0TRGSEL = 0 | eCOMP0 output (internal)         | P1.6, P1.7                        |
| TB0TRGSEL = 1 | P1.2                             |                                   |
| TB1TRGSEL = 0 | eCOMP0 output (internal)         | P2.0, P2.1                        |
| TB1TRGSEL = 1 | P2.3                             |                                   |

### 6.11.9 Backup Memory (BAKMEM)

The BAKMEM supports data retention during LPM3.5 mode. This device provides up to 32 bytes that are retained during LPM3.5.

### 6.11.10 Real-Time Clock (RTC) Counter

The RTC counter is a 16-bit modulo counter that is functional in AM, LPM0, LPM3, LPM4, and LPM3.5. This module may periodically wake up the CPU from LPM0, LPM3, LPM4, and LPM3.5 based on timing from a low-power clock source such as the XT1, ACLK, or VLO clocks. In AM, RTC can be driven by SMCLK to generate high-frequency timing events and interrupts. ACLK and SMCLK both can source to the RTC, however only one of them can be selected simultaneously. The RTC overflow events trigger:

- Timer0\_B3 CCI0A
- ADC conversion trigger when ADCSHSx bits are set as 01b

### 6.11.11 10-Bit Analog-to-Digital Converter (ADC)

The 10-bit ADC module supports fast 10-bit analog-to-digital conversions with single-ended input. The module implements a 10-bit SAR core, sample select control, a reference generator, and a conversion result buffer. A window comparator with lower and upper limits allows CPU-independent result monitoring with three window comparator interrupt flags.

The ADC supports 10 external inputs and 4 internal inputs (see [Table 6-16](#)).

**Table 6-16. ADC Channel Connections**

| ADCINCHx | ADC CHANNELS               | EXTERNAL PIN |
|----------|----------------------------|--------------|
| 0        | A0/V <sub>ref</sub> +      | P1.0         |
| 1        | A1                         | P1.1         |
| 2        | A2/V <sub>ref</sub> -      | P1.2         |
| 3        | A3                         | P1.3         |
| 4        | A4                         | P1.4         |
| 5        | A5                         | P1.5         |
| 6        | A6                         | P1.6         |
| 7        | A7 <sup>(1)</sup>          | P1.7         |
| 8        | Not used                   | N/A          |
| 9        | Not used                   | N/A          |
| 10       | Not used                   | N/A          |
| 11       | Not used                   | N/A          |
| 12       | On-chip temperature sensor | N/A          |
| 13       | Reference voltage (1.5 V)  | N/A          |
| 14       | DVSS                       | N/A          |
| 15       | DVCC                       | N/A          |

- (1) When A7 is used, the PMM 1.2-V reference voltage can be output to this pin by setting the PMM control register. The 1.2-V voltage can be measured by the A7 channel.

The analog-to-digital conversion can be started by software or a hardware trigger. [Table 6-17](#) lists the trigger sources that are available.

**Table 6-17. ADC Trigger Signal Connections**

| ADC SHSx |         | TRIGGER SOURCE               |
|----------|---------|------------------------------|
| BINARY   | DECIMAL |                              |
| 00       | 0       | ADCSC bit (software trigger) |
| 01       | 1       | RTC event                    |
| 10       | 2       | TB1.1B                       |
| 11       | 3       | eCOMP0 COUT                  |

### 6.11.12 eCOMP0

The enhanced comparator is an analog voltage comparator with built-in 6-bit DAC as an internal voltage reference. The integrated 6-bit DAC can be set up to 64 steps for comparator reference voltage. This module has 4-level programmable hysteresis and configurable power modes, high power or low power.

eCOMP0 supports external inputs and internal inputs (see [Table 6-18](#)) and outputs (see [Table 6-19](#)).

**Table 6-18. eCOMP0 Input Channel Connections**

| CPPSEL, CPNSEL | eCOMP0 CHANNELS | EXTERNAL OR INTERNAL CONNECTION                             |
|----------------|-----------------|-------------------------------------------------------------|
| BINARY         |                 |                                                             |
| 000            | C0              | P1.0                                                        |
| 001            | C1              | P1.1                                                        |
| 010            | Not used        | N/A                                                         |
| 011            | Not used        | N/A                                                         |
| 100            | C4              | SAC0, OA0O on positive port<br>TIA0, TRI0O on negative port |
| 101            | Not used        | N/A                                                         |
| 110            | C6              | Built-in 6-bit DAC                                          |

**Table 6-19. eCOMP0 Output Channel Connections**

| eCOMP0 OUT | EXTERNAL PIN OUT, MODULE                  |
|------------|-------------------------------------------|
| 1          | P2.0                                      |
| 2          | TB0.1B, TB0 (TB0OUTH), TB1 (TB1OUTH), ADC |

### 6.11.13 SAC0

The Smart Analog Combo (SAC) integrates a high-performance low-power operational amplifier. SAC-L1 is integrated in FR231x. SAC-L1 supports only a general-purpose amplifier. For more information, see the *Smart Analog Combo (SAC)* chapter in the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#).

SAC0 supports external inputs and internal inputs (see [Table 6-20](#) and [Table 6-21](#)).

**Table 6-20. SAC0 Positive Input Channel Connections**

| PSEL | SAC0 CHANNELS                | EXTERNAL PIN OUT, MODULE |
|------|------------------------------|--------------------------|
| 00   | SAC0, OA0 positive channel 1 | P1.4                     |
| 10   | SAC0, OA0 positive channel 2 | TRI0O                    |

**Table 6-21. SAC0 Negative Input Channel Connections**

| NSEL | SAC0 CHANNELS                | EXTERNAL PIN OUT, MODULE |
|------|------------------------------|--------------------------|
| 00   | SAC0, OA0 negative channel 1 | P1.2                     |
| 10   | Not used                     | N/A                      |

#### 6.11.14 TIA0

The Transimpedance Amplifier (TIA) is a high-performance low-power amplifier with rail-to-rail output. This module is an amplifier that converts current to voltage. It has programmable power modes: high power or low power. For more information, see the *Transimpedance Amplifier (TIA)* chapter in the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#).

The FR231x device in the TSSOP-16 package supports a dedicated low-leakage pad for TIA negative input to support low-leakage performance. In other packages (TSSOP-20 and VQFN-16), the TIA negative port is shared with a GPIO to support the transimpedance amplifier function. For more information, see [Section 4](#) and [Table 5-25](#).

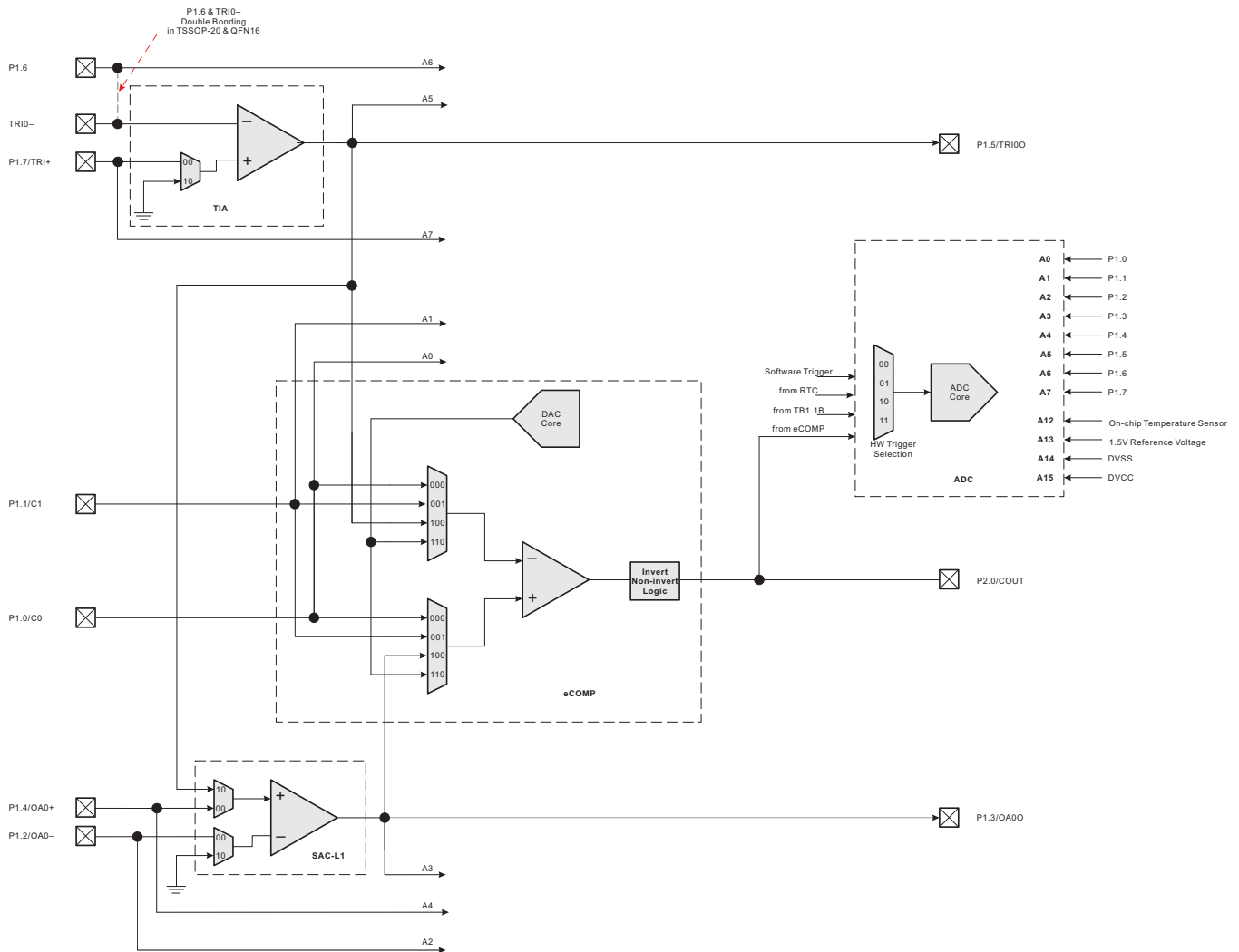
The TIA supports external input (see [Table 6-22](#) and [Section 4](#)).

**Table 6-22. TIA Input Channel Connections**

| TRIPSEL | TIA0 CHANNELS  | EXTERNAL PIN OUT, MODULE |
|---------|----------------|--------------------------|
| 00      | Positive input | P1.7                     |
| 01      | Not used       | N/A                      |
| 10      | Not used       | N/A                      |
| 11      | Not used       | N/A                      |

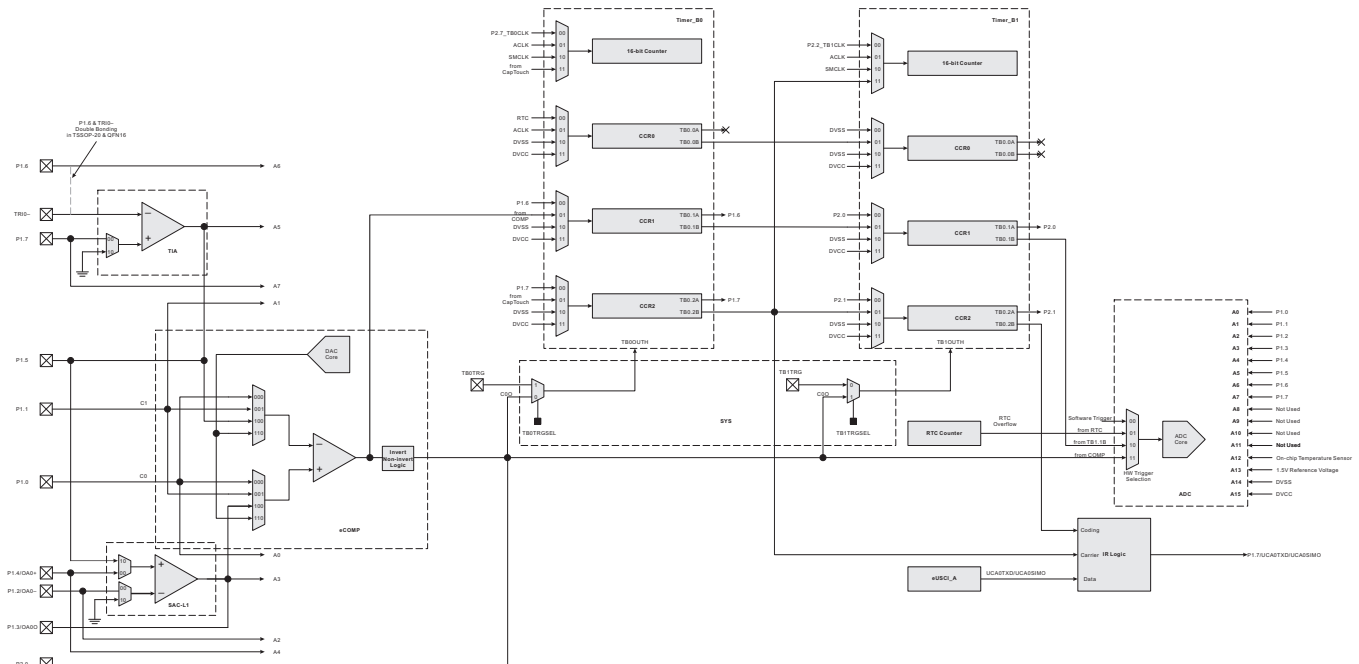
### 6.11.15 eCOMP0, SAC0, TIA0, and ADC in SOC Interconnection

Figure 6-3 shows how the high-performance analog modules are internally connected.



**Figure 6-3. High-Performance Analog SOC Interconnection**

Figure 6-4 shows how the analog modules can be connected internally.



### Figure 6-4. SOC Interconnection

#### 6.11.16 Embedded Emulation Module (EEM)

The EEM supports real-time in-system debugging. The EEM on these devices has the following features:

- Three hardware triggers or breakpoints on memory access
- One hardware trigger or breakpoint on CPU register write access
- Up to four hardware triggers that can be combined to form complex triggers or breakpoints
- One cycle counter
- Clock control on module level

### 6.11.17 Peripheral File Map

Table 6-23 lists the base address of the registers for each peripheral. Table 6-24 through Table 6-42 list all of the available registers for each peripheral and their address offsets.

**Table 6-23. Peripherals Summary**

| MODULE NAME                           | BASE ADDRESS | SIZE  |
|---------------------------------------|--------------|-------|
| Special Functions (see Table 6-24)    | 0100h        | 0010h |
| PMM (see Table 6-25)                  | 0120h        | 0020h |
| SYS (see Table 6-26)                  | 0140h        | 0040h |
| CS (see Table 6-27)                   | 0180h        | 0020h |
| FRAM (see Table 6-28)                 | 01A0h        | 0010h |
| CRC (see Table 6-29)                  | 01C0h        | 0008h |
| WDT (see Table 6-30)                  | 01CCh        | 0002h |
| Port P1, P2 (see Table 6-31)          | 0200h        | 0020h |
| Capacitive Touch I/O (see Table 6-32) | 02E0h        | 0010h |
| RTC (see Table 6-33)                  | 0300h        | 0010h |
| Timer0_B3 (see Table 6-34)            | 0380h        | 0030h |
| Timer1_B3 (see Table 6-35)            | 03C0h        | 0030h |
| eUSCI_A0 (see Table 6-36)             | 0500h        | 0020h |
| eUSCI_B0 (see Table 6-37)             | 0540h        | 0030h |
| Backup Memory (see Table 6-38)        | 0660h        | 0020h |
| ADC (see Table 6-39)                  | 0700h        | 0040h |
| eCOMP0 (see Table 6-40)               | 08E0h        | 0020h |
| SAC0 (see Table 6-41)                 | 0C80h        | 0010h |
| TIA0 (see Table 6-42)                 | 0F00h        | 0010h |

**Table 6-24. Special Function Registers (Base Address: 0100h)**

| REGISTER DESCRIPTION  | REGISTER | OFFSET |
|-----------------------|----------|--------|
| SFR interrupt enable  | SFRIE1   | 00h    |
| SFR interrupt flag    | SFRIFG1  | 02h    |
| SFR reset pin control | SFRRPCR  | 04h    |

**Table 6-25. PMM Registers (Base Address: 0120h)**

| REGISTER DESCRIPTION | REGISTER | OFFSET |
|----------------------|----------|--------|
| PMM control 0        | PMMCTL0  | 00h    |
| PMM control 1        | PMMCTL1  | 02h    |
| PMM control 2        | PMMCTL2  | 04h    |
| PMM interrupt flags  | PMMIFG   | 0Ah    |
| PM5 control 0        | PM5CTL0  | 10h    |

**Table 6-26. SYS Registers (Base Address: 0140h)**

| REGISTER DESCRIPTION          | REGISTER | OFFSET |
|-------------------------------|----------|--------|
| System control                | SYSCTL   | 00h    |
| Bootloader configuration area | SYSBSLC  | 02h    |
| JTAG mailbox control          | SYSJMBC  | 06h    |
| JTAG mailbox input 0          | SYSJMBI0 | 08h    |
| JTAG mailbox input 1          | SYSJMBI1 | 0Ah    |
| JTAG mailbox output 0         | SYSJMBO0 | 0Ch    |

**Table 6-26. SYS Registers (Base Address: 0140h) (continued)**

| REGISTER DESCRIPTION        | REGISTER | OFFSET |
|-----------------------------|----------|--------|
| JTAG mailbox output 1       | SYSJMBO1 | 0Eh    |
| User NMI vector generator   | SYSUNIV  | 1Ah    |
| System NMI vector generator | SYSSNIV  | 1Ch    |
| Reset vector generator      | SYSRSTIV | 1Eh    |
| System configuration 0      | SYSCFG0  | 20h    |
| System configuration 1      | SYSCFG1  | 22h    |
| System configuration 2      | SYSCFG2  | 24h    |

**Table 6-27. CS Registers (Base Address: 0180h)**

| REGISTER DESCRIPTION | REGISTER | OFFSET |
|----------------------|----------|--------|
| CS control 0         | CSCTL0   | 00h    |
| CS control 1         | CSCTL1   | 02h    |
| CS control 2         | CSCTL2   | 04h    |
| CS control 3         | CSCTL3   | 06h    |
| CS control 4         | CSCTL4   | 08h    |
| CS control 5         | CSCTL5   | 0Ah    |
| CS control 6         | CSCTL6   | 0Ch    |
| CS control 7         | CSCTL7   | 0Eh    |
| CS control 8         | CSCTL8   | 10h    |

**Table 6-28. FRAM Registers (Base Address: 01A0h)**

| REGISTER DESCRIPTION | REGISTER | OFFSET |
|----------------------|----------|--------|
| FRAM control 0       | FRCTL0   | 00h    |
| General control 0    | GCCTL0   | 04h    |
| General control 1    | GCCTL1   | 06h    |

**Table 6-29. CRC Registers (Base Address: 01C0h)**

| REGISTER DESCRIPTION          | REGISTER  | OFFSET |
|-------------------------------|-----------|--------|
| CRC data input                | CRC16DI   | 00h    |
| CRC data input reverse byte   | CRCDIRB   | 02h    |
| CRC initialization and result | CRCINIRES | 04h    |
| CRC result reverse byte       | CRCRESR   | 06h    |

**Table 6-30. WDT Registers (Base Address: 01CCh)**

| REGISTER DESCRIPTION   | REGISTER | OFFSET |
|------------------------|----------|--------|
| Watchdog timer control | WDTCTL   | 00h    |

**Table 6-31. Port P1, P2 Registers (Base Address: 0200h)**

| REGISTER DESCRIPTION          | REGISTER | OFFSET |
|-------------------------------|----------|--------|
| Port P1 input                 | P1IN     | 00h    |
| Port P1 output                | P1OUT    | 02h    |
| Port P1 direction             | P1DIR    | 04h    |
| Port P1 pulling enable        | P1REN    | 06h    |
| Port P1 selection 0           | P1SEL0   | 0Ah    |
| Port P1 selection 1           | P1SEL1   | 0Ch    |
| Port P1 interrupt vector word | P1IV     | 0Eh    |

**Table 6-31. Port P1, P2 Registers (Base Address: 0200h) (continued)**

| REGISTER DESCRIPTION          | REGISTER | OFFSET |
|-------------------------------|----------|--------|
| Port P1 complement selection  | P1SELC   | 16h    |
| Port P1 interrupt edge select | P1IES    | 18h    |
| Port P1 interrupt enable      | P1IE     | 1Ah    |
| Port P1 interrupt flag        | P1IFG    | 1Ch    |
| Port P2 input                 | P2IN     | 01h    |
| Port P2 output                | P2OUT    | 03h    |
| Port P2 direction             | P2DIR    | 05h    |
| Port P2 pulling enable        | P2REN    | 07h    |
| Port P2 selection 0           | P2SEL0   | 0Bh    |
| Port P2 selection 1           | P2SEL1   | 0Dh    |
| Port P2 complement selection  | P2SELC   | 17h    |
| Port P2 interrupt vector word | P2IV     | 1Eh    |
| Port P2 interrupt edge select | P2IES    | 19h    |
| Port P2 interrupt enable      | P2IE     | 1Bh    |
| Port P2 interrupt flag        | P2IFG    | 1Dh    |

**Table 6-32. Capacitive Touch I/O Registers (Base Address: 02E0h)**

| REGISTER DESCRIPTION           | REGISTER  | OFFSET |
|--------------------------------|-----------|--------|
| Capacitive touch I/O 0 control | CAPIO0CTL | 0Eh    |

**Table 6-33. RTC Registers (Base Address: 0300h)**

| REGISTER DESCRIPTION | REGISTER | OFFSET |
|----------------------|----------|--------|
| RTC control          | RTCCTL   | 00h    |
| RTC interrupt vector | RTCIV    | 04h    |
| RTC modulo           | RTCMOD   | 08h    |
| RTC counter          | RTCCNT   | 0Ch    |

**Table 6-34. Timer0\_B3 Registers (Base Address: 0380h)**

| REGISTER DESCRIPTION      | REGISTER | OFFSET |
|---------------------------|----------|--------|
| TB0 control               | TB0CTL   | 00h    |
| Capture/compare control 0 | TB0CCTL0 | 02h    |
| Capture/compare control 1 | TB0CCTL1 | 04h    |
| Capture/compare control 2 | TB0CCTL2 | 06h    |
| TB0 counter               | TB0R     | 10h    |
| Capture/compare 0         | TB0CCR0  | 12h    |
| Capture/compare 1         | TB0CCR1  | 14h    |
| Capture/compare 2         | TB0CCR2  | 16h    |
| TB0 expansion 0           | TB0EX0   | 20h    |
| TB0 interrupt vector      | TB0IV    | 2Eh    |

**Table 6-35. Timer1\_B3 Registers (Base Address: 03C0h)**

| REGISTER DESCRIPTION      | REGISTER | OFFSET |
|---------------------------|----------|--------|
| TB1 control               | TB1CTL   | 00h    |
| Capture/compare control 0 | TB1CCTL0 | 02h    |
| Capture/compare control 1 | TB1CCTL1 | 04h    |
| Capture/compare control 2 | TB1CCTL2 | 06h    |

**Table 6-35. Timer1\_B3 Registers (Base Address: 03C0h) (continued)**

| REGISTER DESCRIPTION | REGISTER | OFFSET |
|----------------------|----------|--------|
| TB1 counter          | TB1R     | 10h    |
| Capture/compare 0    | TB1CCR0  | 12h    |
| Capture/compare 1    | TB1CCR1  | 14h    |
| Capture/compare 2    | TB1CCR2  | 16h    |
| TB1 expansion 0      | TB1EX0   | 20h    |
| TB1 interrupt vector | TB1IV    | 2Eh    |

**Table 6-36. eUSCI\_A0 Registers (Base Address: 0500h)**

| REGISTER DESCRIPTION          | REGISTER    | OFFSET |
|-------------------------------|-------------|--------|
| eUSCI_A control word 0        | UCA0CTLW0   | 00h    |
| eUSCI_A control word 1        | UCA0CTLW1   | 02h    |
| eUSCI_A control rate 0        | UCA0BR0     | 06h    |
| eUSCI_A control rate 1        | UCA0BR1     | 07h    |
| eUSCI_A modulation control    | UCA0MCTLW   | 08h    |
| eUSCI_A status                | UCA0STAT    | 0Ah    |
| eUSCI_A receive buffer        | UCA0RXBUF   | 0Ch    |
| eUSCI_A transmit buffer       | UCA0TXBUF   | 0Eh    |
| eUSCI_A LIN control           | UCA0ABCTL   | 10h    |
| eUSCI_A IrDA transmit control | IUCA0IRTCTL | 12h    |
| eUSCI_A IrDA receive control  | IUCA0IRRCTL | 13h    |
| eUSCI_A interrupt enable      | UCA0IE      | 1Ah    |
| eUSCI_A interrupt flags       | UCA0IFG     | 1Ch    |
| eUSCI_A interrupt vector word | UCA0IV      | 1Eh    |

**Table 6-37. eUSCI\_B0 Registers (Base Address: 0540h)**

| REGISTER DESCRIPTION           | REGISTER    | OFFSET |
|--------------------------------|-------------|--------|
| eUSCI_B control word 0         | UCB0CTLW0   | 00h    |
| eUSCI_B control word 1         | UCB0CTLW1   | 02h    |
| eUSCI_B bit rate 0             | UCB0BR0     | 06h    |
| eUSCI_B bit rate 1             | UCB0BR1     | 07h    |
| eUSCI_B status word            | UCB0STATW   | 08h    |
| eUSCI_B byte counter threshold | UCB0TBCNT   | 0Ah    |
| eUSCI_B receive buffer         | UCB0RXBUF   | 0Ch    |
| eUSCI_B transmit buffer        | UCB0TXBUF   | 0Eh    |
| eUSCI_B I2C own address 0      | UCB0I2COA0  | 14h    |
| eUSCI_B I2C own address 1      | UCB0I2COA1  | 16h    |
| eUSCI_B I2C own address 2      | UCB0I2COA2  | 18h    |
| eUSCI_B I2C own address 3      | UCB0I2COA3  | 1Ah    |
| eUSCI_B receive address        | UCB0ADDRX   | 1Ch    |
| eUSCI_B address mask           | UCB0ADDMASK | 1Eh    |
| eUSCI_B I2C slave address      | UCB0I2CSA   | 20h    |
| eUSCI_B interrupt enable       | UCB0IE      | 2Ah    |
| eUSCI_B interrupt flags        | UCB0IFG     | 2Ch    |
| eUSCI_B interrupt vector word  | UCB0IV      | 2Eh    |

**Table 6-38. Backup Memory Registers (Base Address: 0660h)**

| REGISTER DESCRIPTION | REGISTER | OFFSET |
|----------------------|----------|--------|
| Backup memory 0      | BAKMEM0  | 00h    |
| Backup memory 1      | BAKMEM1  | 02h    |
| Backup memory 2      | BAKMEM2  | 04h    |
| Backup memory 3      | BAKMEM3  | 06h    |
| Backup memory 4      | BAKMEM4  | 08h    |
| Backup memory 5      | BAKMEM5  | 0Ah    |
| Backup memory 6      | BAKMEM6  | 0Ch    |
| Backup memory 7      | BAKMEM7  | 0Eh    |
| Backup memory 8      | BAKMEM8  | 10h    |
| Backup memory 9      | BAKMEM9  | 12h    |
| Backup memory 10     | BAKMEM10 | 14h    |
| Backup memory 11     | BAKMEM11 | 16h    |
| Backup memory 12     | BAKMEM12 | 18h    |
| Backup memory 13     | BAKMEM13 | 1Ah    |
| Backup memory 14     | BAKMEM14 | 1Ch    |
| Backup memory 15     | BAKMEM15 | 1Eh    |

**Table 6-39. ADC Registers (Base Address: 0700h)**

| REGISTER DESCRIPTION                 | REGISTER | OFFSET |
|--------------------------------------|----------|--------|
| ADC control 0                        | ADCCTL0  | 00h    |
| ADC control 1                        | ADCCTL1  | 02h    |
| ADC control 2                        | ADCCTL2  | 04h    |
| ADC window comparator low threshold  | ADCLO    | 06h    |
| ADC window comparator high threshold | ADCHI    | 08h    |
| ADC memory control 0                 | ADCMCTL0 | 0Ah    |
| ADC conversion memory                | ADCMEM0  | 12h    |
| ADC interrupt enable                 | ADCIE    | 1Ah    |
| ADC interrupt flags                  | ADCIFG   | 1Ch    |
| ADC interrupt vector word            | ADCIV    | 1Eh    |

**Table 6-40. eCOMP0 Registers (Base Address: 08E0h)**

| REGISTER DESCRIPTION            | REGISTER  | OFFSET |
|---------------------------------|-----------|--------|
| Comparator control 0            | CPCTL0    | 00h    |
| Comparator control 1            | CPCTL1    | 02h    |
| Comparator interrupt            | CPINT     | 06h    |
| Comparator interrupt vector     | CPIV      | 08h    |
| Comparator built-in DAC control | CPDACCTL  | 10h    |
| Comparator built-in DAC data    | CPDACDATA | 12h    |

**Table 6-41. SAC0 Registers (Base Address: 0C80h)**

| REGISTER DESCRIPTION | REGISTER | OFFSET |
|----------------------|----------|--------|
| SAC0 OA control      | SAC0OA   | 00h    |

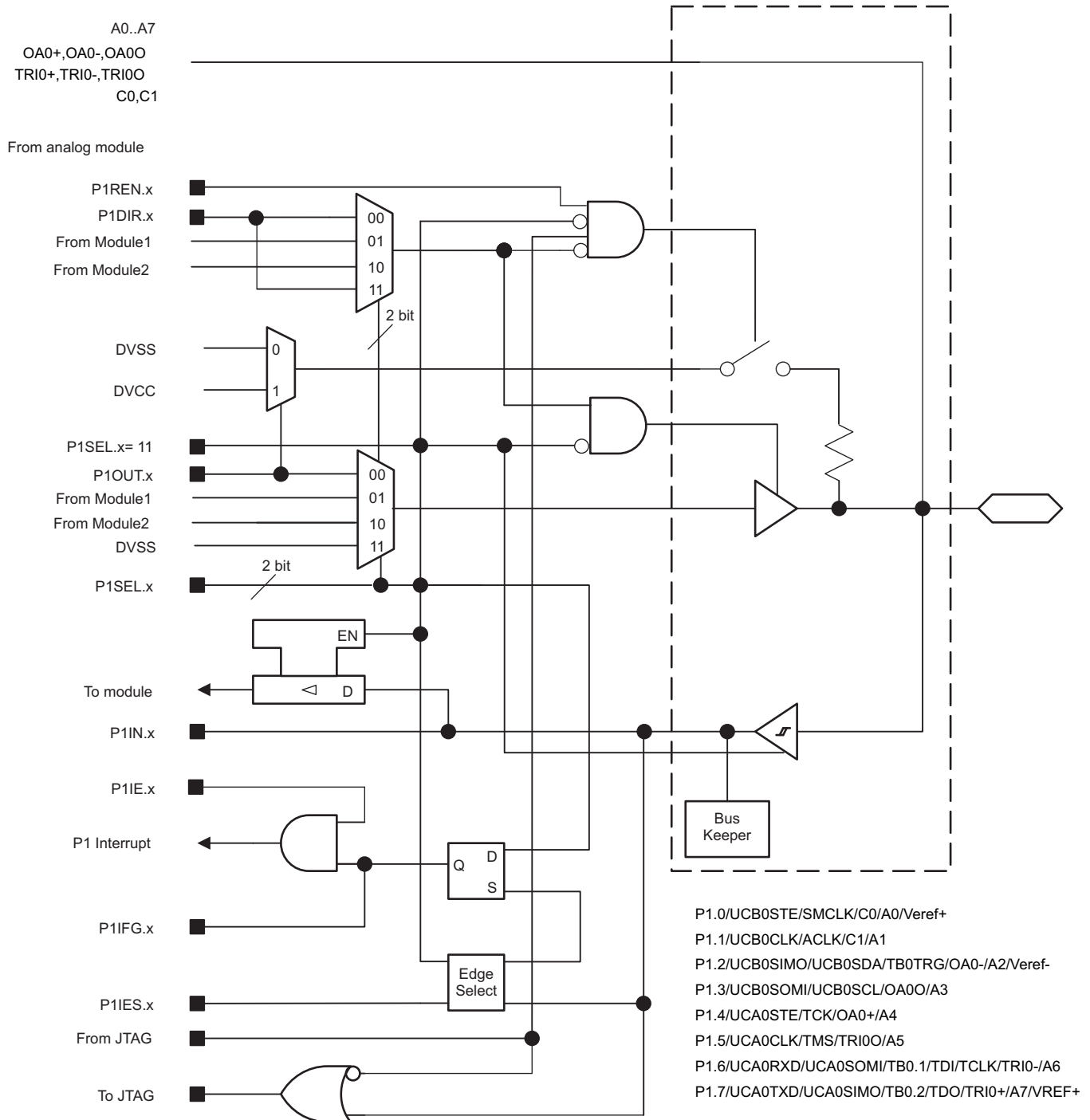
**Table 6-42. TIA0 Registers (Base Address: 0F00h)**

| REGISTER DESCRIPTION | REGISTER | OFFSET |
|----------------------|----------|--------|
| TIA control          | TRICTL   | 00h    |

## 6.12 Input/Output Diagrams

### 6.12.1 Port P1 Input/Output With Schmitt Trigger

Figure 6-5 shows the port diagram. Table 6-43 summarizes the selection of the port functions.



**Figure 6-5. Port P1 Input/Output With Schmitt Trigger**

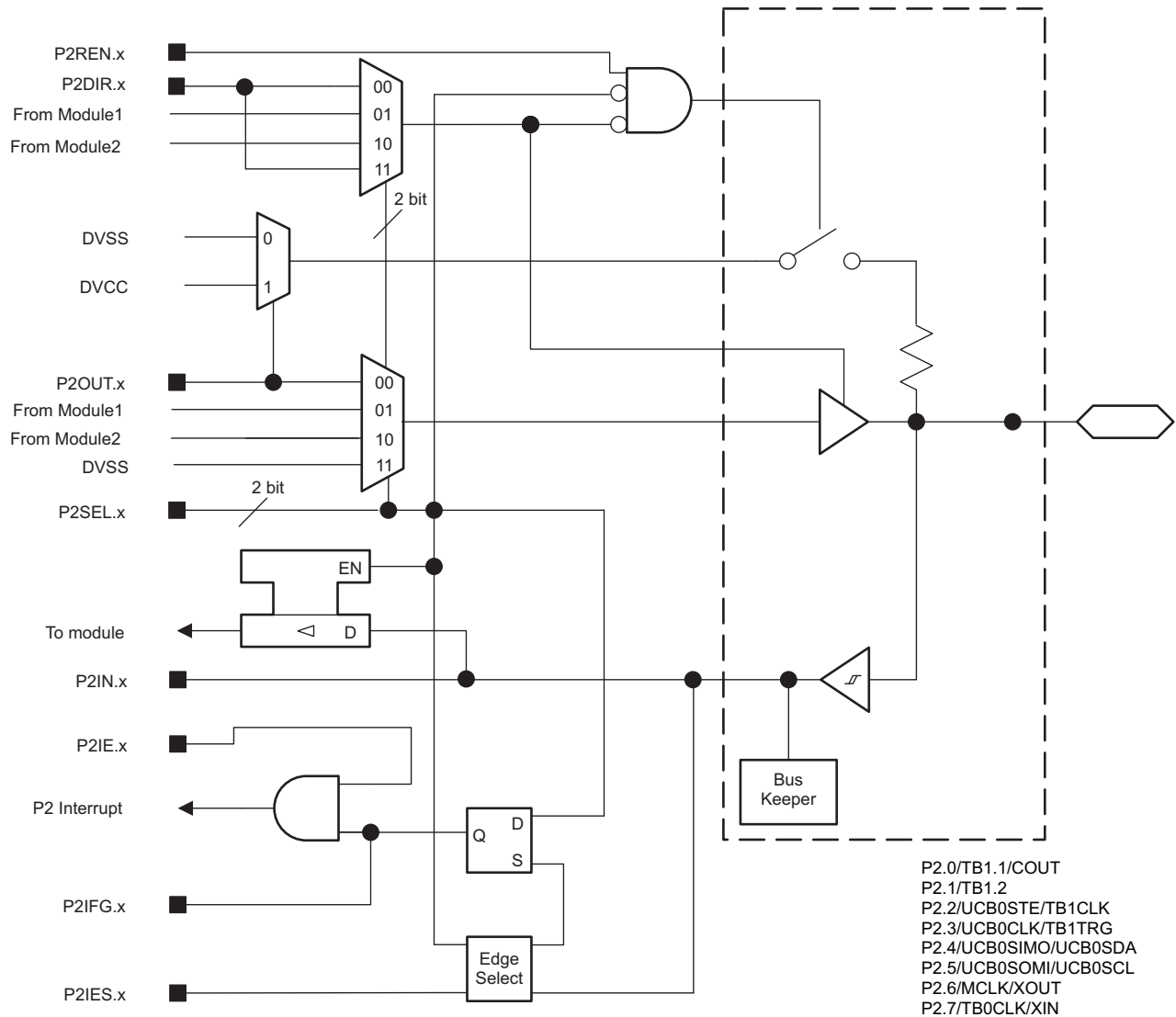
**Table 6-43. Port P1 Pin Functions**

| PIN NAME (P1.x)                                        | x | FUNCTION         | CONTROL BITS AND SIGNALS <sup>(1)</sup> |        |          |
|--------------------------------------------------------|---|------------------|-----------------------------------------|--------|----------|
|                                                        |   |                  | P1DIR.x                                 | P1SELx | JTAG     |
| P1.0/UCB0STE/SMCLK/<br>C0/A0/Veref+                    | 0 | P1.0 (I/O)       | I: 0; O: 1                              | 00     | N/A      |
|                                                        |   | UCB0STE          | X                                       | 01     | N/A      |
|                                                        |   | SMCLK            | 1                                       | 10     | N/A      |
|                                                        |   | VSS              | 0                                       |        |          |
|                                                        |   | C0, A0/Veref+    | X                                       | 11     | N/A      |
| P1.1/UCB0CLK/ACLK/<br>C1A1                             | 1 | P1.1 (I/O)       | I: 0; O: 1                              | 0      | N/A      |
|                                                        |   | UCB0CLK          | X                                       | 01     | N/A      |
|                                                        |   | ACLK             | 1                                       | 10     | N/A      |
|                                                        |   | VSS              | 0                                       |        |          |
|                                                        |   | C1, A1           | X                                       | 11     | N/A      |
| P1.2/UCB0SIMO/<br>UCB0SDA/TB0TRG/<br>OA0-/A2/Veref-    | 2 | P1.2 (I/O)       | I: 0; O: 1                              | 00     | N/A      |
|                                                        |   | UCB0SIMO/UCB0SDA | X                                       | 01     | N/A      |
|                                                        |   | TB0TRG           | 0                                       | 10     | N/A      |
|                                                        |   | OA0-, A2/Veref-  | X                                       | 11     | N/A      |
| P1.3/UCB0SOMI/<br>UCB0SCL/OA0O/A3                      | 3 | P1.3 (I/O)       | I: 0; O: 1                              | 00     | N/A      |
|                                                        |   | UCB0SOMI/UCB0SCL | X                                       | 01     | N/A      |
|                                                        |   | OA0O, A3         | X                                       | 11     | N/A      |
| P1.4/UCA0STE/TCK/<br>OA0+/A4                           | 4 | P1.4 (I/O)       | I: 0; O: 1                              | 00     | Disabled |
|                                                        |   | UCA0STE          | X                                       | 01     | Disabled |
|                                                        |   | OA0+, A4         | X                                       | 11     | Disabled |
|                                                        |   | JTAG TCK         | X                                       | X      | TCK      |
| P1.5/UCA0CLK/TMS/<br>TRI0O/A5                          | 5 | P1.5 (I/O)       | I: 0; O: 1                              | 00     | Disabled |
|                                                        |   | UCA0CLK          | X                                       | 01     | Disabled |
|                                                        |   | TRI0O, A5        | X                                       | 11     | Disabled |
|                                                        |   | JTAG TMS         | X                                       | X      | TMS      |
| P1.6/UCA0RXD/<br>UCA0SOMI/TB0.1/TDI/<br>TCLK/TRI0-/A6  | 6 | P1.6 (I/O)       | I: 0; O: 1                              | 00     | Disabled |
|                                                        |   | UCA0RXD/UCA0SOMI | X                                       | 01     | Disabled |
|                                                        |   | TB0.CCI1A        | 0                                       | 10     | Disabled |
|                                                        |   | TB0.1            | 1                                       |        |          |
|                                                        |   | TRI0-, A6        | X                                       | 11     | Disabled |
|                                                        |   | JTAG TDI/TCLK    | X                                       | X      | TDI/TCLK |
| P1.7/UCA0TXD/<br>UCA0SIMO/TB0.2/TDO/<br>TRI0+/A7/VREF+ | 7 | P1.7 (I/O)       | I: 0; O: 1                              | 00     | Disabled |
|                                                        |   | UCA0TXD/UCA0SIMO | X                                       | 01     | Disabled |
|                                                        |   | TB0.CCI2A        | 0                                       | 10     | Disabled |
|                                                        |   | TB0.2            | 1                                       |        |          |
|                                                        |   | TRI0+, A7, VREF+ | X                                       | 11     | Disabled |
|                                                        |   | JTAG TDO         | X                                       | X      | TDO      |

(1) X = don't care

### 6.12.2 Port P2 Input/Output With Schmitt Trigger

Figure 6-6 shows the port diagram. Table 6-44 summarizes the selection of the port functions.



NOTE: Functional representation only.

**Figure 6-6. Port P2 Input/Output With Schmitt Trigger**

**Table 6-44. Port P2 Pin Functions**

| PIN NAME (P2.x)             | x | FUNCTION         | CONTROL BITS AND SIGNALS <sup>(1)</sup> |        |
|-----------------------------|---|------------------|-----------------------------------------|--------|
|                             |   |                  | P2DIR.x                                 | P2SELx |
| P2.0/TB1.1/COU <sup>T</sup> | 0 | P2.0 (I/O)       | I: 0; O: 1                              | 00     |
|                             |   | TB1.CCI1A        | 0                                       | 01     |
|                             |   | TB1.1            | 1                                       |        |
|                             |   | COU <sup>T</sup> | 1                                       | 10     |
| P2.1/TB1.2                  | 1 | P2.1 (I/O)0      | I: 0; O: 1                              | 00     |
|                             |   | TB1.CCI2A        | 0                                       | 01     |
|                             |   | TB1.2            | 1                                       |        |
| P2.2/UCB0STE/TB1CLK         | 2 | P2.2 (I/O)       | I: 0; O: 1                              | 00     |
|                             |   | UCB0STE          | X                                       | 01     |
|                             |   | TB1CLK           | 0                                       | 10     |
|                             |   | VSS              | 1                                       |        |
| P2.3/UCB0CLK/TB1TRG         | 3 | P2.3 (I/O)       | I: 0; O: 1                              | 00     |
|                             |   | UCB0CLK          | X                                       | 01     |
|                             |   | TB1TRG           | 0                                       | 10     |
| P2.4/UCB0SIMO/UCB0SDA       | 4 | P2.4 (I/O)       | I: 0; O: 1                              | 00     |
|                             |   | UCB0SIMO/UCB0SDA | X                                       | 01     |
| P2.5/UCB0SOMI/UCB0SCL       | 5 | P2.5 (I/O)       | I: 0; O: 1                              | 00     |
|                             |   | UCB0SOMI/UCB0SCL | X                                       | 01     |
| P2.6/MCLK/XOU <sup>T</sup>  | 6 | P2.6 (I/O)       | I: 0; O: 1                              | 00     |
|                             |   | MCLK             | 1                                       | 01     |
|                             |   | VSS              | 0                                       |        |
|                             |   | XOU <sup>T</sup> | X                                       | 10     |
| P2.7/TB0CLK/XIN             | 7 | P2.7 (I/O)       | I: 0; O: 1                              | 00     |
|                             |   | TB0CLK           | 0                                       | 01     |
|                             |   | VSS              | 1                                       |        |
|                             |   | XIN              | X                                       | 10     |

(1) X = don't care

## 6.13 Device Descriptors (TLV)

Table 6-45 lists the Device IDs of the MSP430FR231x MCU variants. Table 6-46 lists the contents of the device descriptor tag-length-value (TLV) structure for the devices.

**Table 6-45. Device IDs**

| DEVICE       | DEVICE ID |       |
|--------------|-----------|-------|
|              | 1A04h     | 1A05h |
| MSP430FR2311 | F0        | 82    |
| MSP430FR2310 | F1        | 82    |

**Table 6-46. Device Descriptors**

| DESCRIPTION     |                                                      | MSP430FR231x |                 |
|-----------------|------------------------------------------------------|--------------|-----------------|
|                 |                                                      | ADDRESS      | VALUE           |
| Info block      | Info length                                          | 1A00h        | 06h             |
|                 | CRC length                                           | 1A01h        | 06h             |
|                 | CRC value <sup>(1)</sup>                             | 1A02h        | Per unit        |
|                 |                                                      | 1A03h        | Per unit        |
|                 | Device ID                                            | 1A04h        | See Table 6-45. |
|                 |                                                      | 1A05h        |                 |
|                 | Hardware revision                                    | 1A06h        | Per unit        |
|                 | Firmware revision                                    | 1A07h        | Per unit        |
| Die record      | Die record tag                                       | 1A08h        | 08h             |
|                 | Die record length                                    | 1A09h        | 0Ah             |
|                 | Lot wafer ID                                         | 1A0Ah        | Per unit        |
|                 |                                                      | 1A0Bh        | Per unit        |
|                 |                                                      | 1A0Ch        | Per unit        |
|                 |                                                      | 1A0Dh        | Per unit        |
|                 | Die X position                                       | 1A0Eh        | Per unit        |
|                 |                                                      | 1A0Fh        | Per unit        |
|                 | Die Y position                                       | 1A10h        | Per unit        |
|                 |                                                      | 1A11h        | Per unit        |
| ADC calibration | Test result                                          | 1A12h        | Per unit        |
|                 |                                                      | 1A13h        | Per unit        |
|                 | ADC calibration tag                                  | 1A14h        | Per unit        |
|                 | ADC calibration length                               | 1A15h        | Per unit        |
|                 | ADC gain factor                                      | 1A16h        | Per unit        |
|                 |                                                      | 1A17h        | Per unit        |
|                 | ADC offset                                           | 1A18h        | Per unit        |
|                 |                                                      | 1A19h        | Per unit        |
|                 | ADC 1.5-V reference, temperature 30°C <sup>(2)</sup> | 1A1Ah        | Per unit        |
|                 |                                                      | 1A1Bh        | Per unit        |
|                 | ADC 1.5-V reference, temperature 85°C <sup>(2)</sup> | 1A1Ch        | Per unit        |
|                 |                                                      | 1A1Dh        | Per unit        |

(1) The CRC value covers the checksum from 0x1A04h to 0x1A77h by applying CRC-CCITT-16 polynomial of  $X^{16} + X^{12} + X^5 + 1$

(2) TI recommends to do a two-point calibration for the on-chip temperature sensor in precision application.

**Table 6-46. Device Descriptors (continued)**

| DESCRIPTION                   |                                                              | MSP430FR231x |          |
|-------------------------------|--------------------------------------------------------------|--------------|----------|
|                               |                                                              | ADDRESS      | VALUE    |
| Reference and DCO calibration | Calibration tag                                              | 1A1Eh        | 12h      |
|                               | Calibration length                                           | 1A1Fh        | 04h      |
|                               | 1.5-V reference factor                                       | 1A20h        | Per unit |
|                               |                                                              | 1A21h        | Per unit |
|                               | DCO tap settings for 16 MHz, temperature 30°C <sup>(3)</sup> | 1A22h        | Per unit |
|                               |                                                              | 1A23h        | Per unit |

(3) This value can be directly loaded into the DCO bits in the CSCTL0 register to get an accurate 16-MHz frequency at room temperature, especially when MCU exits from LPM3 and below. TI also suggests using a predivider to decrease the frequency if the temperature drift might result an overshoot above 16 MHz.

## 6.14 Identification

### 6.14.1 Revision Identification

The device revision information is shown as part of the top-side marking on the device package. The device-specific errata sheet describes these markings. For links to all of the errata sheets for the devices in this data sheet, see [8.4](#).

The hardware revision is also stored in the Device Descriptor structure in the Info Block section. For details on this value, see the "Hardware Revision" entries in [Section 6.13](#).

### 6.14.2 Device Identification

The device type can be identified from the top-side marking on the device package. The device-specific errata sheet describes these markings. For links to all of the errata sheets for the devices in this data sheet, see [8.4](#).

A device identification value is also stored in the Device Descriptor structure in the Info Block section. For details on this value, see the "Device ID" entries in [Section 6.13](#).

### 6.14.3 JTAG Identification

Programming through the JTAG interface, including reading and identifying the JTAG ID, is described in detail in the [MSP430 Programming With the JTAG Interface](#).

## 7 Applications, Implementation, and Layout

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their implementation to confirm system functionality.

### 7.1 Device Connection and Layout Fundamentals

This section describes the recommended guidelines when designing with the MSP430. These guidelines are to make sure that the device has proper connections for powering, programming, debugging, and optimum analog performance.

#### 7.1.1 Power Supply Decoupling and Bulk Capacitors

TI recommends connecting a combination of a 10- $\mu$ F capacitor and a 100-nF low-ESR ceramic decoupling capacitor to the DVCC pin. Higher-value capacitors may be used but can affect supply rail ramp-up time. Decoupling capacitors must be placed as close as possible to the pins that they decouple (within a few millimeters).

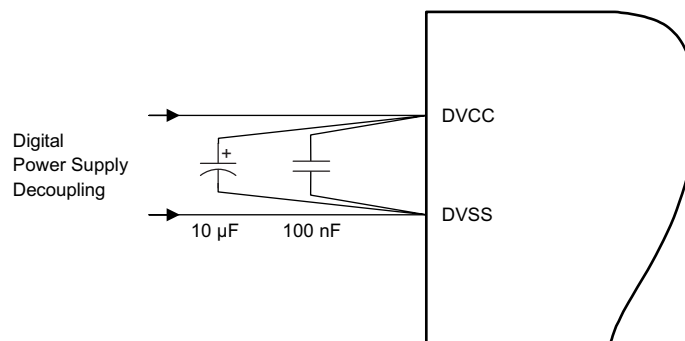


Figure 7-1. Power Supply Decoupling

#### 7.1.2 External Oscillator

Depending on the device variant (see [Table 3-1](#)), the device can support a low-frequency crystal (32 kHz) on the LFXT pins, a high-frequency crystal on the HFXT pins, or both. External bypass capacitors for the crystal oscillator pins are required.

It is also possible to apply digital clock signals to the LFXIN and HFXIN input pins that meet the specifications of the respective oscillator if the appropriate LFXTBYPASS or HFXTBYPASS mode is selected. In this case, the associated LFXOUT and HFXOUT pins can be used for other purposes. If the LFXOUT and HFXOUT pins are left unused, they must be terminated according to [Section 4.6](#).

[Figure 7-2](#) shows a typical connection diagram.

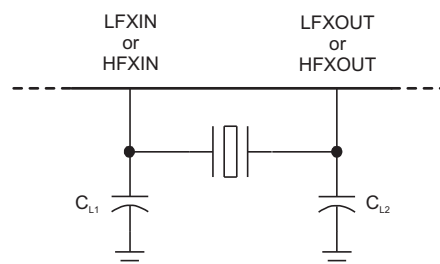


Figure 7-2. Typical Crystal Connection

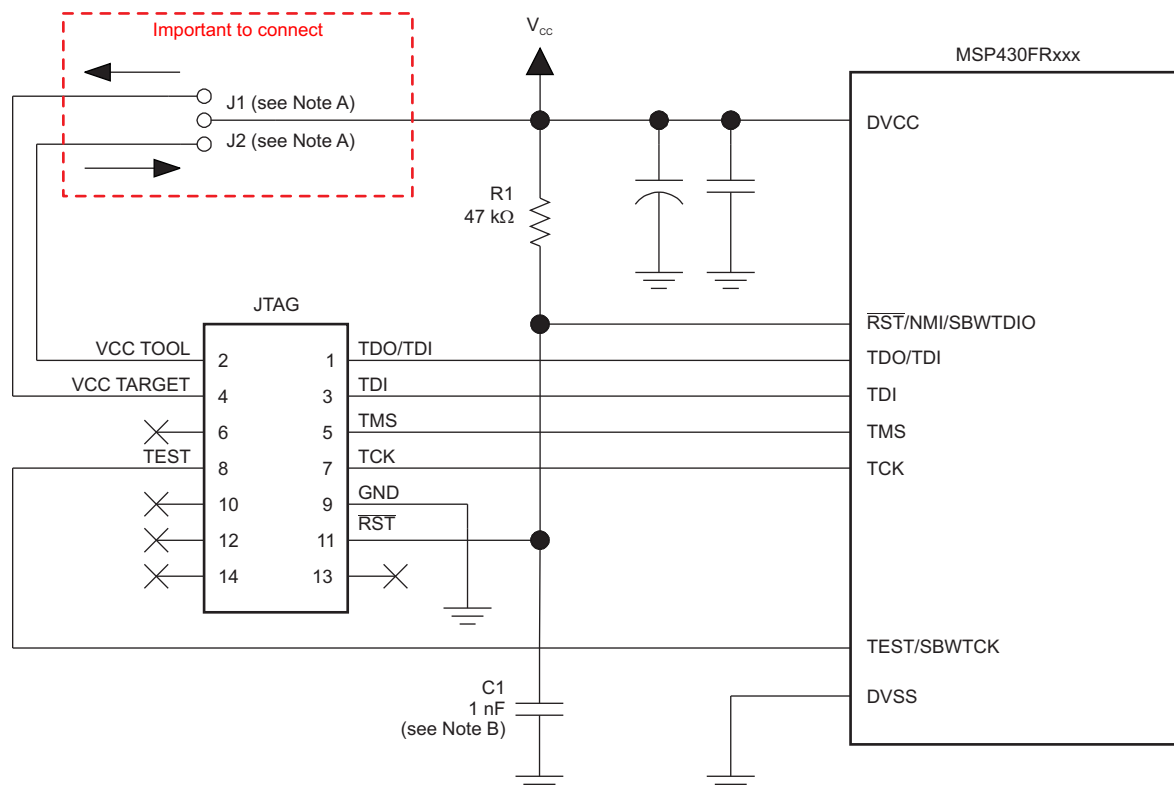
See [MSP430 32-kHz Crystal Oscillators](#) for more information on selecting, testing, and designing a crystal oscillator with the MSP430 devices.

### 7.1.3 JTAG

With the proper connections, the debugger and a hardware JTAG interface (such as the MSP-FET or MSP-FET430UIF) can be used to program and debug code on the target board. In addition, the connections also support the MSP-GANG production programmers, thus providing an easy way to program prototype boards, if desired. [Figure 7-3](#) shows the connections between the 14-pin JTAG connector and the target device required to support in-system programming and debugging for 4-wire JTAG communication. [Figure 7-4](#) shows the connections for 2-wire JTAG mode (Spy-Bi-Wire).

The connections for the MSP-FET and MSP-FET430UIF interface modules and the MSP-GANG are identical. Both can supply  $V_{CC}$  to the target board (through pin 2). In addition, the MSP-FET and MSP-FET430UIF interface modules and MSP-GANG have a  $V_{CC}$  sense feature that, if used, requires an alternate connection (pin 4 instead of pin 2). The  $V_{CC}$ -sense feature detects the local  $V_{CC}$  present on the target board (that is, a battery or other local power supply) and adjusts the output signals accordingly. [Figure 7-3](#) and [Figure 7-4](#) show a jumper block that supports both scenarios of supplying  $V_{CC}$  to the target board. If this flexibility is not required, the desired  $V_{CC}$  connections may be hardwired to eliminate the jumper block. Pins 2 and 4 must not be connected at the same time.

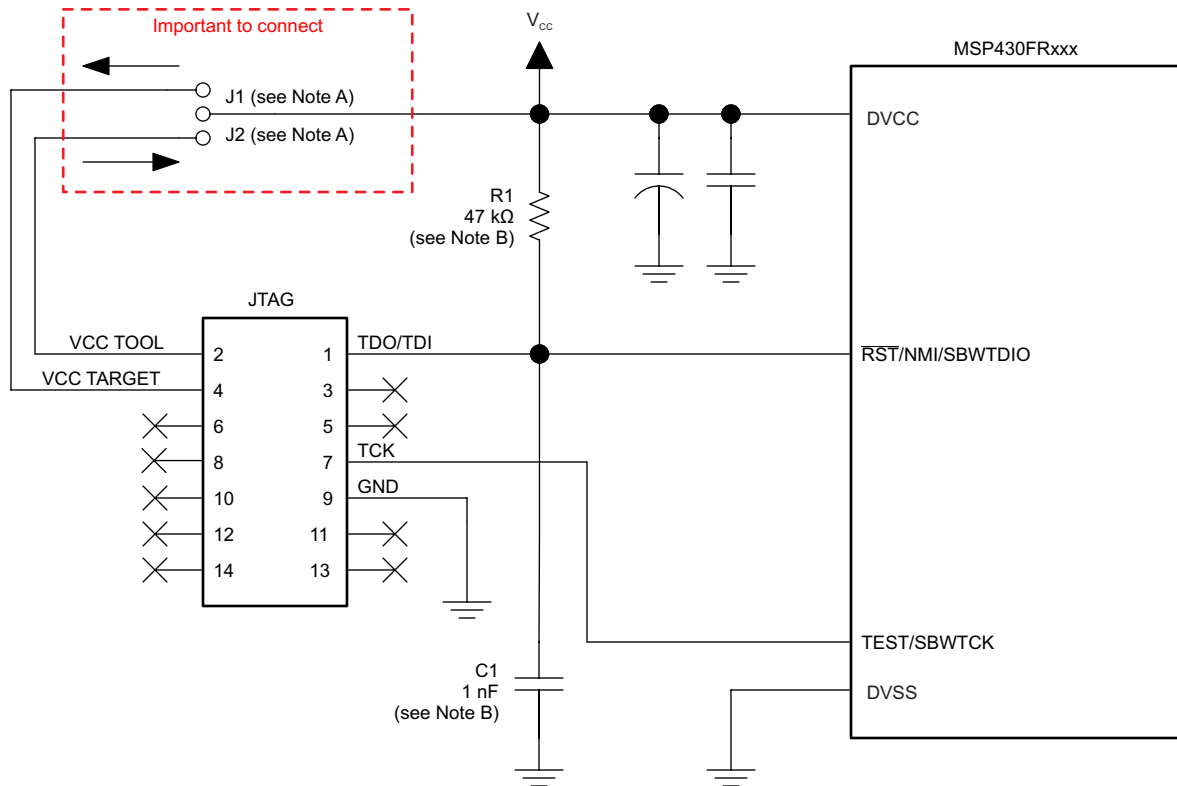
For additional design information regarding the JTAG interface, see the [MSP430 Hardware Tools User's Guide](#).



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- If a local target power supply is used, make connection J1. If power from the debug or programming adapter is used, make connection J2.
- The upper limit for C1 is 1.1 nF when using TI tools. TI recommends a 1-nF capacitor to enable high-speed SBW communication.

**Figure 7-3. Signal Connections for 4-Wire JTAG Communication**



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- Make connection J1 if a local target power supply is used, or make connection J2 if the target is powered from the debug or programming adapter.
- The device  $\overline{\text{RST}}/\text{NMI}/\text{SBWDIO}$  pin is used in 2-wire mode for bidirectional communication with the device during JTAG access, and any capacitance that is attached to this signal may affect the ability to establish a connection with the device. The upper limit for C1 is 1.1 nF when using TI tools. TI recommends a 1-nF capacitor to enable high-speed SBW communication.

**Figure 7-4. Signal Connections for 2-Wire JTAG Communication (Spy-Bi-Wire)**

### 7.1.4 Reset

The reset pin can be configured as a reset function (default) or as an NMI function in the Special Function Register (SFR), SFRRPCR.

In reset mode, the  $\overline{\text{RST}}/\text{NMI}$  pin is active low, and a pulse applied to this pin that meets the reset timing specifications generates a BOR-type device reset.

Setting SYSNMI causes the  $\overline{\text{RST}}/\text{NMI}$  pin to be configured as an external NMI source. The external NMI is edge sensitive, and its edge is selectable by SYSNMIIES. Setting the NMIIE enables the interrupt of the external NMI. When an external NMI event occurs, the NMIFG is set.

The  $\overline{\text{RST}}/\text{NMI}$  pin can have either a pullup or pulldown that is enabled or not. SYSRSTUP selects either pullup or pulldown, and SYSRSTRE causes the pullup (default) or pulldown to be enabled (default) or not. If the  $\overline{\text{RST}}/\text{NMI}$  pin is unused, it is required either to select and enable the internal pullup or to connect an external 47-kΩ pullup resistor to the  $\overline{\text{RST}}/\text{NMI}$  pin with a 10-nF pulldown capacitor. The pulldown capacitor should not exceed 1.1 nF when using devices with Spy-Bi-Wire interface in Spy-Bi-Wire mode or in 4-wire JTAG mode with TI tools like FET interfaces or GANG programmers.

See the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#) for more information on the referenced control registers and bits.

### 7.1.5 Unused Pins

For details on the connection of unused pins, see [Section 4.6](#).

### 7.1.6 General Layout Recommendations

- Proper grounding and short traces for external crystal to reduce parasitic capacitance. See [MSP430 32-kHz Crystal Oscillators](#) for recommended layout guidelines.
- Proper bypass capacitors on DVCC, AVCC, and reference pins if used.
- Avoid routing any high-frequency signal close to an analog signal line. For example, keep digital switching signals such as PWM or JTAG signals away from the oscillator circuit and ADC signals.
- Proper ESD level protection should be considered to protect the device from unintended high-voltage electrostatic discharge. See [MSP430 System-Level ESD Considerations](#) for guidelines.

### 7.1.7 Do's and Don'ts

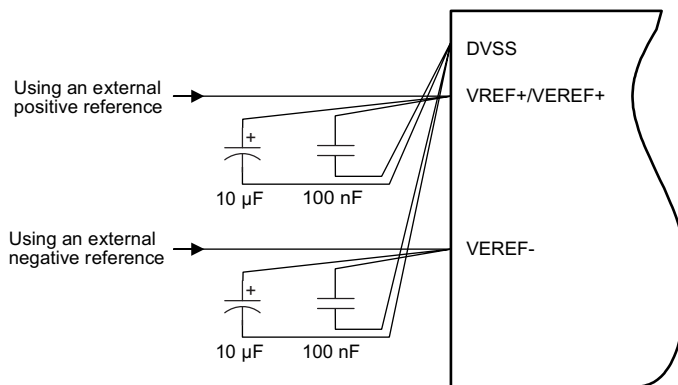
During power up, power down, and device operation, the voltage difference between AVCC and DVCC must not exceed the limits specified in the [Absolute Maximum Ratings](#) section. Exceeding the specified limits may cause malfunction of the device including erroneous writes to RAM and FRAM.

## 7.2 Peripheral- and Interface-Specific Design Information

### 7.2.1 ADC Peripheral

#### 7.2.1.1 Partial Schematic

Figure 7-5 shows the recommended decoupling circuit when an external voltage reference is used.



**Figure 7-5. ADC Grounding and Noise Considerations**

#### 7.2.1.2 Design Requirements

As with any high-resolution ADC, appropriate printed-circuit-board layout and grounding techniques should be followed to eliminate ground loops, unwanted parasitic effects, and noise.

Ground loops are formed when return current from the ADC flows through paths that are common with other analog or digital circuitry. If care is not taken, this current can generate small unwanted offset voltages that can add to or subtract from the reference or input voltages of the ADC. The general guidelines in [Section 7.1.1](#) combined with the connections shown in [Figure 7-5](#) prevent this.

In addition to grounding, ripple and noise spikes on the power-supply lines that are caused by digital switching or switching power supplies can corrupt the conversion result. TI recommends a noise-free design using separate analog and digital ground planes with a single-point connection to achieve high accuracy.

[Figure 7-5](#) shows the recommended decoupling circuit when an external voltage reference is used. The internal reference module has a maximum drive current as described in the sections *ADC Pin Enable* and *1.2-V Reference Settings* of the [MSP430FR4xx and MSP430FR2xx Family User's Guide](#).

The reference voltage must be a stable voltage for accurate measurements. The capacitor values that are selected in the general guidelines filter out the high- and low-frequency ripple before the reference voltage enters the device. In this case, the 10- $\mu$ F capacitor buffers the reference pin and filters any low-frequency ripple. A bypass capacitor of 100 nF filters out any high-frequency noise.

### 7.2.1.3 Layout Guidelines

Components that are shown in the partial schematic (see [Figure 7-5](#)) should be placed as close as possible to the respective device pins to avoid long traces, because they add additional parasitic capacitance, inductance, and resistance on the signal.

Avoid routing analog input signals close to a high-frequency pin (for example, a high-frequency PWM), because the high-frequency switching can be coupled into the analog signal.

## 7.3 Typical Applications

[Table 7-1](#) provides a link to a LaunchPad™ development kit. For the most up-to-date list of available tools and TI Designs, see the device-specific product folders listed in [8.5](#).

**Table 7-1. Tools**

| NAME                                   | LINK                                                                                          |
|----------------------------------------|-----------------------------------------------------------------------------------------------|
| MSP430FR2311 LaunchPad Development Kit | <a href="http://www.ti.com/tool/MSP-EXP430FR2311">http://www.ti.com/tool/MSP-EXP430FR2311</a> |

## 8 デバイスおよびドキュメントのサポート

### 8.1 はじめに

MSP430™ファミリのデバイス、および開発に役立つツールやライブラリの詳細については、「[MSP430™ 超低消費電力センシング / 測定マイコン](#)」の概要ページを参照してください。

### 8.2 デバイスの項目表記

製品開発サイクルの段階を示すために、TIではMSP MCUデバイスのすべての型番に接頭辞が割り当てられています。MSP MCU商用ファミリの各番号には、MSP、XMSのいずれかの接頭辞があります。これらの接頭辞は、製品開発の進展段階を表します。段階には、エンジニアリング・プロトタイプ(XMS)から、完全認定済みの量産デバイス(MSP)までがあります。

**XMS** - 実験段階のデバイスで、最終的なデバイスの電氣的仕様を表しているとは限りません。

**MSP** - 完全に認定済みの量産版デバイスです。

XMSデバイスは、次の免責事項付きで出荷されます。

「開発中の製品は、社内での評価用です。」

MSPデバイスの特性は完全に明確化されており、デバイスの品質と信頼性が十分に示されています。TIの標準保証が適用されます。

プロトタイプ・デバイス(XMS)は標準の量産デバイスよりも故障率が高いことが予想されます。これらのデバイスは、予測される最終使用時の故障率が未定義であるため、TIはそれらのデバイスを量産システムで使用しないよう推奨しています。認定された量産デバイスのみを使用する必要があります。

TIデバイスの項目表記には、デバイス・ファミリ名の接尾辞も含まれます。この接尾辞は、温度範囲、パッケージ・タイプ、配布形式を示しています。デバイス名の各部の読み方を図 8-1 に示します。

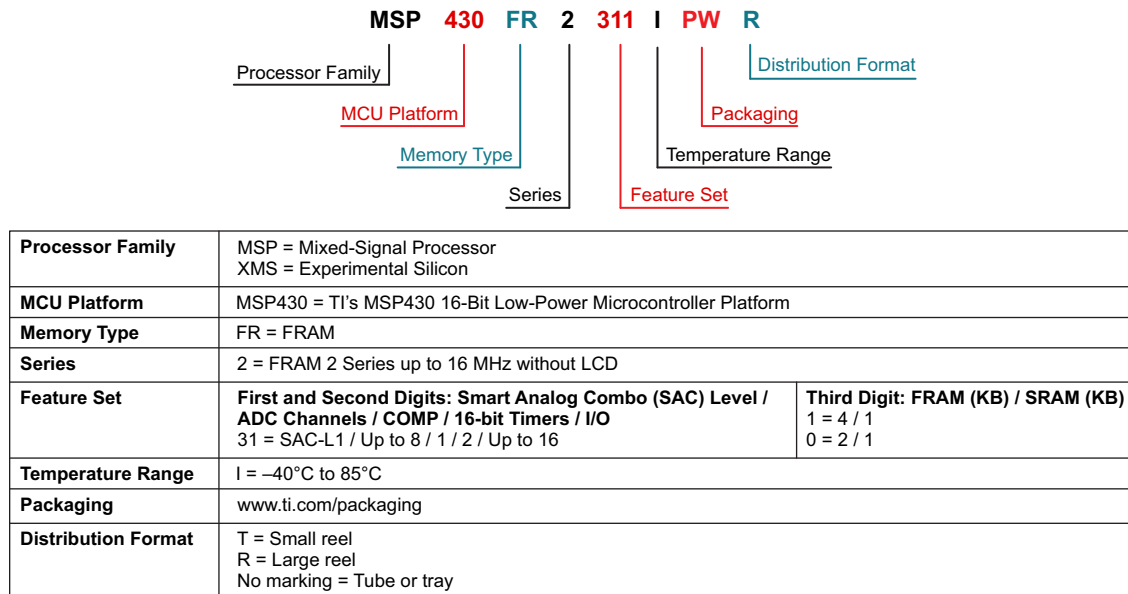


図 8-1. デバイスの項目表記

### 8.3 ツールとソフトウェア

表 8-1 は、これらのマイクロコントローラでサポートされるデバッグ機能の一覧です。利用可能な機能の詳細については、『Code Composer Studio™ v5.2 ユーザーズ・ガイド MSP430™ 版ユーザーズ・ガイド』を参照してください。

表 8-1. ハードウェアの特長

| MSP430のアーキテクチャ | 4線式JTAG | 2線式JTAG | ブレーク・ポイント (N) | 範囲ブレーク・ポイント | クロック制御 | 状態シーケンサ | トレース・バッファ | LPMx.5デバッグ・サポート | EEMのバージョン |
|----------------|---------|---------|---------------|-------------|--------|---------|-----------|-----------------|-----------|
| MSP430Xv2      | ○       | ○       | 3             | ○           | ○      | ×       | ×         | ×               | S         |

#### 設計キットと評価基板

##### MSP430FR2311 LaunchPad開発キット

MSP-EXP430FR2311 LaunchPad開発キットは、MSP430FR2311 MCU用の使いやすいマイクロコントローラ開発ボードです。プログラミング、デバッグ、電力測定を行うためのオンボード・エミュレーションなど、MSP430FR2x FRAMプラットフォームの迅速な開発に必要なすべての機能を備えています。

##### MSP-FET+MSP-TS430PW20 FRAMマイクロコントローラ開発キット・バンドル

MSP-FET430U20バンドルは、2つのデバッグ・ツールを組み合わせたもので、MSP430FR23xマイクロコントローラ用の20ピンPWパッケージ(MSP430FR2311PW20など)をサポートしています。これら2つのツールには、MSP-TS430PW20とMSP-FETが含まれています。

##### MSP430FR2x MCU用MSP-TS430PW20 20ピン・ターゲット開発ボード

MSP-TS430PW20 はスタンドアロンの ZIF ソケット・ターゲット・ボードで、JTAG インターフェイスまたは Spy-Bi-Wire (2線式の JTAG) プロトコルによるシステム内の MSP430 MCU のプログラムとデバッグに使用されます。この開発ボードは、20 ピンまたは 16 ピンの TSSOP パッケージ (TI パッケージ・コード:PW) に封止された MSP430FR23x および MSP430FR21x のフラッシュ部品をすべてサポートしています。

#### ソフトウェア

##### MSP430Ware™ソフトウェア

MSP430Wareソフトウェアは、すべてのMSP430デバイス向けのサンプル・コード、データシート、その他の設計リソースを、1つの便利なパッケージとしてまとめたものです。既存のMSP430用設計リソースの完全なコレクションに加えて、MSP430WareソフトウェアにはMSP430ドライバ・ライブラリという高レベルのAPIも含まれています。このライブラリにより、MSP430ハードウェアを簡単にプログラムできます。MSP430WareソフトウェアはCCSのコンポーネントとして、またはスタンドアロンのパッケージとして入手できます。

##### MSP430FR231xのサンプル・コード

すべてのMSPデバイス用に、内蔵の各ペリフェラルをさまざまなアプリケーションの要求に応じて構成するためのCコード・サンプルが用意されています。

##### MSP ドライバ・ライブラリ

MSPドライバ・ライブラリの抽象化されたAPIには、使いやすい関数呼び出しが含まれているため、MSP430ハードウェアのビットやバイトを直接操作する煩雑さから解放されます。使いやすいAPIガイドにより包括的な技術資料が参照でき、それぞれの関数呼び出しと、認識されるパラメータの詳細が記載されています。開発者は、ドライバ・ライブラリの関数を使用して、最小限のオーバーヘッドで完全なプロジェクトを作成できます。

##### MSP EnergyTrace™ テクノロジー

MSP430 マイコン向け EnergyTrace テクノロジーはエネルギー・ベースのコード分析ツールで、アプリケーションのエネルギー・プロファイルの測定と表示を行うとともに、消費電力の大幅な低減のための最適化も可能です。

## ULP (超低消費電力) Advisor

ULP Advisor™ソフトウェアは、MSPおよびMSP432マイクロコントローラの超低消費電力機能を十分に活用できる、最も効率的なコードを開発者が作成できるよう手引きするツールです。ULP Advisorはマイクロコントローラに熟練した開発者と、新しい開発者の両方を対象としており、包括的なULPチェックリストを使用してコードをチェックし、アプリケーションのエネルギー消費を最小化するため役立ちます。ビルド時に、消費電力低減のためさらに最適化が可能なコードの部分を明らかにするため通知と注釈を出力します。

## MSP超低消費電力マイクロコントローラ用FRAM組み込みソフトウェア・ユーティリティ

FRAMユーティリティは、組み込みソフトウェア・ユーティリティのコレクションとして成長するように設計されており、超低消費電力とはほぼ無限の書き込み耐性というFRAMの特長を活用できます。このユーティリティはMSP430FRxx FRAMマイクロコントローラで利用でき、アプリケーション開発に役立つサンプル・コードを提供します。搭載されているユーティリティには、Compute Through Power Loss (CTPL)があります。CTPLはユーティリティAPIセットで、LPMx.5低消費電力モードにより使いやすさを実現する一方、強力なシャットダウン・モードにより、停電検出時にアプリケーションが重要なシステム・コンポーネントを保存・復元できます。

## IEC60730 ソフトウェア・パッケージ

IEC60730 MSP430ソフトウェア・パッケージは、クラスBまでの製品について、お客様がIEC 60730-1:2010 (家庭および同様な用途に使用される自動電気制御 – 第1部: 一般的な要件)に準拠するため役立つよう開発されています。この分類には家電機器、アーク検出器、電力コンバータ、電動工具、電動アシスト自転車、その他多くの製品が含まれます。IEC60730 MSP430 ソフトウェア・パッケージはMSP430 MCUで実行するお客様のアプリケーションに組み込むことができるため、消費者向けデバイスがIEC 60730-1:2010クラスBの機能安全性に準拠していることの認定作業を簡素化できます。

## MSP 用の固定小数点算術ライブラリ

MSP IQmathおよびQmathライブラリは、Cプログラマ向けの高度に最適化された高精度の算術関数のコレクションで、浮動小数点アルゴリズムをMSP430およびMSP432デバイスの固定小数点コードへシームレスに移行できます。これらのルーチンは通常、最適な実行速度、高精度、超低消費電力が重視される、演算集中型のリアルタイム・アプリケーションで使用されます。IQmathライブラリとQmathライブラリを使用すると、浮動小数点演算を使用して記述した同等のコードに比べて、実行速度を大幅に高速化するとともに、消費電力の大幅な削減が可能です。

## MSP430用の浮動小数点算術ライブラリ

低消費電力で低コストのマイクロコントローラ分野にさらなる革新を引き起こすため、TIはMSPMATHLIBを提供します。この浮動小数点算術ライブラリは、弊社デバイスのインテリジェントなペリフェラルを活用し、標準のMSP430算術関数よりも最高で26倍も高速なスカラ関数です。Mathlibは、設計へ簡単に組み入れることができます。このライブラリは無償で、Code Composer Studio IDEとIAR Embedded Workbench IDEの両方に組み込まれています。

## 開発ツール

### Code Composer Studio™: MSPマイクロコントローラ用の統合開発環境

Code Composer Studio (CCS)は、すべてのMSPマイクロコントローラ・デバイスをサポートする統合開発環境 (IDE)です。CCSは、組み込みアプリケーションの開発とデバッグに使用される、組み込み用ソフトウェア・ユーティリティのスイートです。最適化C/C++コンパイラ、ソース・コード・エディタ、プロジェクト・ビルド環境、デバッガ、プロファイラなど、多数の機能が含まれています。

## コマンドライン・プログラマ

MSP Flasher は、FET プログラマまたは eZ430 を経由し、JTAG または Spy-Bi-Wire (SBW) 通信を使用してMSP マイクロコントローラをプログラムするための、オープン・ソースでシェル・ベースのインターフェイスです。MSP Flasher は、IDE を使用せずにバイナリ・ファイル (.txt または .hex) を MSP マイクロコントローラへ直接ダウンロードできます。

## MSP MCU プログラマおよびデバッガ

MSP-FETは強力なエミュレーション開発ツールで、多くの場合にデバッグ・プローブと呼ばれます。ユーザーはこのツールを使用して、MSP低消費電力MCUのアプリケーション開発をすぐに始めることができます。MCUのソフトウェアを作成する場合は通常、結果として得られたバイナリ・プログラムをMSPデバイスにダウンロードし、検証とデバッグを行う必要があります。

## MSP-GANG 量産プログラマ

MSP Gang プログラマは MSP430 または MSP432 用のデバイス・プログラマで、8つまでの同一の MSP430 または MSP432 のフラッシュまたは FRAM デバイスを同時にプログラムできます。MSP Gang プログラマは、標準の RS-232 または USB 接続を使用してホスト PC と接続し、柔軟なプログラミング・オプションが用意されているため、ユーザーはプロセスを完全にカスタマイズ可能です。

## 8.4 ドキュメントのサポート

以下のドキュメントには、MSP430FR231x マイクロコントローラについての解説が記載されています。これらのドキュメントのコピーは、[www.ti.com](http://www.ti.com) で入手できます。

### ドキュメントの更新通知を受け取る方法

ドキュメント更新の通知を、シリコンの正誤表も含めて受け取るには、[ti.com](http://ti.com) でお使いのデバイスの製品フォルダへ移動します (製品フォルダへのリンクについては、8.5 を参照してください)。右上の「アラートを受け取る」ボタンをクリックします。これによって登録が行われ、変更された製品情報の概要を毎週受け取ることができます。変更の詳細については、修正されたドキュメントに含まれている改訂履歴をご覧ください。

### 正誤表

#### 『MSP430FR2311 デバイス正誤表』

機能仕様に対する既知の例外が記載されています。

#### 『MSP430FR2310 デバイス正誤表』

機能仕様に対する既知の例外が記載されています。

### ユーザー・ガイド

#### 『MSP430FR4xx および MSP430FR2xx ファミリー ユーザー・ガイド』

このデバイス・ファミリで利用可能なすべてのモジュールとペリフェラルについての詳細情報です。

#### 『MSP430 FRAM デバイス・ブートローダ (BSL) ユーザー・ガイド』

MSP430 MCU に搭載されたブートローダ (BSL) を使用すると、プロトタイプ作成フェーズ、最終的な量産、およびサービス中に、MSP430 MCU の組み込みメモリと通信できます。必要に応じて、プログラム可能メモリ (フラッシュ・メモリ) とデータ・メモリ (RAM) の両方を変更できます。

#### 『JTAG インターフェイスによる MSP430 のプログラミング』

このドキュメントでは、JTAG 通信ポートを使用して MSP430 のフラッシュ・ベースおよび FRAM ベースのマイクロコントローラ・ファミリのメモリ・モジュールを消去、プログラム、検証するために必要な機能について解説しています。さらに、すべての MSP430 デバイスで利用可能な JTAG アクセス・セキュリティ・ヒューズのプログラム方法についても解説しています。このドキュメントには、標準の 4 線式 JTAG インターフェイスと 2 線式 JTAG インターフェイスの両方を使用してデバイスにアクセスする方法が解説されています。2 線式 JTAG インターフェイスは Spy-Bi-Wire (SBW) と呼ばれます。

#### 『MSP430 ハードウェア・ツール ユーザー・ガイド』

このマニュアルには、TI MSP-FET430 フラッシュ・エミュレーション・ツール (FET) のハードウェアについて解説されています。この FET は、MSP430 超低消費電力マイクロコントローラ用のプログラム開発ツールです。利用可能なインターフェイスとして、パラレル・ポート・インターフェイスと USB インターフェイスの両方について解説されています。

### アプリケーション・レポート

#### 『MSP430 32kHz 水晶発振器』

適切な水晶、正しい負荷回路、および適切な基板レイアウトの選択は、安定した水晶発振器のために重要です。このアプリケーション・レポートでは、水晶発振器の機能について要約し、MSP430 MCU の超低消費電力動作の適切な水晶を選択するためのパラメータについて説明します。また、正しい基板レイアウトについてのヒントや例も紹介しています。このドキュメントには、量産時の安定した発振器の動作を保証するために行うことができる、発振器のテストについての詳細情報も記載されています。

## 『MSP430 システム・レベルESDの考慮事項』

シリコン・テクノロジーのスケーリングによる低電圧化の進行と、コスト効率の優れた超低消費電力コンポーネントを設計する必要性の高まりにより、システム・レベルの ESD の要求はますます高まっています。このアプリケーション・レポートでは、基板設計者と OEM が堅牢なシステム・レベルのデザインを理解し設計できるよう、各種の ESD トピックについて扱います。現実世界でのシステム・レベルのESD保護設計の例のいくつかと、その結果についても解説します。

## 8.5 関連リンク

表 8-2 に、クイック・アクセス・リンクの一覧を示します。カテゴリには、技術資料、サポートおよびコミュニティ・リソース、ツールとソフトウェア、およびサンプル注文またはご購入へのクイック・アクセスが含まれます。

表 8-2. 関連リンク

| 製品           | プロダクト・フォルダ              | ご注文はこちら                 | 技術資料                    | ツールとソフトウェア              | サポートとコミュニティ             |
|--------------|-------------------------|-------------------------|-------------------------|-------------------------|-------------------------|
| MSP430FR2311 | <a href="#">ここをクリック</a> | <a href="#">ここをクリック</a> | <a href="#">ここをクリック</a> | <a href="#">ここをクリック</a> | <a href="#">ここをクリック</a> |
| MSP430FR2310 | <a href="#">ここをクリック</a> | <a href="#">ここをクリック</a> | <a href="#">ここをクリック</a> | <a href="#">ここをクリック</a> | <a href="#">ここをクリック</a> |

## 8.6 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

### TI E2E™ Community

TI's *Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At [e2e.ti.com](http://e2e.ti.com), you can ask questions, share knowledge, explore ideas, and help solve problems with fellow engineers.

### TI Embedded Processors Wiki

*Texas Instruments Embedded Processors Wiki*. Established to help developers get started with embedded processors from Texas Instruments and to foster innovation and growth of general knowledge about the hardware and software surrounding these devices.

## 8.7 商標

LaunchPad, MSP430, MSP430Ware, Code Composer Studio, E2E, EnergyTrace, ULP Advisor are trademarks of Texas Instruments.

All other trademarks are the property of their respective owners.

## 8.8 静電気放電に関する注意事項



すべての集積回路は、適切なESD保護方法を用いて、取扱いと保存を行うようにして下さい。

静電気放電はわずかな性能の低下から完全なデバイスの故障に至るまで、様々な損傷を与えます。高精度の集積回路は、損傷に対して敏感であり、極めてわずかなパラメータの変化により、デバイスに規定された仕様に適合しなくなる場合があります。

## 8.9 Glossary

**TI Glossary** This glossary lists and explains terms, acronyms, and definitions.

## 9 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。この情報は、そのデバイスについて利用可能な最新のデータです。このデータは予告なく変更されることがあり、ドキュメントが改訂される場合もあります。本データシートのブラウザ版を使用されている場合は、画面左側の説明をご覧ください。

## PACKAGING INFORMATION

| Orderable part number              | Status<br>(1) | Material type<br>(2) | Package   Pins  | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|------------------------------------|---------------|----------------------|-----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">MSP430FR2310IPW16</a>  | Active        | Production           | TSSOP (PW)   16 | 90   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2310              |
| MSP430FR2310IPW16.A                | Active        | Production           | TSSOP (PW)   16 | 90   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2310              |
| <a href="#">MSP430FR2310IPW16R</a> | Active        | Production           | TSSOP (PW)   16 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2310              |
| MSP430FR2310IPW16R.A               | Active        | Production           | TSSOP (PW)   16 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2310              |
| <a href="#">MSP430FR2310IPW20</a>  | Active        | Production           | TSSOP (PW)   20 | 70   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2310              |
| MSP430FR2310IPW20.A                | Active        | Production           | TSSOP (PW)   20 | 70   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2310              |
| <a href="#">MSP430FR2310IPW20R</a> | Active        | Production           | TSSOP (PW)   20 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2310              |
| MSP430FR2310IPW20R.A               | Active        | Production           | TSSOP (PW)   20 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2310              |
| <a href="#">MSP430FR2310IRGYR</a>  | Active        | Production           | VQFN (RGY)   16 | 3000   LARGE T&R      | Yes         | NIPDAU   SELECTIVE<br>AG (TOP SIDE)  | Level-2-260C-1 YEAR               | -40 to 85    | FR2310              |
| MSP430FR2310IRGYR.A                | Active        | Production           | VQFN (RGY)   16 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2310              |
| <a href="#">MSP430FR2310IRGYT</a>  | Active        | Production           | VQFN (RGY)   16 | 250   SMALL T&R       | Yes         | NIPDAU   SELECTIVE<br>AG (TOP SIDE)  | Level-2-260C-1 YEAR               | -40 to 85    | FR2310              |
| MSP430FR2310IRGYT.A                | Active        | Production           | VQFN (RGY)   16 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2310              |
| <a href="#">MSP430FR2311IPW16</a>  | Active        | Production           | TSSOP (PW)   16 | 90   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2311              |
| MSP430FR2311IPW16.A                | Active        | Production           | TSSOP (PW)   16 | 90   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2311              |
| <a href="#">MSP430FR2311IPW16R</a> | Active        | Production           | TSSOP (PW)   16 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2311              |
| MSP430FR2311IPW16R.A               | Active        | Production           | TSSOP (PW)   16 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2311              |
| <a href="#">MSP430FR2311IPW20</a>  | Active        | Production           | TSSOP (PW)   20 | 70   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2311              |
| MSP430FR2311IPW20.A                | Active        | Production           | TSSOP (PW)   20 | 70   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2311              |
| <a href="#">MSP430FR2311IPW20R</a> | Active        | Production           | TSSOP (PW)   20 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2311              |
| MSP430FR2311IPW20R.A               | Active        | Production           | TSSOP (PW)   20 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2311              |
| <a href="#">MSP430FR2311IRGYR</a>  | Active        | Production           | VQFN (RGY)   16 | 3000   LARGE T&R      | Yes         | NIPDAU   SELECTIVE<br>AG (TOP SIDE)  | Level-1-260C-UNLIM                | -40 to 85    | FR2311              |
| MSP430FR2311IRGYR.A                | Active        | Production           | VQFN (RGY)   16 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | FR2311              |
| <a href="#">MSP430FR2311IRGYT</a>  | Active        | Production           | VQFN (RGY)   16 | 250   SMALL T&R       | Yes         | NIPDAU   SELECTIVE<br>AG (TOP SIDE)  | Level-2-260C-1 YEAR               | -40 to 85    | FR2311              |
| MSP430FR2311IRGYT.A                | Active        | Production           | VQFN (RGY)   16 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | FR2311              |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

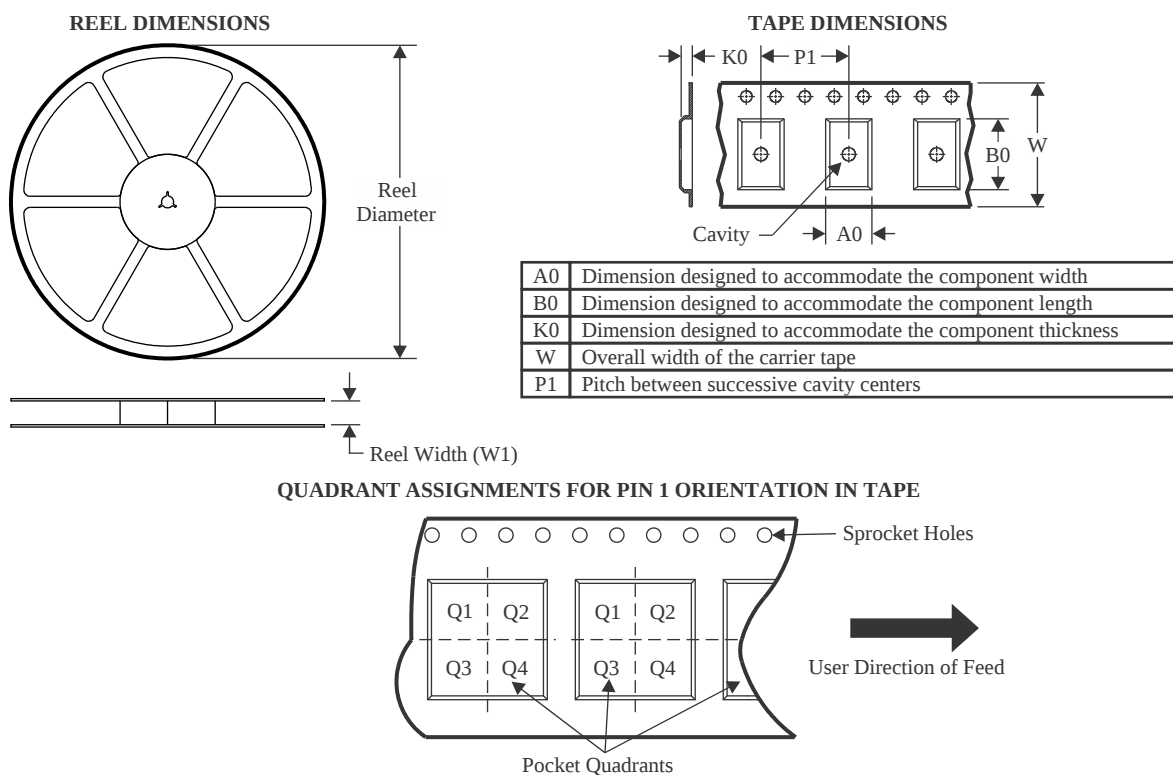
<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

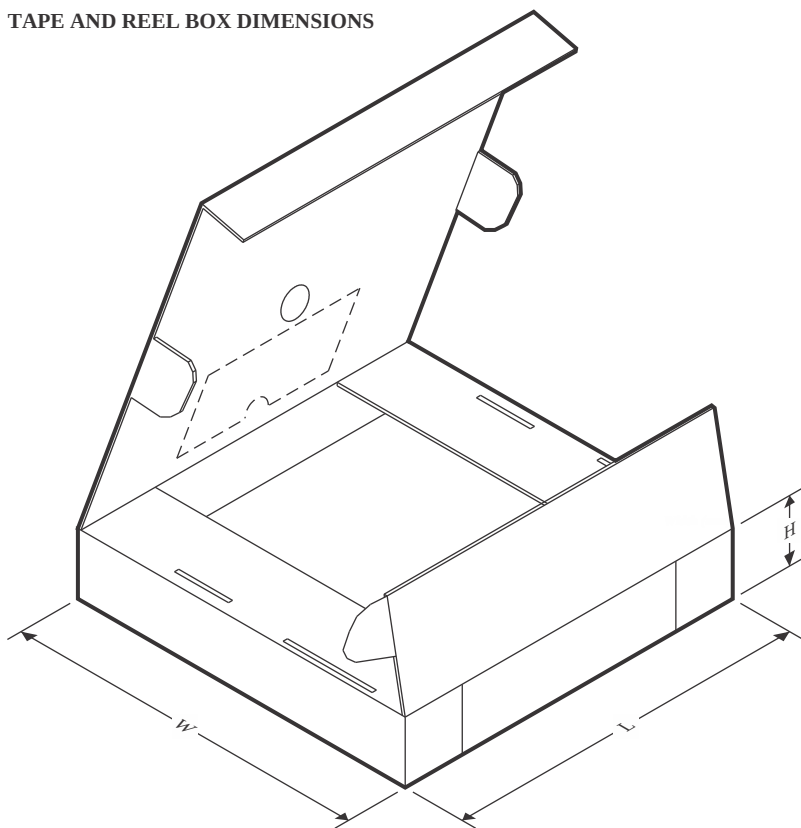
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

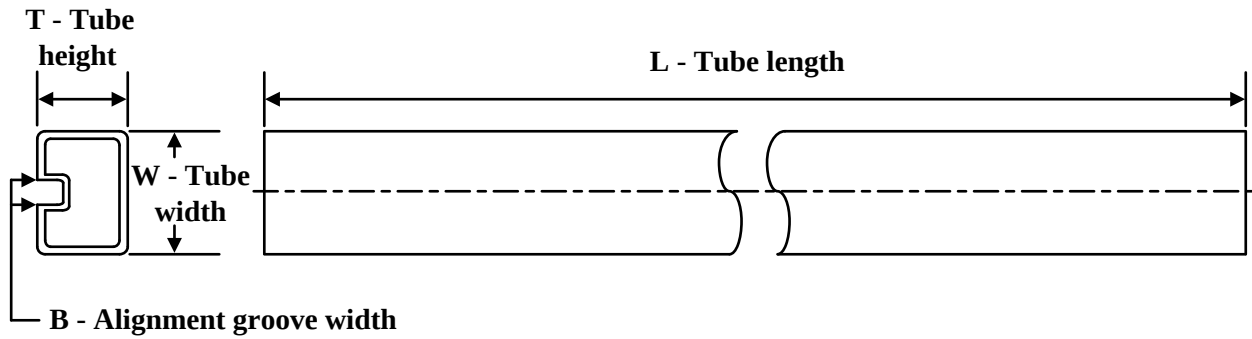
| Device             | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| MSP430FR2310IPW16R | TSSOP        | PW              | 16   | 2000 | 330.0              | 12.4               | 6.9     | 5.6     | 1.6     | 8.0     | 12.0   | Q1            |
| MSP430FR2310IPW20R | TSSOP        | PW              | 20   | 2000 | 330.0              | 16.4               | 6.95    | 7.1     | 1.6     | 8.0     | 16.0   | Q1            |
| MSP430FR2310IRGYR  | VQFN         | RGY             | 16   | 3000 | 330.0              | 12.4               | 3.8     | 4.3     | 1.5     | 8.0     | 12.0   | Q1            |
| MSP430FR2310IRGYT  | VQFN         | RGY             | 16   | 250  | 180.0              | 12.4               | 3.8     | 4.3     | 1.5     | 8.0     | 12.0   | Q1            |
| MSP430FR2311IPW16R | TSSOP        | PW              | 16   | 2000 | 330.0              | 12.4               | 6.9     | 5.6     | 1.6     | 8.0     | 12.0   | Q1            |
| MSP430FR2311IPW20R | TSSOP        | PW              | 20   | 2000 | 330.0              | 16.4               | 6.95    | 7.1     | 1.6     | 8.0     | 16.0   | Q1            |
| MSP430FR2311IRGYR  | VQFN         | RGY             | 16   | 3000 | 330.0              | 12.4               | 3.8     | 4.3     | 1.5     | 8.0     | 12.0   | Q1            |
| MSP430FR2311IRGYT  | VQFN         | RGY             | 16   | 250  | 180.0              | 12.4               | 3.8     | 4.3     | 1.5     | 8.0     | 12.0   | Q1            |

## TAPE AND REEL BOX DIMENSIONS



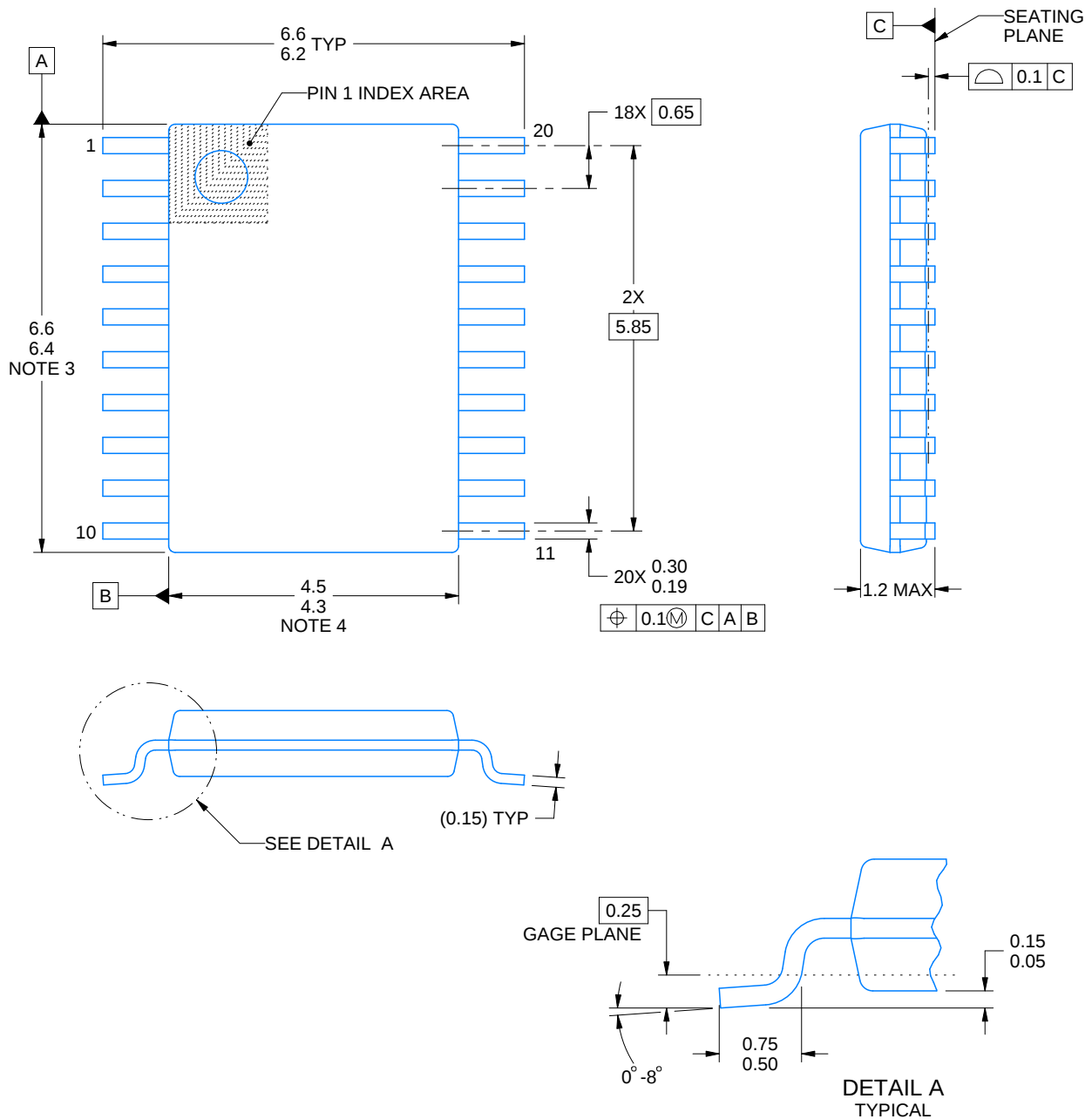
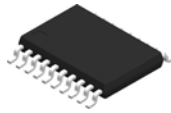
\*All dimensions are nominal

| Device             | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|--------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| MSP430FR2310IPW16R | TSSOP        | PW              | 16   | 2000 | 350.0       | 350.0      | 43.0        |
| MSP430FR2310IPW20R | TSSOP        | PW              | 20   | 2000 | 350.0       | 350.0      | 43.0        |
| MSP430FR2310IRGYR  | VQFN         | RGY             | 16   | 3000 | 346.0       | 346.0      | 33.0        |
| MSP430FR2310IRGYT  | VQFN         | RGY             | 16   | 250  | 210.0       | 185.0      | 35.0        |
| MSP430FR2311IPW16R | TSSOP        | PW              | 16   | 2000 | 350.0       | 350.0      | 43.0        |
| MSP430FR2311IPW20R | TSSOP        | PW              | 20   | 2000 | 350.0       | 350.0      | 43.0        |
| MSP430FR2311IRGYR  | VQFN         | RGY             | 16   | 3000 | 346.0       | 346.0      | 33.0        |
| MSP430FR2311IRGYT  | VQFN         | RGY             | 16   | 250  | 210.0       | 185.0      | 35.0        |

**TUBE**


\*All dimensions are nominal

| Device              | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (μm) | B (mm) |
|---------------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| MSP430FR2310IPW16   | PW           | TSSOP        | 16   | 90  | 530    | 10.2   | 3600   | 3.5    |
| MSP430FR2310IPW16.A | PW           | TSSOP        | 16   | 90  | 530    | 10.2   | 3600   | 3.5    |
| MSP430FR2310IPW20   | PW           | TSSOP        | 20   | 70  | 530    | 10.2   | 3600   | 3.5    |
| MSP430FR2310IPW20.A | PW           | TSSOP        | 20   | 70  | 530    | 10.2   | 3600   | 3.5    |
| MSP430FR2311IPW16   | PW           | TSSOP        | 16   | 90  | 530    | 10.2   | 3600   | 3.5    |
| MSP430FR2311IPW16.A | PW           | TSSOP        | 16   | 90  | 530    | 10.2   | 3600   | 3.5    |
| MSP430FR2311IPW20   | PW           | TSSOP        | 20   | 70  | 530    | 10.2   | 3600   | 3.5    |
| MSP430FR2311IPW20.A | PW           | TSSOP        | 20   | 70  | 530    | 10.2   | 3600   | 3.5    |



4220206/A 02/2017

## NOTES:

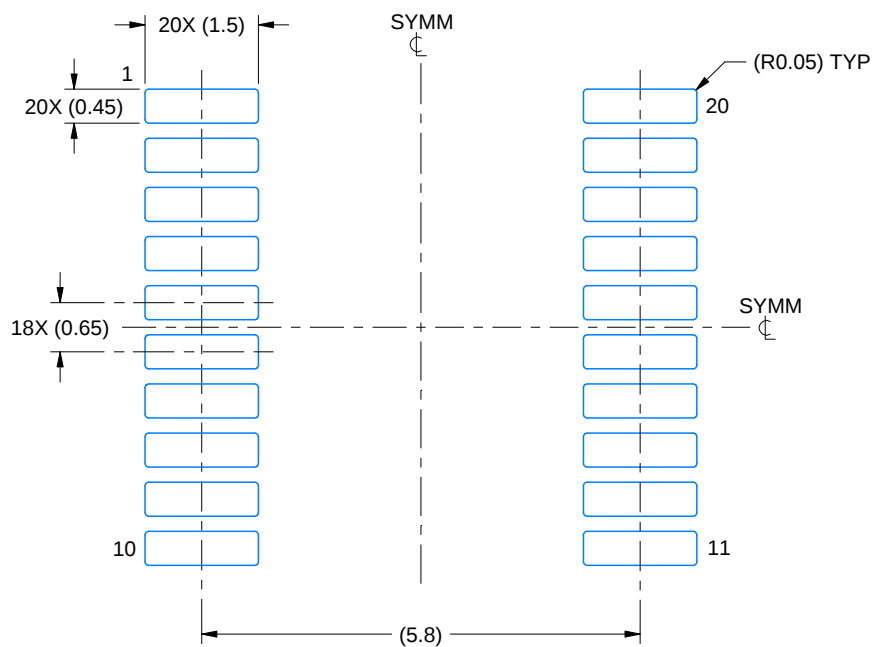
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

# EXAMPLE BOARD LAYOUT

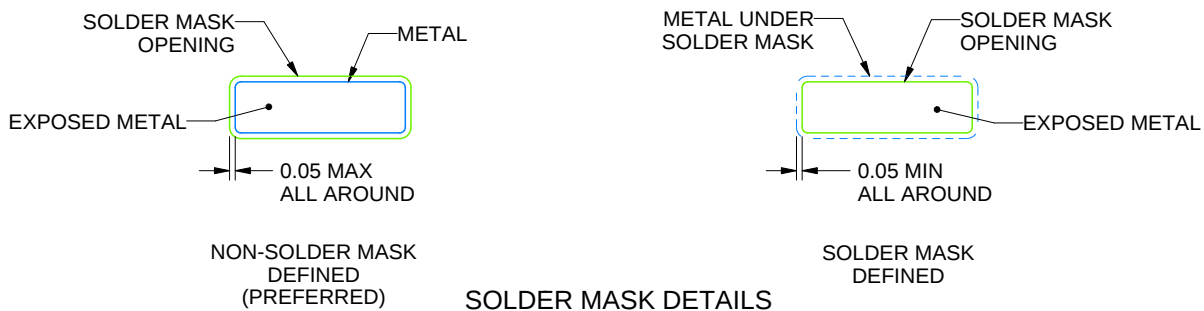
PW0020A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 10X



4220206/A 02/2017

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

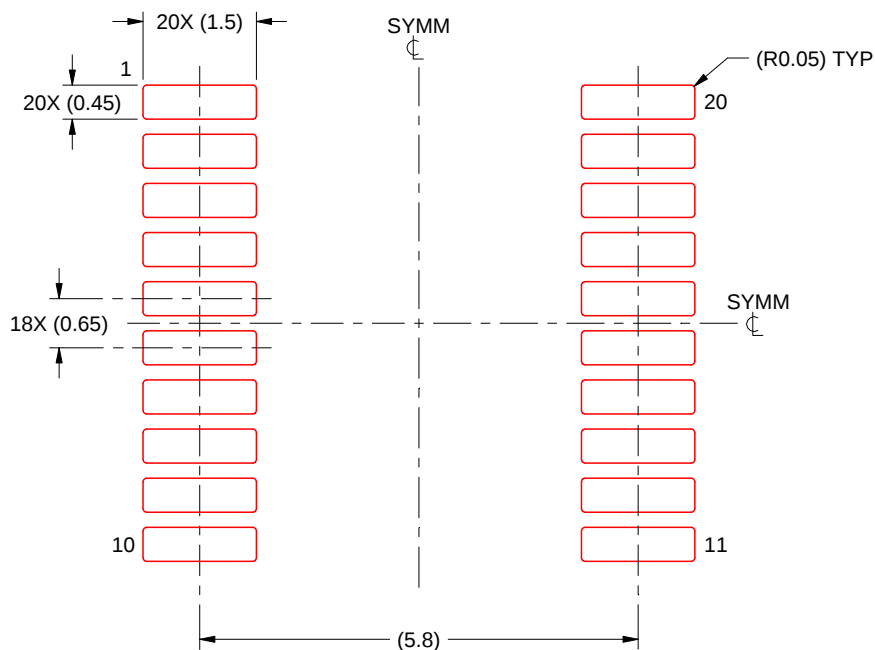
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

## EXAMPLE STENCIL DESIGN

PW0020A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

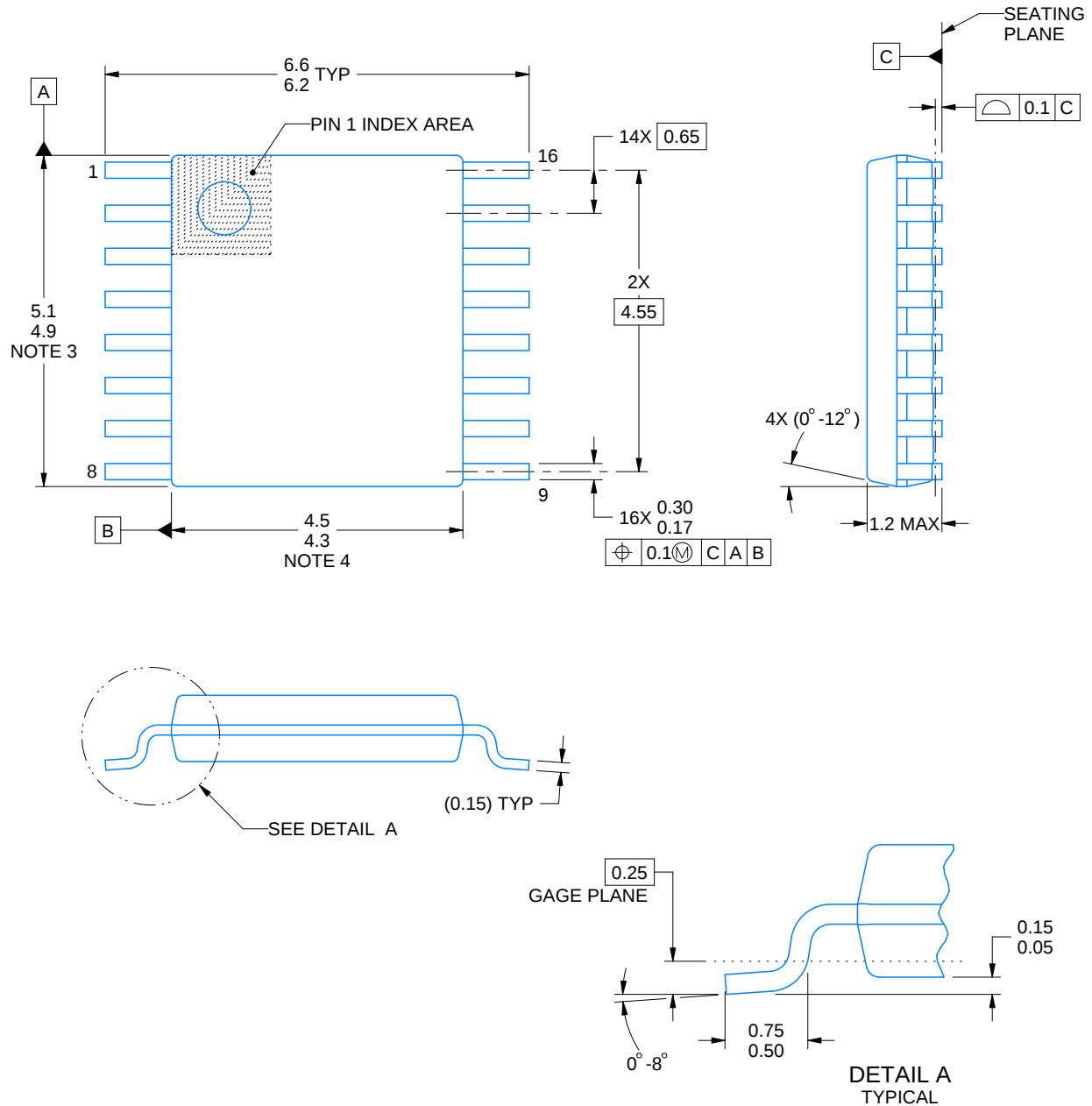
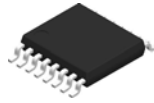


SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 10X

4220206/A 02/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



4220204/B 12/2023

## NOTES:

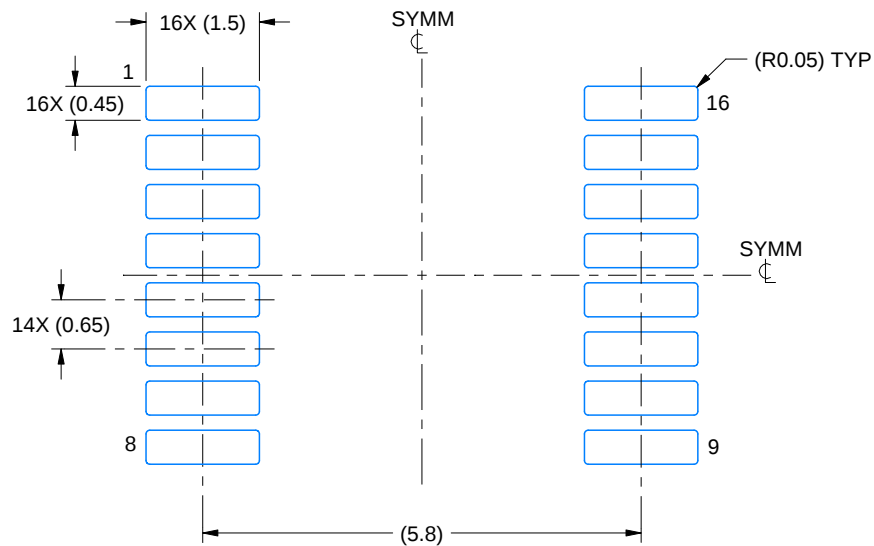
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

# EXAMPLE BOARD LAYOUT

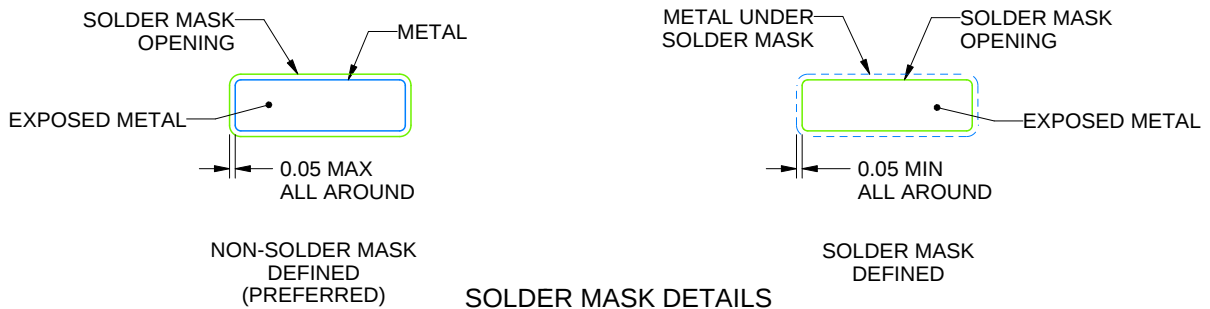
PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 10X



4220204/B 12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

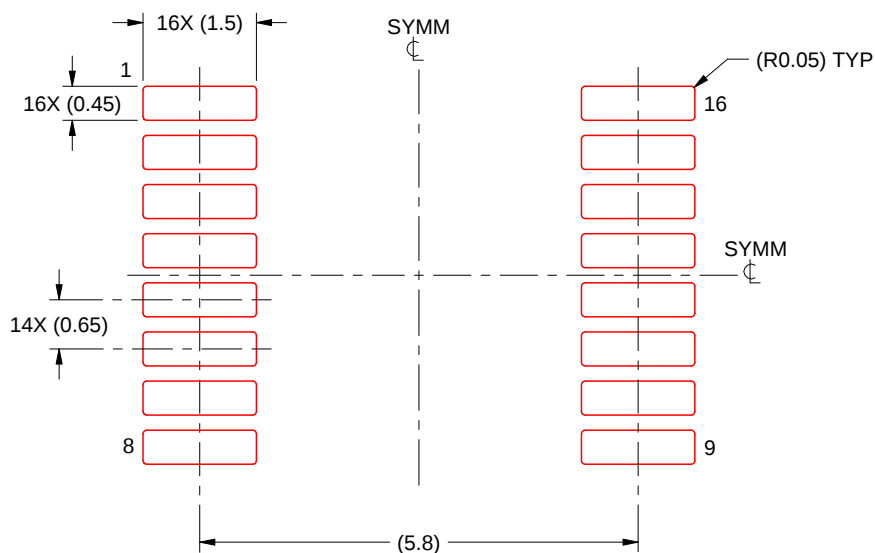
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 10X

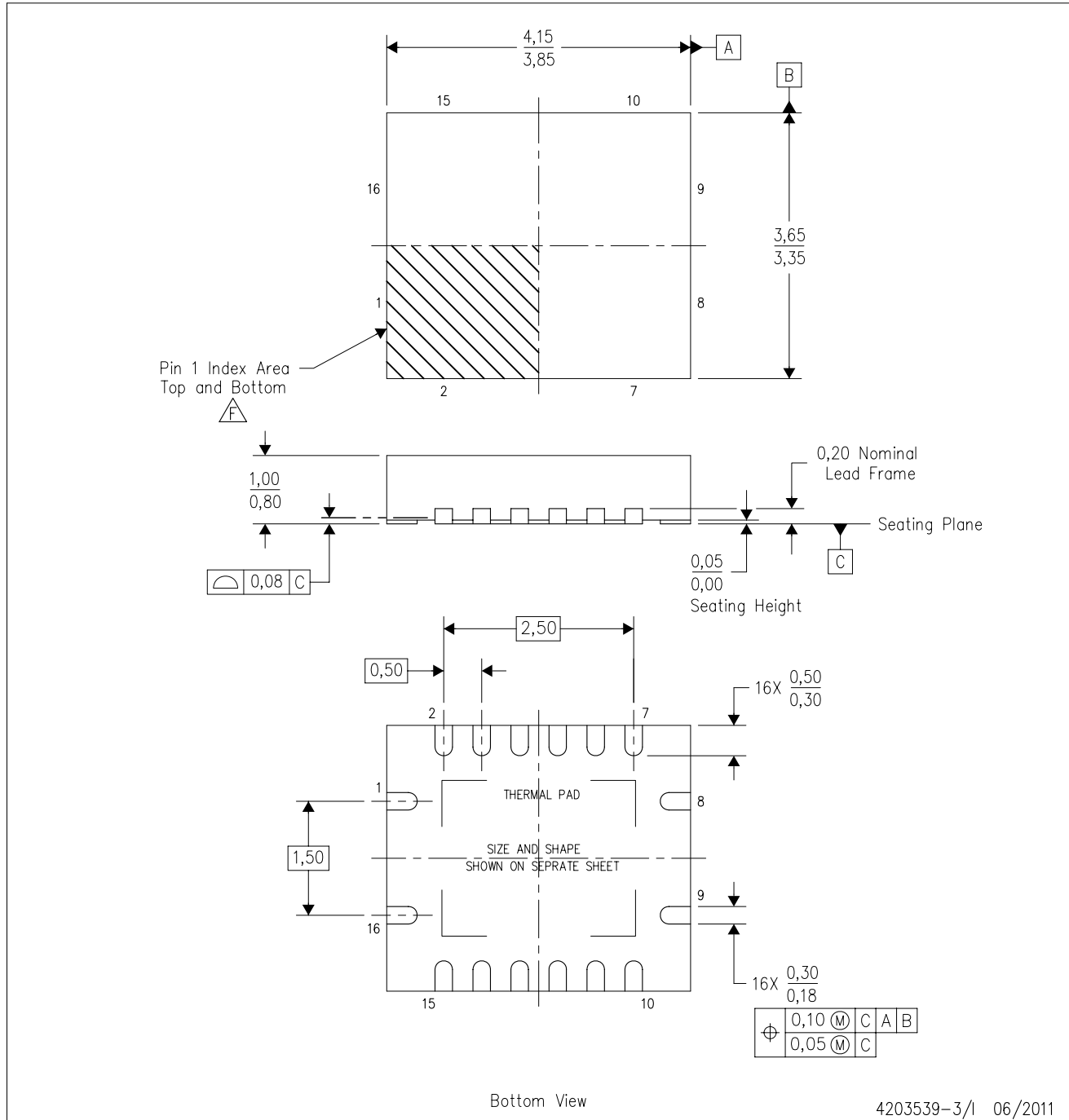
4220204/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

RGY (R-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



4203539-3/I 06/2011

- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - This drawing is subject to change without notice.
  - QFN (Quad Flatpack No-Lead) package configuration.
  - The package thermal pad must be soldered to the board for thermal and mechanical performance.
  - See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- F** Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- Package complies to JEDEC MO-241 variation BA.

RGY (R-PVQFN-N16)

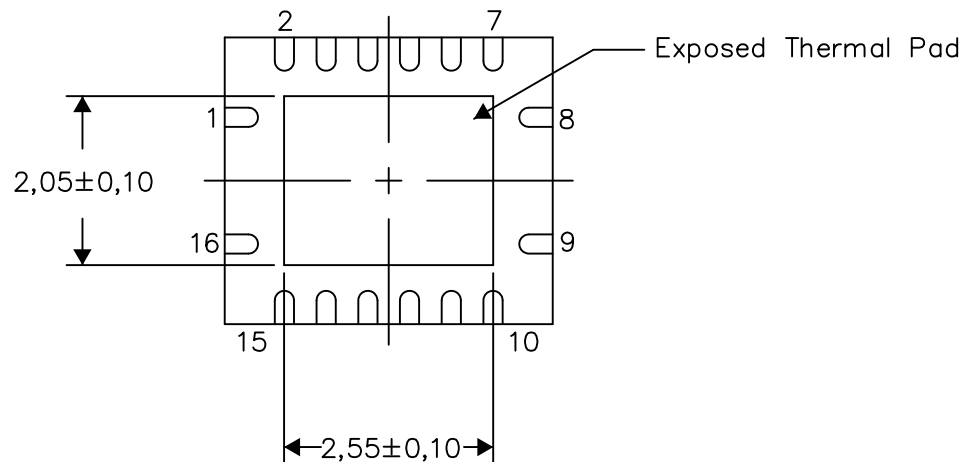
PLASTIC QUAD FLATPACK NO-LEAD

## THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at [www.ti.com](http://www.ti.com).

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

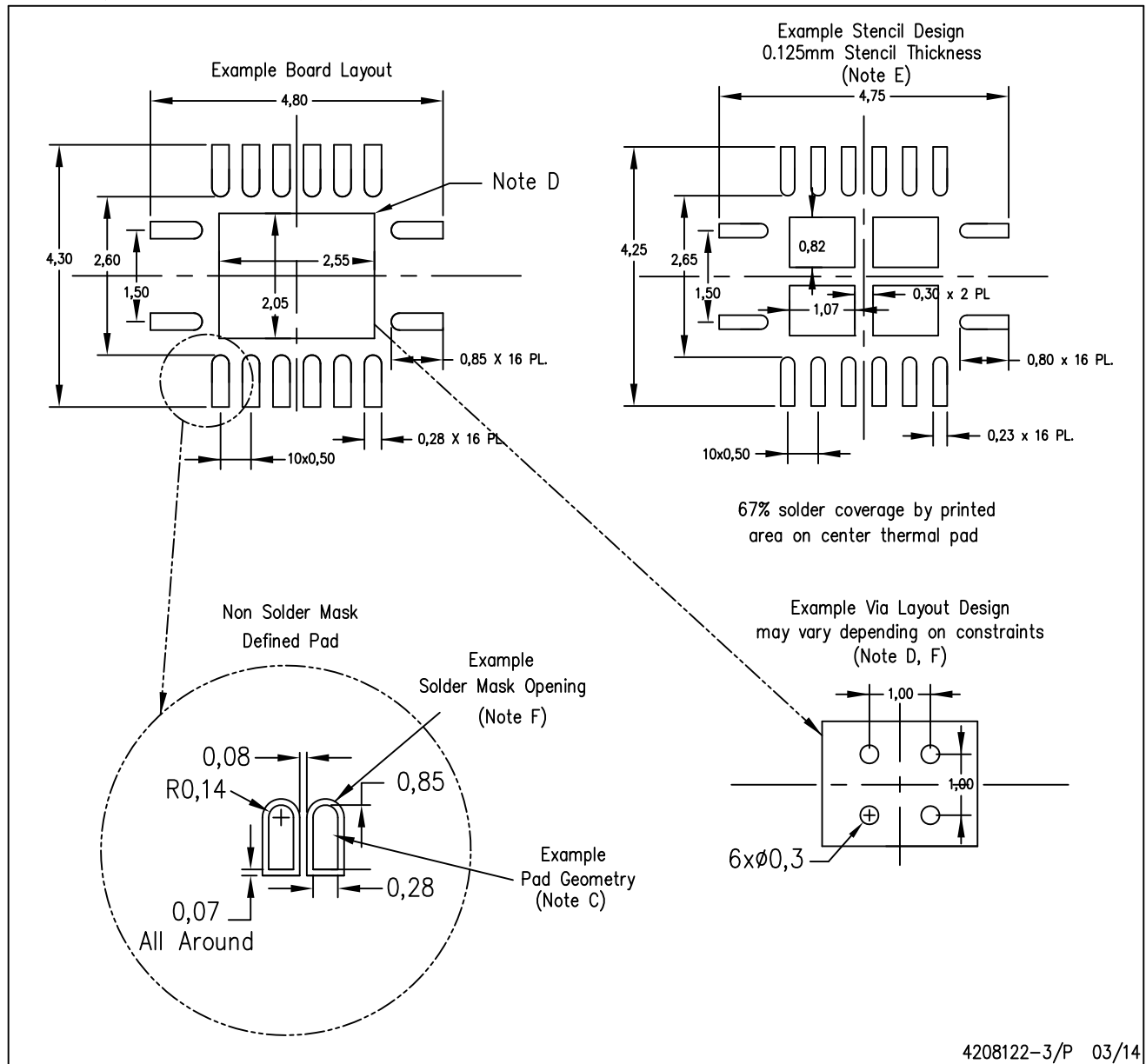
Exposed Thermal Pad Dimensions

4206353-3/P 03/14

NOTE: All linear dimensions are in millimeters

RGY (R-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
  - Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.

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最終更新日：2025 年 10 月